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# **D9010EBSC IEEE802.3 bs/cd Conformance Test Application**



# Notices

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# 1 Overview

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## IEEE802.3 bs/cd Automated Testing—At a Glance

The Keysight D9010EBSC IEEE802.3 bs/cd Test Application is an Ethernet test solution that covers the electrical timing parameters for PAM4 and NRZ specification (IEEE 802.3bs/IEEE 802.3cd).

The main features of the IEEE802.3 bs/cd Test Application are:

- Data Analytics
- IEEE802.3bs/cd, update for final release specification
- Complete coverage of specification-based chip-to-chip (C2C) and chip-to-module (C2M) tests
- Test coverage for PAM4 and NRZ signals
- Coverage of Signal-to-Noise Distortion Ratio (SNDR) and SNDR\_ISI at test point TP0a
- Support for User Interactive Pulse Response

The Keysight D9010EBSC IEEE802.3 bs/cd Test Application:

- Lets you select individual or multiple tests to run.
- Lets you identify the device being tested and its configuration.
- Shows you how to make oscilloscope connections to the device under test.
- Automatically checks for proper oscilloscope configuration.
- Automatically sets up the oscilloscope for each test.
- Provides detailed information for each test that has been run and lets you specify the thresholds at which marginal or critical warnings appear.
- Creates a printable HTML report of the tests that have been run.

### NOTE

The tests performed by the Keysight D9010EBSC IEEE802.3 bs/cd Test Application are intended to provide a quick check of the electrical health of the DUT. This testing is not a replacement for an exhaustive test validation plan.

---

## Required Equipment and Software

To run automated tests on PAM4 and NRZ signals, you need the following equipment and software:

### Hardware

- Use one of the following Oscilloscope models. Refer to [www.keysight.com](http://www.keysight.com) for the respective bandwidth ranges.
  - Keysight UXR series Real-Time Infiniium Oscilloscopes:
    - Channels: 2
    - Minimum Bandwidth of 50 GHz
    - Sample Rate of up to 160 GSa/s
- Keyboard, qty = 1, (provided with the Keysight Infiniium oscilloscope)
- Mouse, qty = 1, (provided with the Keysight Infiniium oscilloscope)
- Keysight also recommends using a second monitor to view the test application.

### Software

- The minimum version of Infiniium Oscilloscope Software (see the Keysight D9010EBSC IEEE802.3 bs/cd Test Application Release Notes)
- Keysight D9010EBSC IEEE802.3 bs/cd Test Application software

### Licensing Information

Refer to the *Data Sheet* pertaining to IEEE802.3 bs/cd Test Application to know about the licenses you must install along with other optional licenses. Visit "<http://www.keysight.com/find/D9010EBSC>" and in the web page's **Document Library** tab, you may view the associated Data Sheet.

To procure a license, you require the Host ID information that is displayed in the Keysight License Manager application installed on the same machine where you wish to install the license.

The licensing format for Keysight License Manager 6 differs from its predecessors. See "[Installing the License Key](#)" on page 17 to see the difference in installing a license key using either of the applications on your machine.



## 2 Installing the Test Application and Licenses

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If you purchased the D9010EBSC IEEE802.3 bs/cd Test Application separate from your Infiniium oscilloscope, you must install the software and license key.

## Installing the Test Application

- 1 Make sure you have the minimum version of Infiniium Oscilloscope software (see the D9010EBSC release notes). To ensure that you have the minimum version, select **Help > About Infiniium...** from the main menu.
- 2 To obtain the IEEE802.3 bs/cd Test Application, go to Keysight website:  
“<http://www.keysight.com/find/D9010EBSC>”.
- 3 In the web page's **Trials & Licenses** tab, click the **Details and Download** button to view instructions for downloading and installing the application software.



## Installing the License Key

To procure a license, you require the Host ID information that is displayed in the Keysight License Manager application installed on the same machine where you wish to install the license.

### Using Keysight License Manager 5

To view and copy the Host ID from Keysight License Manager 5:

- 1 Launch Keysight License Manager on your machine, where you wish to run the Test Application and its features.
- 2 Copy the Host ID that appears on the top pane of the application. Note that x indicates numeric values.

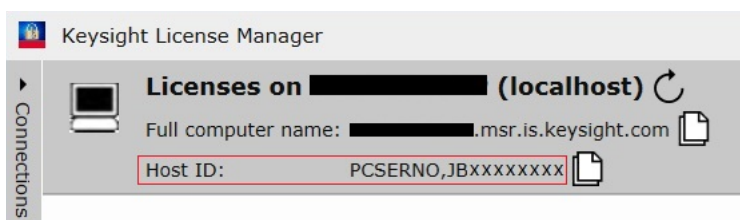


Figure 1 Viewing the Host ID information in Keysight License Manager 5

To install one of the procured licenses using Keysight License Manager 5 application,

- 1 Save the license files on the machine, where you wish to run the Test Application and its features.
- 2 Launch Keysight License Manager.
- 3 From the configuration menu, use one of the options to install each license file.

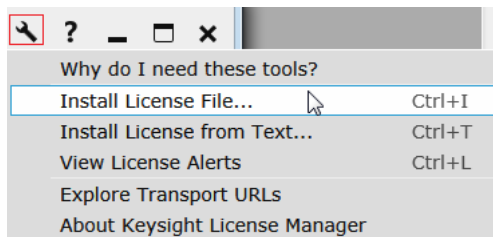


Figure 2 Configuration menu options to install licenses on Keysight License Manager 5

For more information regarding installation of procured licenses on Keysight License Manager 5, refer to [Keysight License Manager 5 Supporting Documentation](#).

## Using Keysight License Manager 6

To view and copy the Host ID from Keysight License Manager 6:

- 1 Launch Keysight License Manager 6 on your machine, where you wish to run the Test Application and its features.
- 2 Copy the Host ID, which is the first set of alphanumeric value (as highlighted in [Figure 3](#)) that appears in the Environment tab of the application. Note that x indicates numeric values.

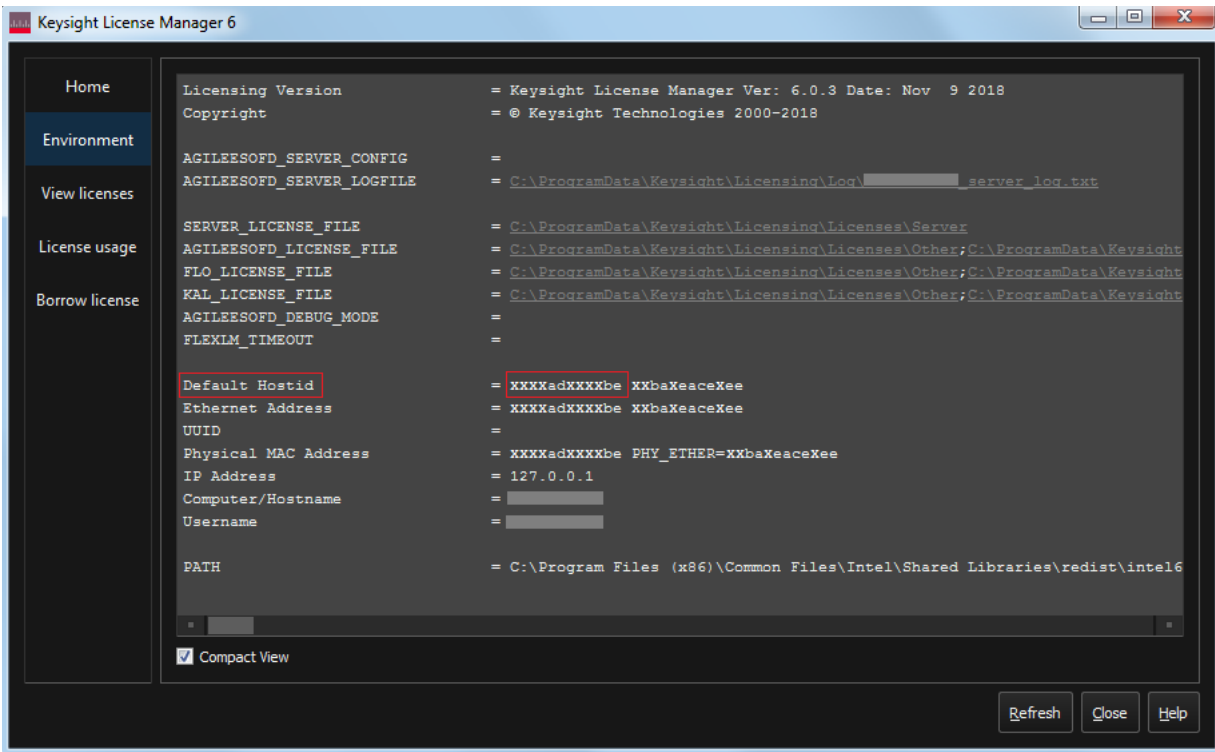


Figure 3 Viewing the Host ID information in Keysight License Manager 6

To install one of the procured licenses using Keysight License Manager 6 application,

- 1 Save the license files on the machine, where you wish to run the Test Application and its features.
- 2 Launch Keysight License Manager 6.
- 3 From the Home tab, use one of the options to install each license file.

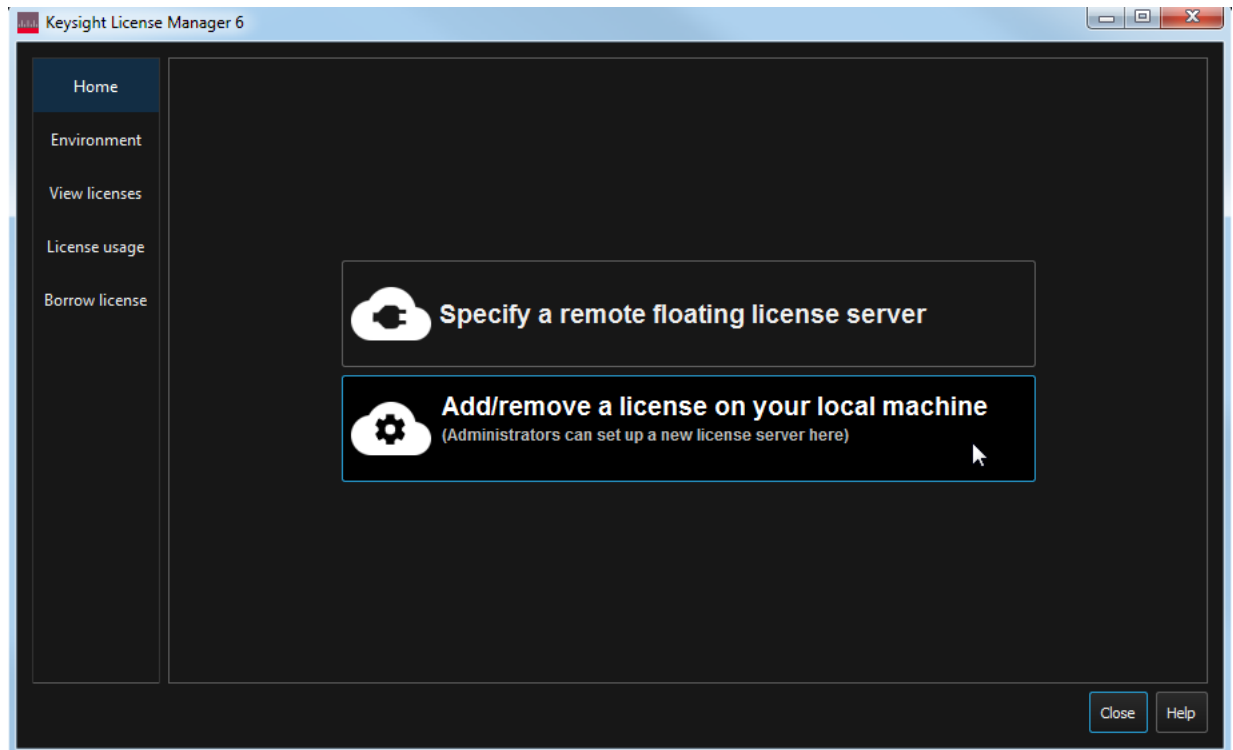


Figure 4 Home menu options to install licenses on Keysight License Manager 6

For more information regarding installation of procured licenses on Keysight License Manager 6, refer to [Keysight License Manager 6 Supporting Documentation](#).



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Before running the automated tests, you should calibrate the oscilloscope and probe. No test fixture is required for this application. After the oscilloscope and probe have been calibrated, you are ready to start the IEEE802.3 bs/cd Test Application and perform the measurements.

## Calibrating the Oscilloscope

If you have not already calibrated the oscilloscope, refer to the *User Guide* for the respective Oscilloscope you are using.

### NOTE

If the ambient temperature changes more than 5 degrees Celsius from the calibration temperature, internal calibration should be performed again. The delta between the calibration temperature and the present operating temperature is shown in the **Utilities > Calibration** menu.

---

### NOTE

If you switch cables between channels or other Oscilloscopes, it is necessary to perform cable and probe calibration again. Keysight recommends that, once calibration is performed, you label the cables with the channel on which they were calibrated.

---

## Starting the IEEE802.3 bs/cd Test Application

- 1 Ensure that the IEEE802.3 bs/cd Device Under Test (DUT) is operating and set to desired test modes.
  - 2 To start the IEEE802.3 bs/cd Test Application: From the Infiniium Oscilloscope's main menu, select **Analyze > Automated Test Apps > D9010EBSC IEEE802.3 bs/cd Test App**.
- **Figure 5** shows the Keysight D9010EBSC IEEE802.3 bs/cd Test Application window as it appears when launched within the Infiniium application of the UXR Oscilloscope. The Instrument Setup area in the Set Up tab displays the corresponding Channel assignments.

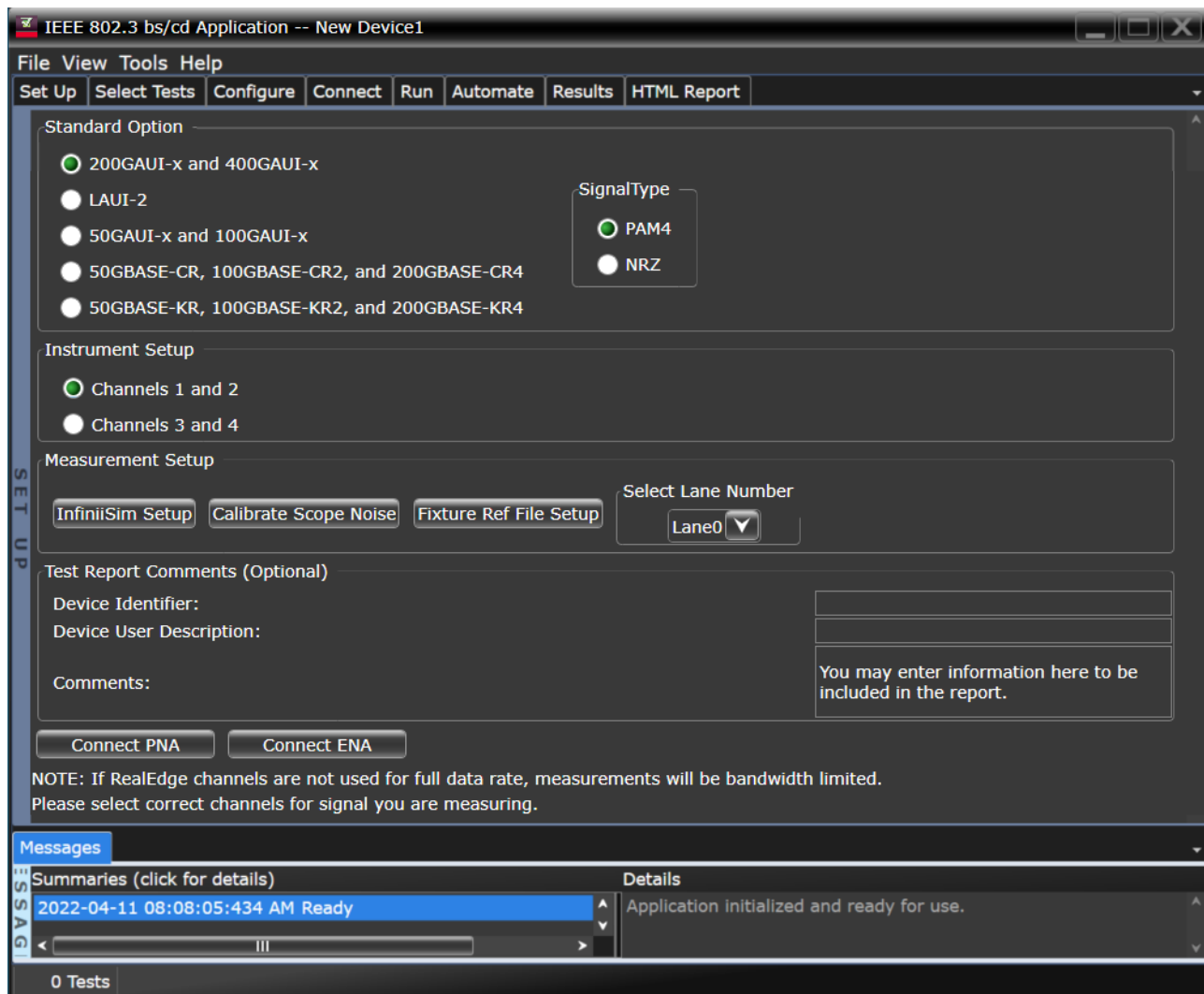


Figure 5 IEEE802.3 bs/cd Test Application main window on a UXR Oscilloscope

The task flow pane and the tabs in the main pane show the steps you take in running the automated tests:

<b>Set Up</b>	<p>Lets you identify and set up the test environment, including information about the device under test.</p> <p>The <b>Device Identifier</b>, <b>User Description</b>, and <b>Comments</b> are all printed in the final HTML report. Select the <b>Standard Option</b> and <b>SignalType</b> to be tested.</p> <p>For UXR scopes, select the appropriate Channel option in <b>Instrument Setup</b>.</p> <p>Set up InfiniiSim with the <b>InfiniiSim Setup</b> button.</p> <p><b>Calibrate Scope Noise</b> option allows to remove scope noise from jitter and sigma-n/SNDR measurements.</p> <p><b>Fixture Ref File Setup</b> option allows to upload an S-parameter file (*.tf4) for the test fixture. The <b>Select Lane Number</b> drop down box enables you to select a specific lane for testing. In order to connect a PNA (Performance Network Analyzer) or ENA (Economy Network Analyzer), please use <b>Connect PNA</b> or <b>Connect ENA</b> options, respectively. These instruments can be connected using their VISA addresses or through the Keysight Connection Expert.</p>
<b>Select Tests</b>	Lets you select the tests you want to run. The tests are organized hierarchically so you can select all tests in a group. After tests are run, status indicators show which tests have passed, failed, or not been run, and there are indicators for the test groups.
<b>Configure</b>	Lets you configure test parameters (for example, channels used in test, voltage levels, etc.).
<b>Connect</b>	Shows you how to connect the oscilloscope to the device under test for the tests that are to be run.
<b>Run</b>	Starts the automated tests. If the connections to the device under test need to be changed while multiple tests are running, the tests pause, show you how to change the connection, and wait for you to confirm that the connections have been changed before continuing.
<b>Automate</b>	Lets you construct scripts of commands that drive execution of the application.
<b>Results</b>	Contains more detailed information about the tests that have been run. You can change the thresholds at which marginal or critical warnings appear.
<b>HTML Report</b>	Shows a compliance test report that can be printed.

## NOTE

In the **Configure** tab, the values for all such Configuration parameters that are Oscilloscope-dependent, will correspond to the Oscilloscope Model, on which you are running the Test Application.



## Configuring IEEE802.3 bs/cd Test Application for test runs

To run one or more compliance tests on the DUT, which is connected to Oscilloscope, proceed to configure the IEEE802.3 bs/cd Test Application:

- 1 In the **Set Up** tab (shown in [Figure 5](#)), select the **Standard Option** and **SignalType** to filter the test groups in accordance with the connected DUT. [Table 1](#), [Table 2](#), [Table 3](#) and [Table 4](#) show a comprehensive list of the tests that are filtered in the **Select Tests** tab for each combination of **Standard Option** and **SignalType**.

Optionally, you may configure the rest of the settings as described in the task flow table in the previous section.

- 2 In the **Select Tests** tab, select one or more tests, which appear according to the configuration done under the **Set Up** tab. Each section of this manual displays the appearance of the **Select Tests** tab for each test type.
- 3 In the **Configure** tab, you may change the values assigned to one or more options to cater to the compliance requirements for the selected tests. By default, the IEEE802.3 bs/cd Test Application sets optimum values for each configuration parameter.

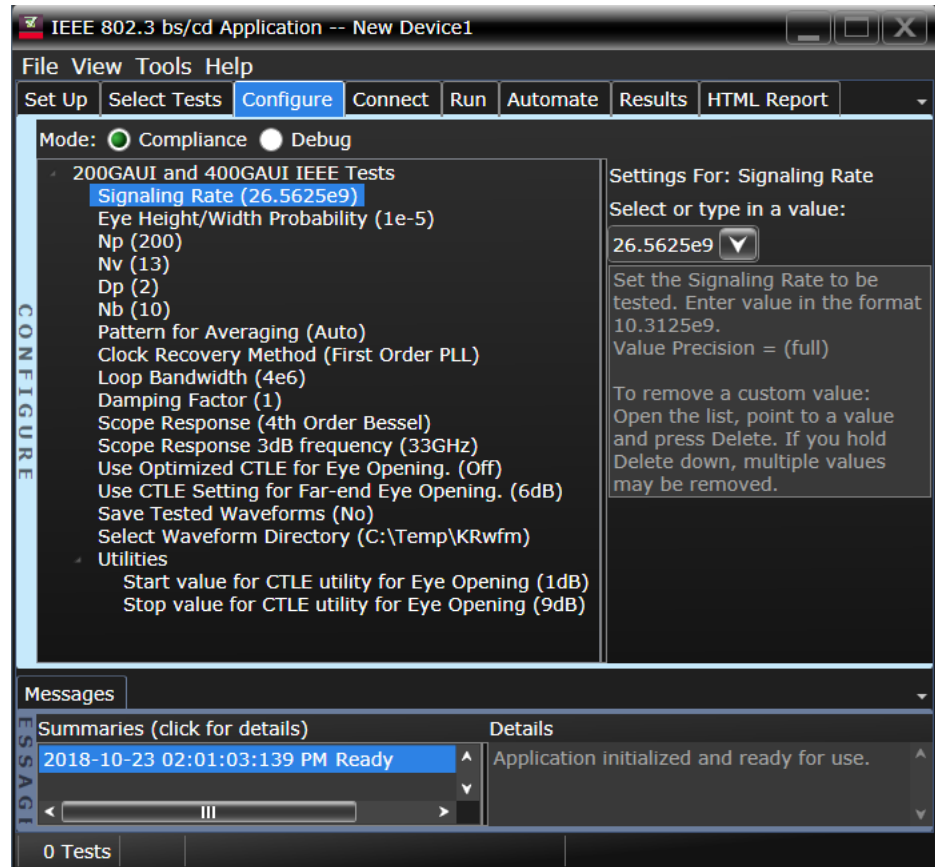


Figure 6 Configure tab in the IEEE802.3 bs/cd Test Application

- 4 In the **Connect** tab, view the instructions along with the connection diagram to ensure that all requirements for the physical setup of the testing instruments and the DUT are met. Click **Connection Completed** to indicate to the Test Application that the required hardware setup is complete. The connection diagram for most of the tests matches the one shown in [Figure 7](#) for UXR Series Oscilloscopes. However, it is a good practice to verify the connection diagram and

instructions displayed under this tab. The Test Application automatically indicates any changes in connections, if needed, during test runs.

- 5 Click **Run Tests** under this tab if you wish to start running tests. However, if you wish to modify the run settings before performing test runs, switch to the **Run** tab.

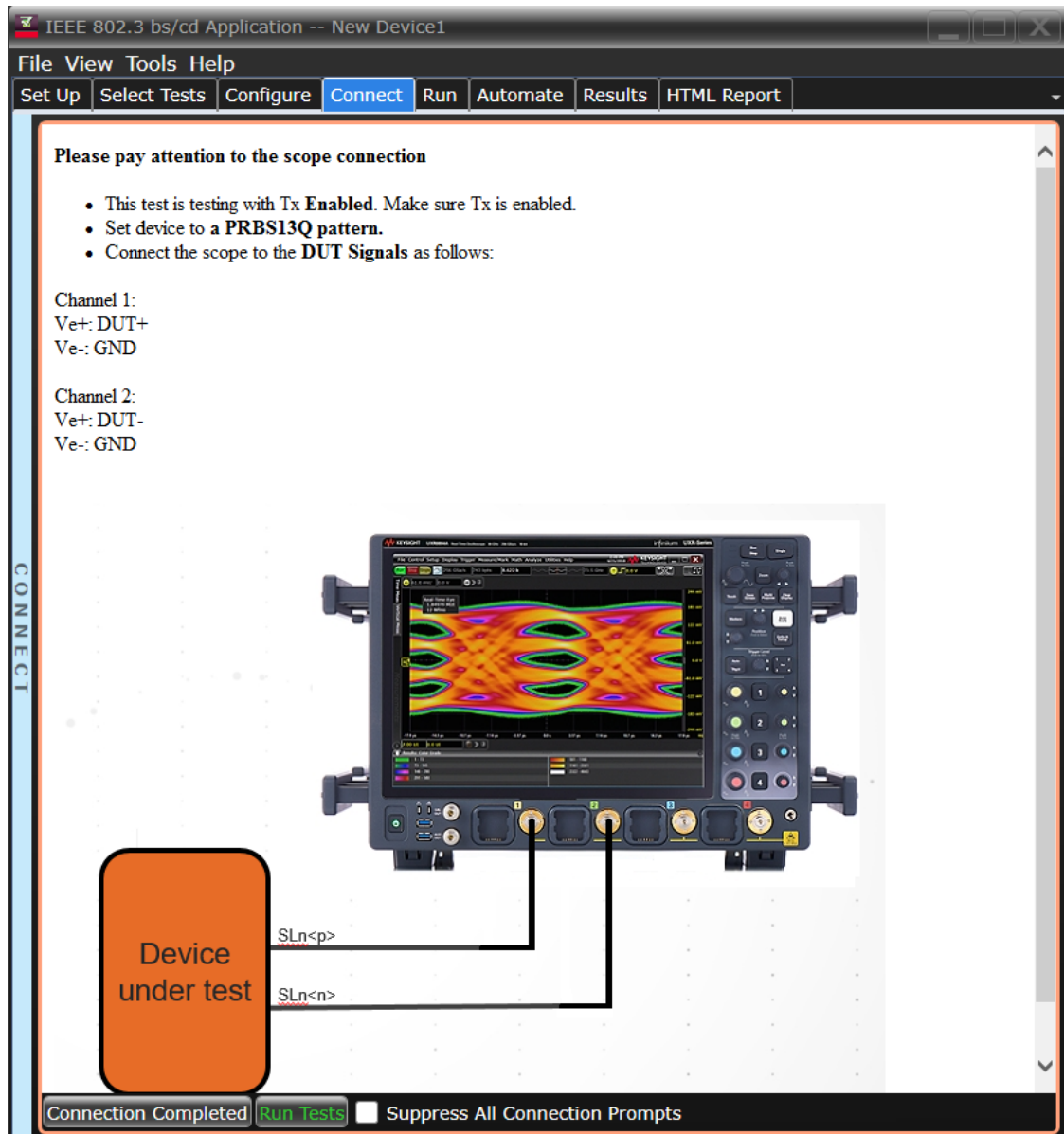


Figure 7 Connect tab in IEEE802.3 bs/cd Test Application on a UXR scope

- 6 In the **Run** tab, you may optionally modify one or more settings as described below, else click **Run** to start the test runs:
- determine the number of times each test must be run,
  - automate specific actions in case of events,
  - store results for certain type of test trials only,
  - send email notifications if the test runs pause or stop during runs.

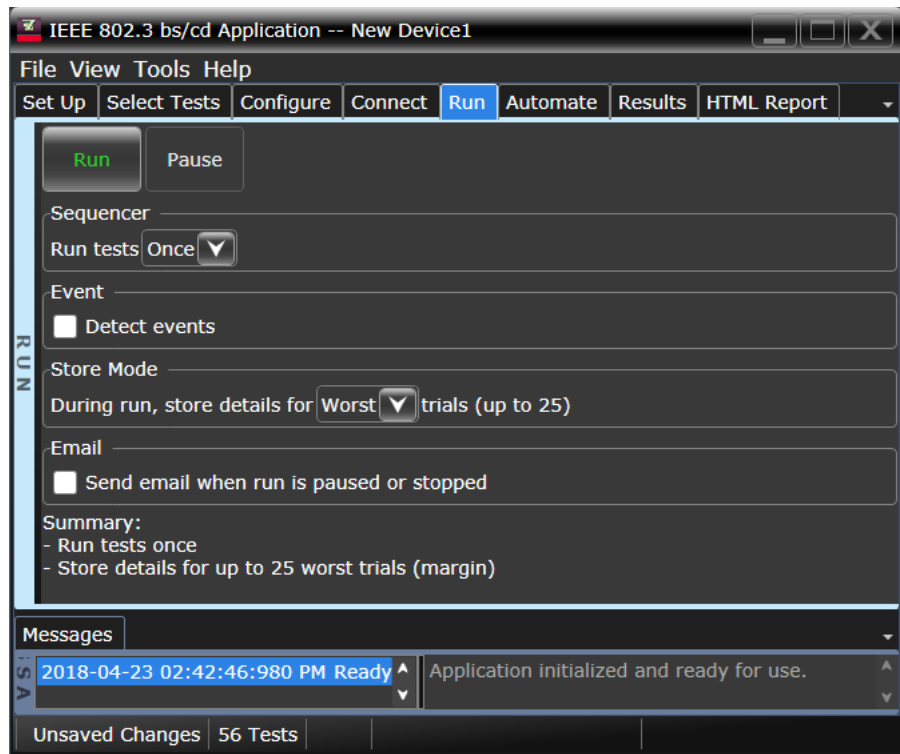


Figure 8 Run tab in IEEE802.3 bs/cd Test Application

- 7 In the **Automate** tab, you may optionally configure automation scripts to perform specific actions/sequences within the Test Application.
- 8 In the **Results** tab, which appears automatically after test runs are complete, view the test results displayed for each selected test.
- 9 In the **HTML Report** tab, view a comprehensive report for each test within the Application. The Test Application enables exporting these results in CSV or HTML format for the purpose of analysis.
- 10 To perform a high-level analysis on each measurement data, you may upload the results to the KS6800A Series Analytics Services Software. Refer to [“Exporting Measurement Results to Repository”](#) on page 28 to understand an overview on the functionality of this feature.

## Exporting Measurement Results to Repository

The Upload Results To Repository feature is an add-on to the Keysight Test Application, where it expands the boundaries of storing and analyzing the measurement results to a wider audience, who may be based in multiple sites across various geographical locations. Along with the feature of exporting test results from the Test Application into your local disk in a CSV or HTML file format, you have the option to upload the test results to a Dataset on a Web Repository. Based on your requirements, you may either upload only a single measurement trial or upload huge volumes of measurement results to any Dataset.

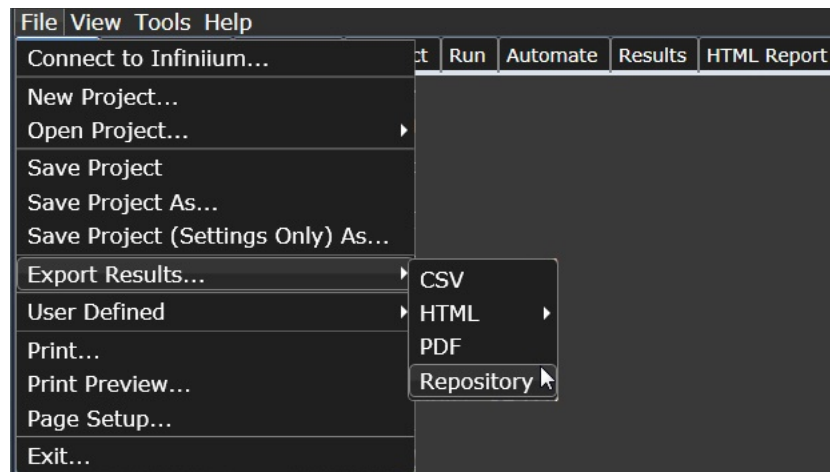
Not only can remote users with an active Internet connection access these Datasets and the corresponding test results on the Web Repository, but they have the option to add and delete Datasets on the Web Server. In the Upload Results To Repository feature, you can even modify the Dataset properties, which are helpful especially when performing a graphical analysis of the uploaded data.

In combination with the *Keysight KS6800A Series Analytics Software*, the Upload Results To Repository feature provides a comprehensive solution to export, view and perform analysis of the measurement results, thereby resulting in qualitative data to ensure that the Device Under Test (DUT) is compliant to the industry standards.

Refer to the *Keysight KS6800A Series Analytics Software Online Help* for more information about the functionality of various features in this software.

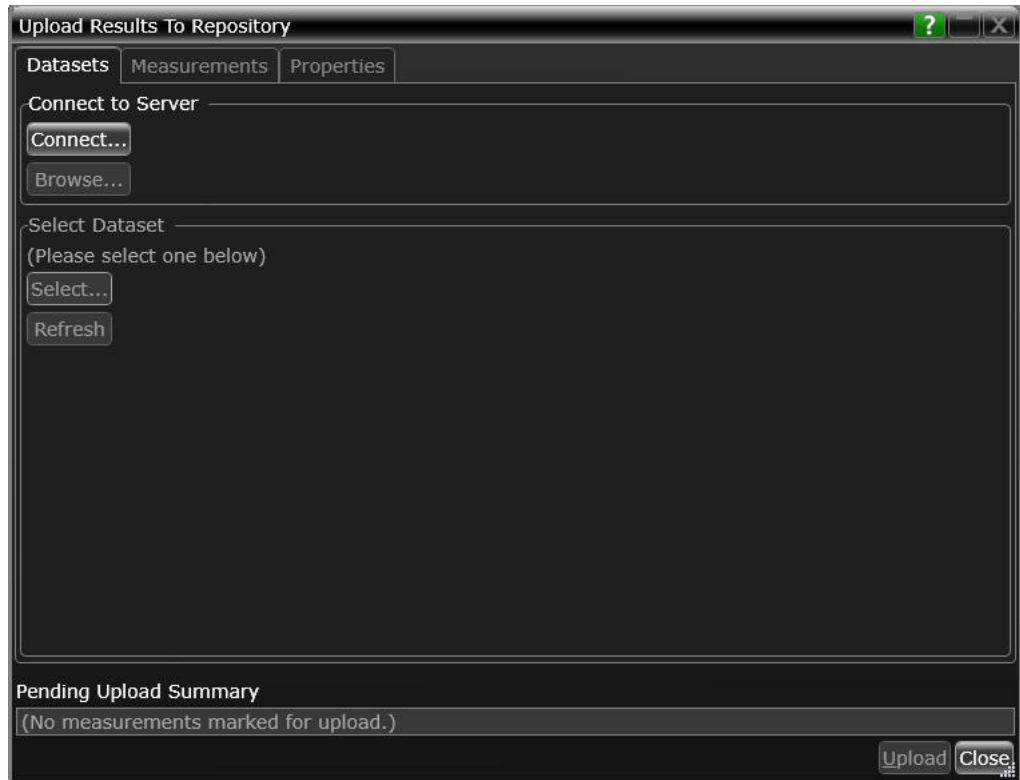
To export measurement results to the Repository after the completion of test runs,

- 1 From the Test Application's main menu, click **File > Export Results... > Repository**.



The **Upload Results to Repository** window appears.

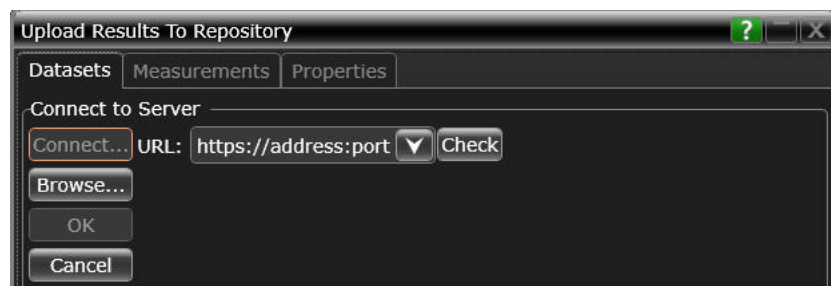
- 2 In the **Connect to Server** pane of the **Datasets** tab, click **Connect...** to login to the Dataset Repository server.



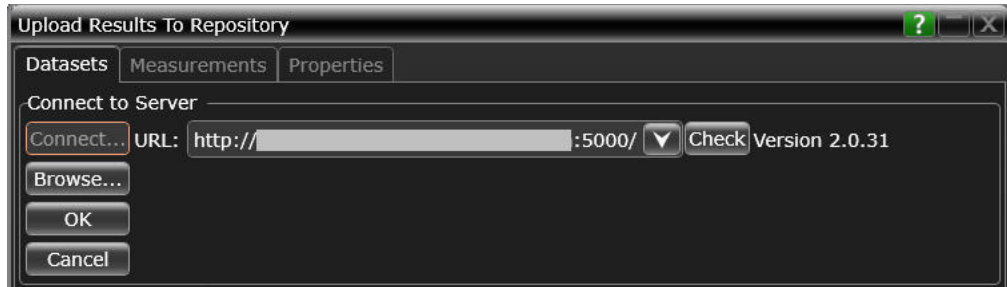
- 3 In the URL: drop-down text field that appears, replace the default text with the actual IP address or the URL along with the port number, if applicable.

You may enter the URL of the Web Repository server, which may be a self-hosted server on your machine (<http://localhost:5000/>), a remote server or an authentication server. Note that all such URLs accessed via this window appear as a drop-down list in the URL: field.

- 4 Click the Check button to verify that the KS6800A Series Analytics service is available on the specified web address. Repeat this step each time you edit the web address.



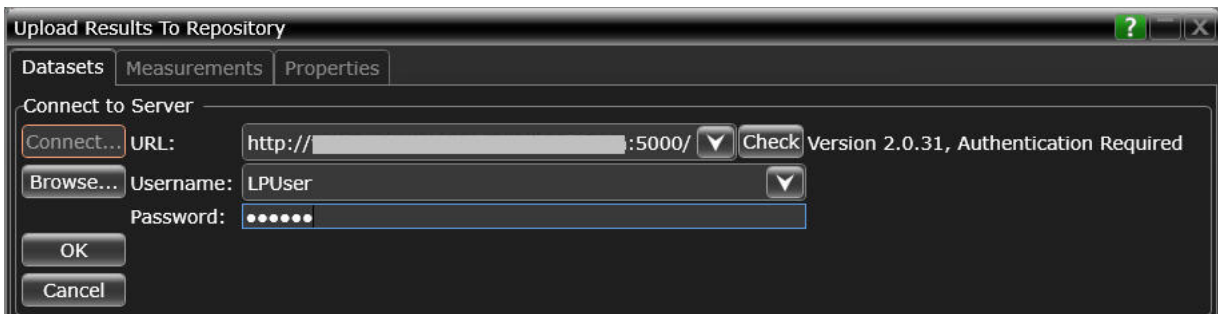
- For unrestricted access to the Repository
  - a If the server does not require authentication and the KS6800A Series Analytics service is found on the specified web address, the version information is displayed adjacent to the Check button.



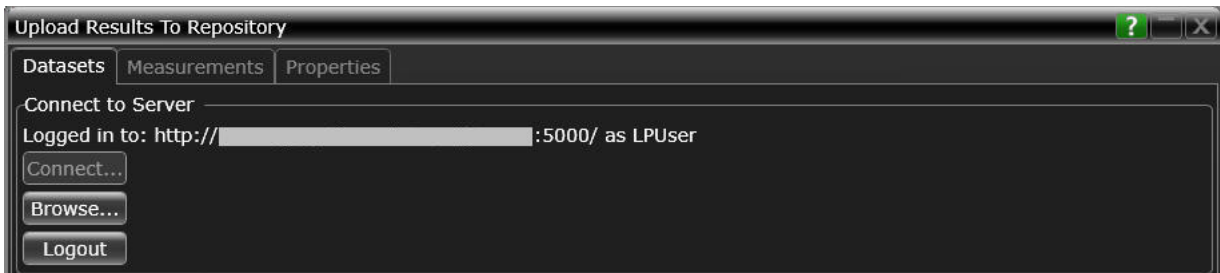
- b If you click OK, the Upload Results to Repository window displays the connectivity status to the Dataset Repository.
- c Click Browse... to navigate directly to the URL.



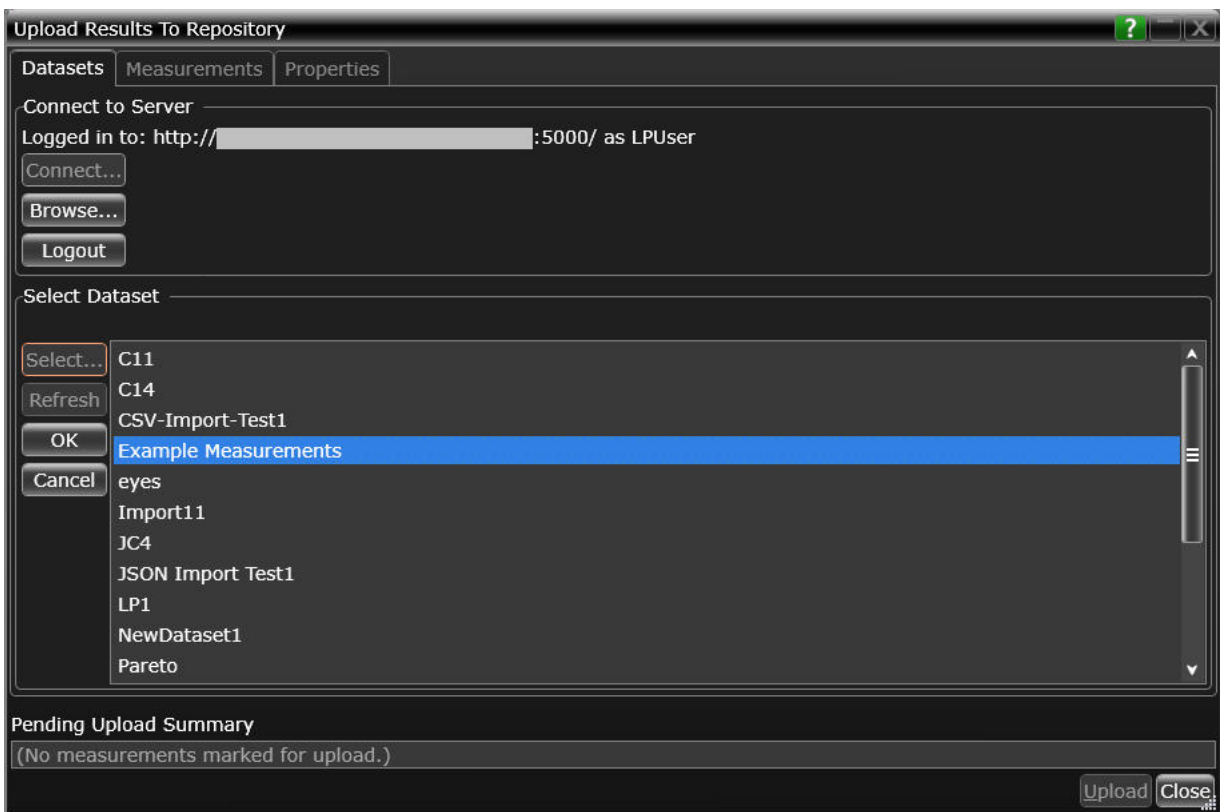
- For restricted access to the Repository
  - a If service is found on the specified URL but access to the web server is restricted based on authentication, the version information is displayed along with the text Authentication Required adjacent to the Check button. Also, the Username: and Password: fields appear. The OK button remains disabled until the authentication credentials are entered.
  - b Enter the user credentials in the respective fields, which are required for authentication to access those Datasets that have been created on the web server you are connecting to. For each URL that you access, the Username: drop-down box keeps a record and displays all user names used to access the respective URL.



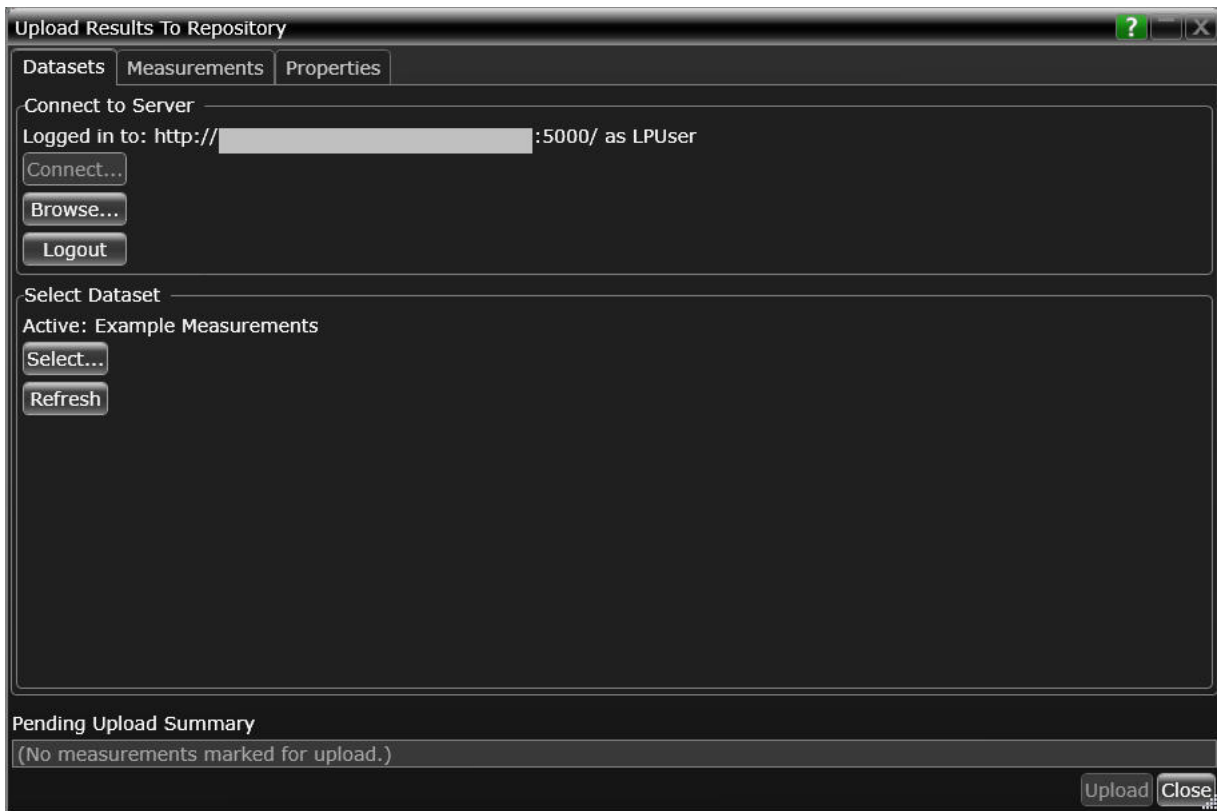
- c Click OK to connect to the entered URL/IP address.  
The Connect to Server area displays the connection status along with the username.
- d Click Browse... to navigate directly to the URL.



- 5 In the Select Dataset area, click Select... to view the list of Datasets created on the connected repository. Click Refresh to update the list of Datasets that appear in the Test Application's user interface.
- 6 Select the Dataset name where you wish to upload measurement results to. Click OK.

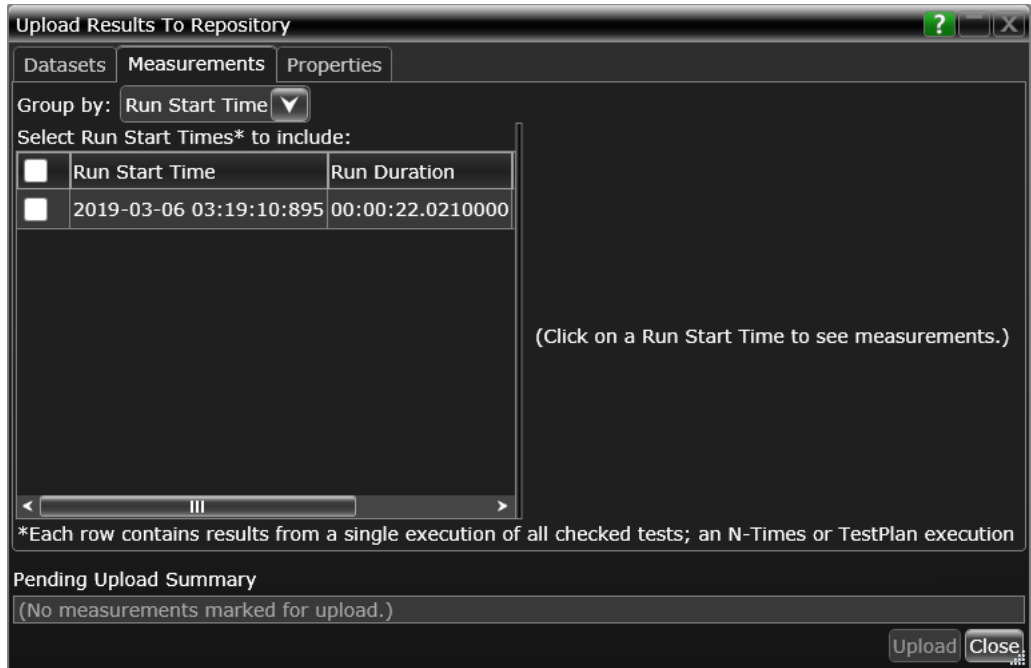


The Select Dataset area displays the selected Dataset as Active. The Measurements and Properties tabs are enabled after a Dataset is selected.



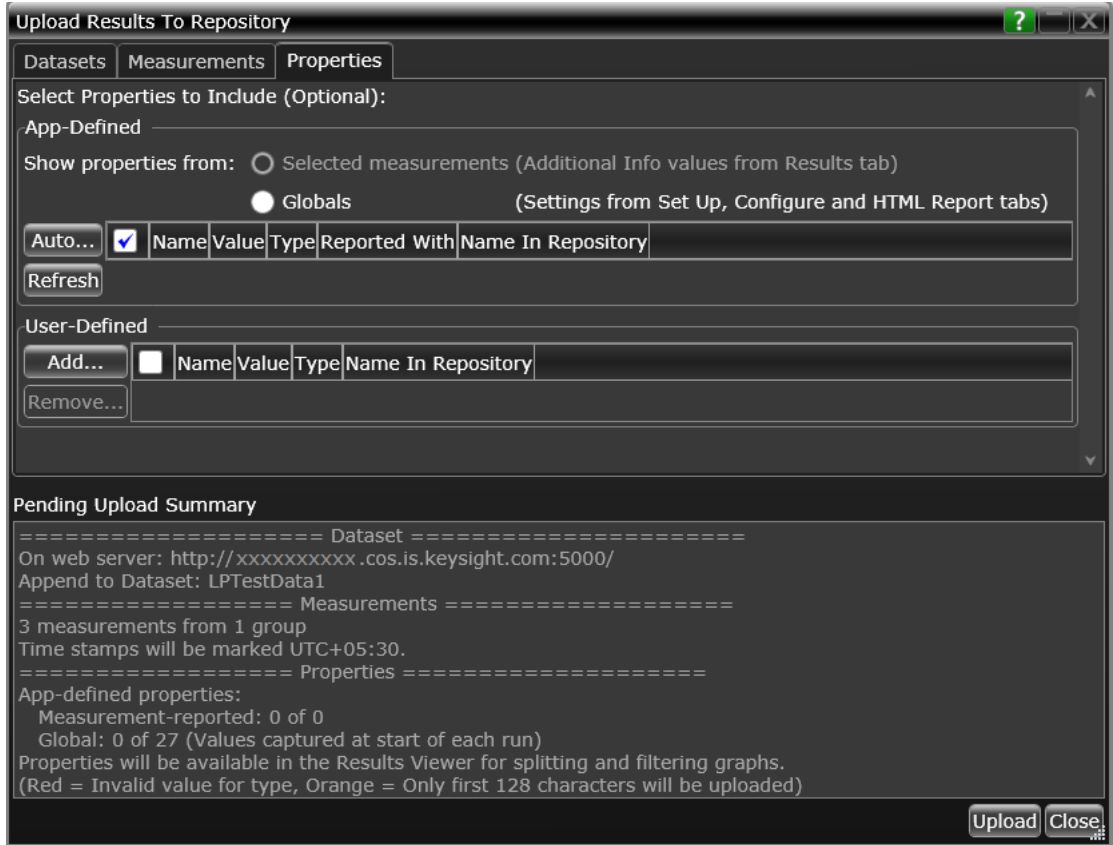


- 7 Click the **Measurements** tab where the test results from the last test run are displayed.
- 8 You may select and export multiple test results to the repository. You may change the format for the display of measurement data using the drop-down options in the **Group by:** field.

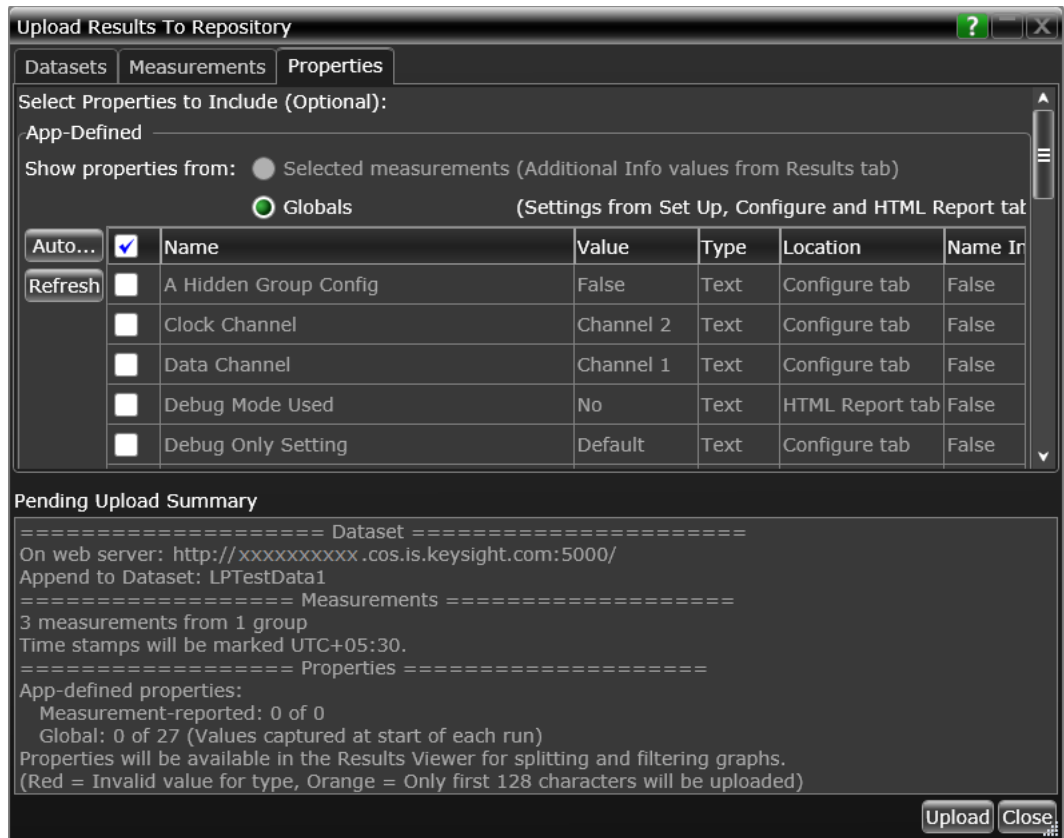


- 9 After selecting one or more measurements, either click **Upload** or switch to the **Properties** tab to associate one or more properties to the measurements that are being uploaded to the Web Server.

To perform an enhanced analysis on the measurement data using the *KS6800A Series Analytics Service Software*, Keysight recommends assigning properties to the measurements.



- Click the **Properties** tab to assign properties for your measurement results that you select to upload. By default, the **App-Defined** properties are selected to be uploaded in association with the measurement data, wherein only certain aspects of the selected measurements are uploaded. However, you may switch to **Globals** to include as properties one or more options configured under the rest of the tabs of the Compliance Test Application or define one or more custom property values to be associated with the selected measurement data.

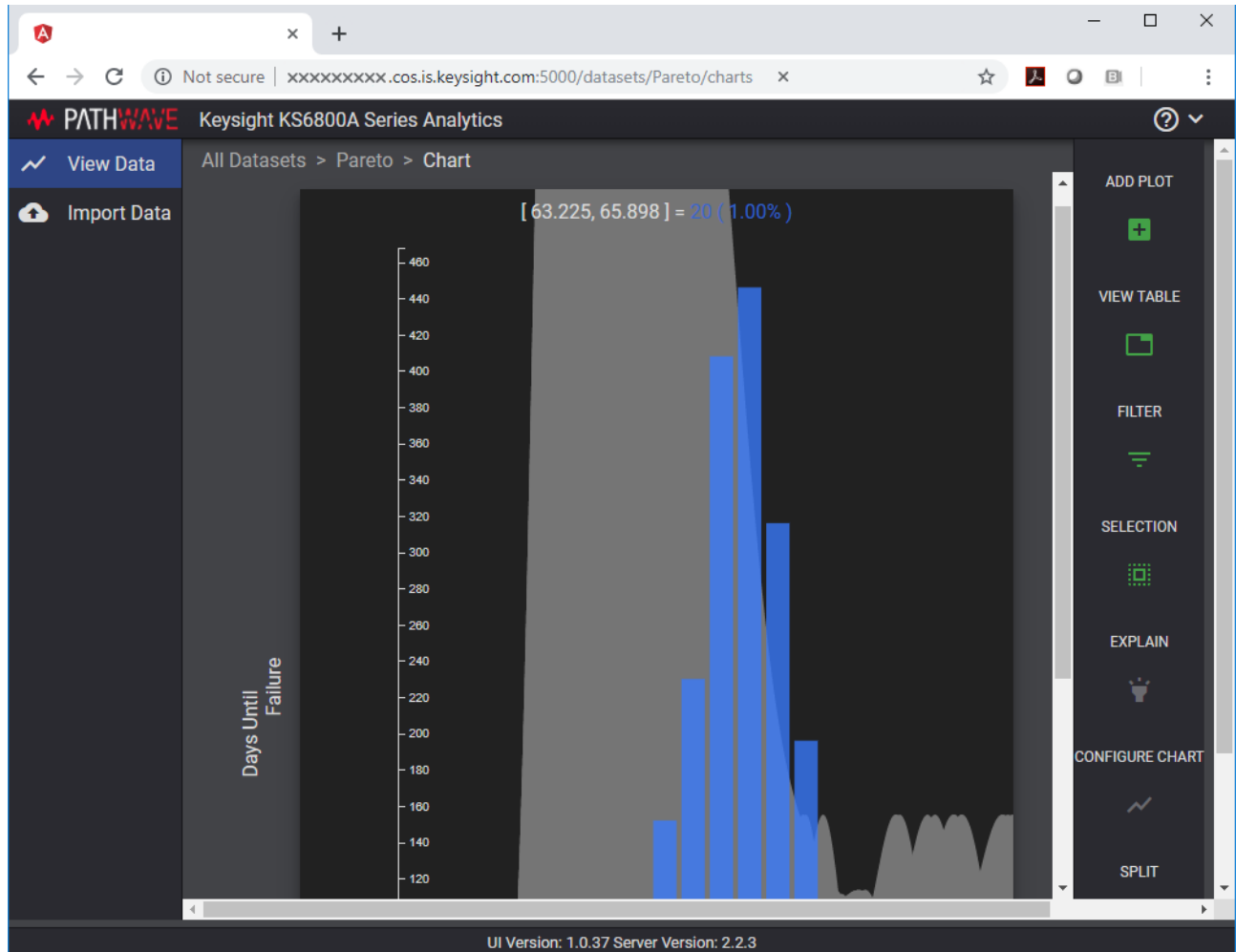


- Click **Upload** to begin uploading measurement results.
- Click **Close** to exit the **Upload Results to Repository** window and to return to the Compliance Test Application.

You may access the Dataset Repository using the Internet browser on your machine to view the measurement results graphically on the *KS6800A Series Analytics Service Software*.

## KS6800A Series Analytics Service Software

The KS6800A Series Analytics Service software supports multiple data sources and also a wide range of data import clients. This web-based software provides various types of charts, such as Histogram, Box-and-Whisker, Line, Scatter, Eye Diagram and Constellation, each with split capability to enable data analysis. Once you upload the measurement results to a Dataset on the *KS6800A Series Analytics Service Software* via the **Upload Results to Repository** window of the Test Application, the measurement results can be viewed graphically as shown below:



For more information on the Data Analytics Web Service Software, visit [KS6800A Series Analytics Service Software](#) page on the Keysight website. You may refer to the Help manual provided within the software to understand the functionality of its features.

## List of tests for Standard Option – Signal Type Combinations

Following tables display the test list that appears under the **Select Tests** tab for each combination of **Standard Option** and **Signal Type** under the **Set Up** tab:

**Table 1** Filtered test list for combinations of Standard Option and Signal Type at Test Point TP0a

Standard Option	Signal Type	Tests
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	PAM4	PAM4 Transmitter Characteristics at TP0a <ul style="list-style-type: none"> <li>▪ Jitter and Signaling Rate Measurements TP0a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ JRMS</li> <li>▪ J4u</li> <li>▪ Even-Odd Jitter</li> </ul> </li> <li>▪ Output Voltage Measurements EYE TP0a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Level - PRBS Pattern</li> <li>▪ Level RMS - PRBS Pattern</li> <li>▪ Level Separation Mismatch Ratio - RLM</li> </ul> </li> <li>▪ Output Waveform Measurements TP0a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Steady State Voltage Vf</li> <li>▪ Linear Fit Pulse Peak</li> <li>▪ Signal-to-noise-and-distortion ratio</li> <li>▪ SNR_ISI Tests</li> <li>▪ Pre and Post Equalization Tests</li> </ul> </li> <li>▪ Main Voltage Measurements TP0a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode Output Return Loss</li> </ul> </li> </ul>
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ LAUI 2</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	NRZ	NRZ Transmitter Characteristics at TP0a <ul style="list-style-type: none"> <li>▪ Jitter and Signaling Rate Measurements TP0a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ Even-Odd Jitter</li> <li>▪ Effective bounded uncorrelated jitter</li> <li>▪ Effective total uncorrelated jitter</li> </ul> </li> <li>▪ Output Waveform Measurements TP0a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Steady State Voltage Vf</li> <li>▪ Linear Fit Pulse Peak</li> <li>▪ Signal-to-noise-and-distortion ratio</li> <li>▪ Pre and Post Equalization Tests</li> </ul> </li> <li>▪ Main Voltage Measurements TP0a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode Output Return Loss</li> </ul> </li> </ul>

Standard Option	Signal Type	Tests
<ul style="list-style-type: none"> <li>▪ 50GBASE-KR, 100GBASE-KR2, and 200GBASE-KR4</li> </ul>	PAM4	PAM4 Transmitter Characteristics at TP0a <ul style="list-style-type: none"> <li>▪ Jitter and Signaling Rate Measurements TP0a (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ JRMS</li> <li>▪ J3u</li> <li>▪ Even-Odd Jitter</li> </ul> </li> <li>▪ Output Voltage Measurements EYE TP0a (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Level - PRBS Pattern</li> <li>▪ Level RMS - PRBS Pattern</li> <li>▪ Level Separation Mismatch Ratio - RLM</li> </ul> </li> <li>▪ Output Waveform Measurements TP0a (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Steady State Voltage Vf</li> <li>▪ Linear Fit Pulse Peak</li> <li>▪ Signal-to-noise-and-distortion ratio</li> <li>▪ ERL Test</li> <li>▪ Coefficient Initialization - Preset n</li> <li>▪ abs Step Size Test</li> </ul> </li> <li>▪ Main Voltage Measurements TP0a (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements               <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode Output Return Loss</li> </ul> </li> </ul>

**Table 2** Filtered test list for combinations of Standard Option and Signal Type at Test Point TP1a

Standard Option	Signal Type	Tests
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	PAM4	<p>PAM4 Host Output Characteristics at TP1a</p> <ul style="list-style-type: none"> <li>▪ Main Voltage Measurements TP1a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ Single-Ended Output Voltage Test</li> </ul> </li> <li>▪ Transition Time Measurements TP1a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Minimum Output Rise Time (20%-80%)</li> <li>▪ Minimum Output Fall Time (20%-80%)</li> </ul> </li> <li>▪ Signaling Rate and Eye Mask Measurements TP1a (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ Eye Height</li> <li>▪ Eye Width</li> <li>▪ ESMW</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode to Differential Output Return Loss</li> </ul> </li> </ul>
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ LAUI 2</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	NRZ	<p>NRZ Host Output Characteristics at TP1a</p> <ul style="list-style-type: none"> <li>▪ Main Voltage Measurements TP1a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ Single-ended Output Voltage Test</li> </ul> </li> <li>▪ Transition Time Measurements TP1a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Minimum Output Rise Time (20%-80%)</li> <li>▪ Minimum Output Fall Time (20%-80%)</li> </ul> </li> <li>▪ Signaling Rate and Eye Mask Measurements TP1a (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ Eye Height</li> <li>▪ Eye Width</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode to Differential Output Return Loss</li> </ul> </li> </ul>

**Table 3** Filtered test list for combinations of Standard Option and Signal Type at Test Point TP4

Standard Option	Signal Type	Tests
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	PAM4	PAM4 Module Output Characteristics at TP4 <ul style="list-style-type: none"> <li>▪ Main Voltage Measurements TP4 (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Differential Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ DC Common Mode Voltage Test</li> </ul> </li> <li>▪ Transition Time Measurements TP4 (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Minimum Output Rise Time (20%-80%)</li> <li>▪ Minimum Output Fall Time (20%-80%)</li> </ul> </li> <li>▪ Signaling Rate and Eye Mask Measurements TP4 (pattern: PRBS13Q)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ Near-end Eye Height</li> <li>▪ Near-end Eye Width</li> <li>▪ Near-end ESMW</li> <li>▪ Vertical Eye Closure</li> <li>▪ Far-end Eye Height</li> <li>▪ Far-end Eye Width</li> <li>▪ Far-end ESMW</li> <li>▪ Far-end pre-cursor ISI ratio</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode to Differential Output Return Loss</li> </ul> </li> </ul>
<ul style="list-style-type: none"> <li>▪ 200GAUI-x and 400GAUI-x</li> <li>▪ LAUI 2</li> <li>▪ 50GAUI-x and 100GAUI-x</li> </ul>	NRZ	NRZ Module Output Characteristics at TP4 <ul style="list-style-type: none"> <li>▪ Main Voltage Measurements TP4 (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Differential Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ DC Common Mode Voltage Test</li> </ul> </li> <li>▪ Transition Time Measurements TP4 (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Minimum Output Rise Time (20%-80%)</li> <li>▪ Minimum Output Fall Time (20%-80%)</li> </ul> </li> <li>▪ Signaling Rate and Eye Mask Measurements TP4 (pattern: PRBS9)                             <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ Near-end Eye Height</li> <li>▪ Near-end Eye Width</li> <li>▪ Vertical Eye Closure</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements                             <ul style="list-style-type: none"> <li>▪ Differential Output Return Loss</li> <li>▪ Common-mode to Differential Output Return Loss</li> </ul> </li> </ul>



**Table 4** Filtered test list for combinations of Standard Option and Signal Type at Test Point TP2

Standard Option	Signal Type	Tests
<ul style="list-style-type: none"> <li>▪ 50GBASE-CR, 100GBASE-CR2, and 200GBASE-CR</li> </ul>	<p>PAM4</p>	<p>PAM4 Transmitter Characteristics at TP2</p> <ul style="list-style-type: none"> <li>▪ Jitter and Signaling Rate Measurements TP2 (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Signaling Rate</li> <li>▪ JRMS</li> <li>▪ J3u</li> <li>▪ Even-Odd Jitter</li> </ul> </li> <li>▪ Output Voltage Measurements EYE TP2 (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Level - PRBS Pattern</li> <li>▪ Level RMS - PRBS Pattern</li> <li>▪ Level Separation Mismatch Ratio - RLM</li> </ul> </li> <li>▪ Output Waveform Measurements TP2 (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Steady State Voltage Vf</li> <li>▪ Linear Fit Pulse Peak</li> <li>▪ Signal-to-noise-and-distortion ratio</li> <li>▪ ERL Test</li> <li>▪ Coefficient Initialization - Preset n</li> <li>▪ abs Step Size Test</li> </ul> </li> <li>▪ Main Voltage Measurements TP2 (pattern: PRBS13Q)               <ul style="list-style-type: none"> <li>▪ Differential Peak-to-Peak Output Voltage Test with TX Disabled</li> <li>▪ DC Common Mode Output Voltage Test</li> <li>▪ AC Common Mode Output Voltage Test</li> <li>▪ Differential Peak-to-Peak Output Voltage Test</li> </ul> </li> <li>▪ Return Loss PNA/ENA Measurements               <ul style="list-style-type: none"> <li>▪ Common-mode Output Return Loss</li> <li>▪ Common-mode to Differential Output Return Loss</li> </ul> </li> </ul>



# 4 PAM4 Transmitter Characteristics at TP0a

Jitter and Signaling Rate Measurements TP0a 46

Output Voltage Measurements EYE TP0a 53

Output Waveform Measurements TP0a 57

Main Voltage Measurements TP0a 84

Return Loss ENA/PNA Measurements 89

This section provides the Methods of Implementation (MOIs) for the IEEE PAM4 Transmitter Characteristics at TP0a. Measurements are made at test point TP0a.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## C2C transmitter characteristics

## PAM4 GAUI-x tests

See [Table 5](#) for pass limits pertaining to 200GAUI-x and 400GAUI-x PAM4 tests, which are specified in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1, Table 120D-1.

**Table 5 200GAUI-4 and 400GAUI-8 C2C transmitter characteristics at TP0a**

Parameter	Reference	Value	Units
Signaling rate per lane (range)		26.5625 ± 100 ppm	GBd
Differential peak-to-peak output voltage <sup>a</sup> (max)	See Sec. 93.8.1.3 of the IEEE specification	30	mV
Transmitter disabled		1200	mV
Transmitter enabled			
Common-mode voltage <sup>a</sup> (max)	See Sec. 93.8.1.3 of the IEEE specification	1.9	V
Common-mode voltage <sup>a</sup> (min)	See Sec. 93.8.1.3 of the IEEE specification	0	V
AC common-mode output voltage <sup>a</sup> (max, RMS)	See Sec. 93.8.1.3 of the IEEE specification	30	mV
Differential output return loss (min)	See Sec. 120D.3.1.1 of the IEEE specification	See Equation (120D-2) of the IEEE specification	dB
Common-mode output return loss (min)	See Sec. 93.8.1.4 of the IEEE specification	See Equation (93-4) of the IEEE specification	dB
Output waveform <sup>b</sup>	See Sections		
Level separation mismatch ratio RLM(min)	120D.3.1.2	0.95	-
Steady state voltage vf (max)	120D.3.1.4	0.6	V
Steady state voltage vf (min)	120D.3.1.4	0.4	V
Linear fit pulse peak (min)	120D.3.1.4	0.76 × vf	V
Pre-cursor equalization	120D.3.1.5	Table 120D-2	-
Post-cursor equalization	120D.3.1.5	Table 120D-3	-
Signal-to-noise-and-distortion ratio SNDR (min)	See Sec.120D.3.1.6 of the IEEE specification	31.5	dB
Transmitter Output residual ISI SNRISI (min)	See Sec. 120D.3.1.7 of the IEEE specification	34.8	dB
Output jitter	See Sections		
JRMS (max)	120D.3.1.8	0.023	UI
J4u (max)	120D.3.1.8	0.118	UI
Even-odd jitter (max)	120D.3.1.8	0.019	UI

a. Measurement uses the method described in section 93.8.1.3 of IEEE specification with the exception that the PRBS13Q test pattern is used.

b. The state of the transmit equalizer is controlled by management interface.

For PAM4 KR tests

A 50GBASE-KR, 100GBASE-KR2, and 200GBASE-KR4 chip-to-chip transmitter shall meet all specifications in section 137.9.2 of the IEEE specification (refer to Table 5 for limits corresponding to Table 120D-1) with the following exceptions:

- The value for the “Linear fit pulse peak (min)” is  $0.75 \times vf$ .
- The output waveform Pre-cursor equalization and Post-cursor equalization parameters are replaced by the “Transmitter output waveform” specifications summarized in Table 136–11 and detailed in 136.9.3.1.
- The differential output return loss (min) and  $SNR_{ISI}$  (min) requirements are replaced by the transmitter effective return loss (ERL) specification in 137.9.2.1.
- The value of SNDR (min) is 32.5 dB.
- The J4u limit in Table 120D–1 does not apply. The maximum J3u (see 136.9.3.3) is 0.106 UI.

## Jitter and Signaling Rate Measurements TP0a

The Jitter and Signaling Rate Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

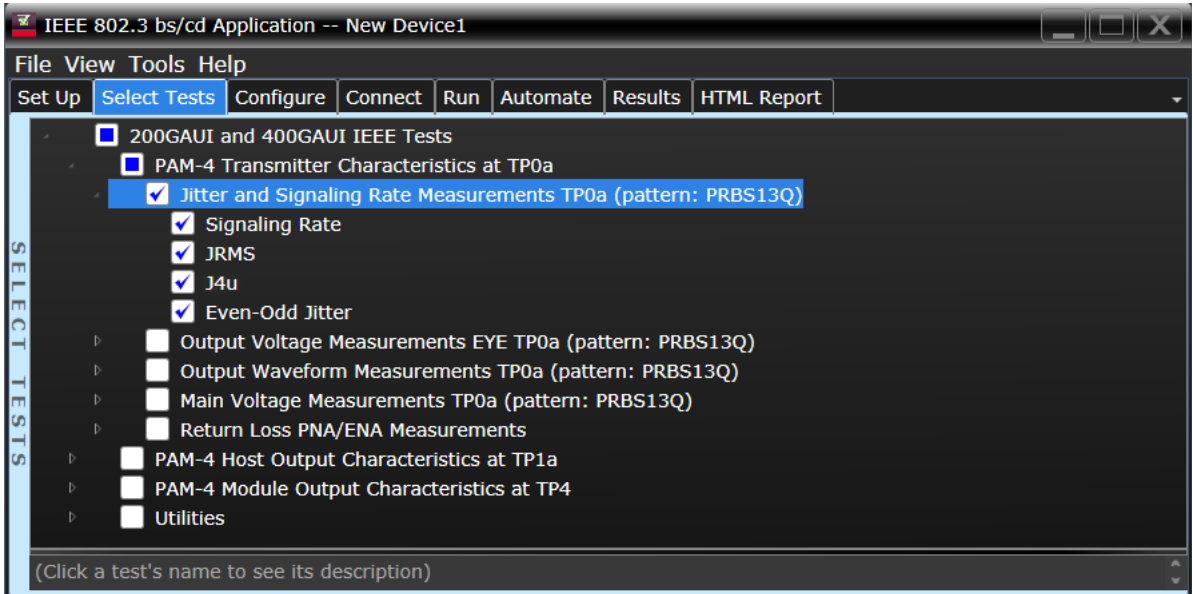


Figure 9 Selecting Jitter and Signaling Rate Measurement Tests - 200GAUI and 400GAUI IEEE

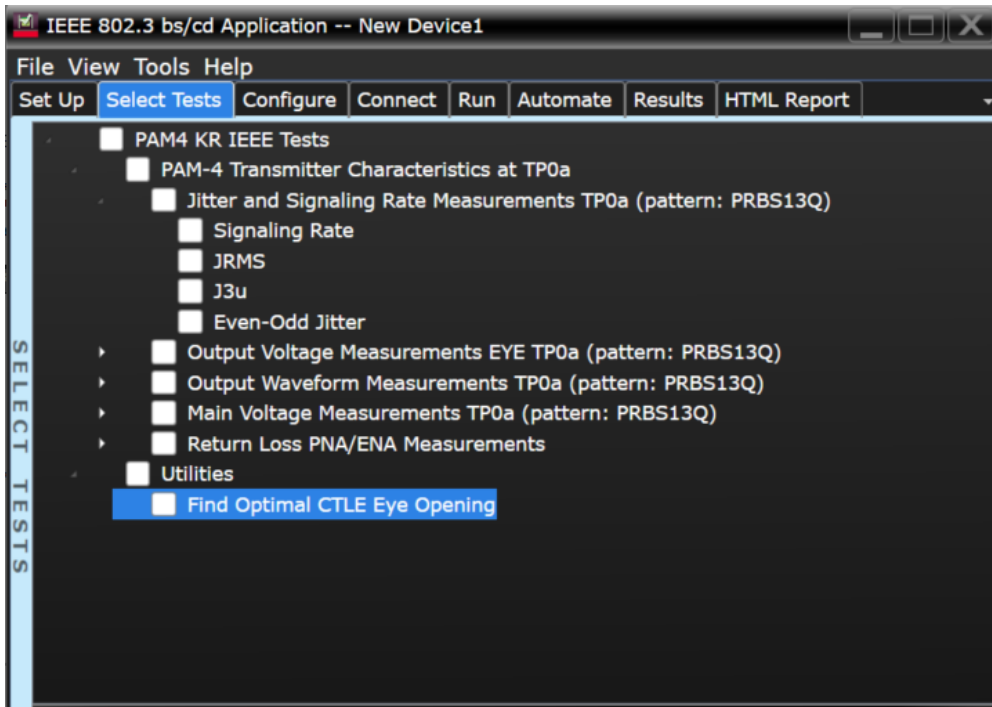


Figure 10 Selecting Jitter and Signaling Rate Measurement Tests - PAM4 KR IEEE

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Jitter and Signaling Rate Measurements TP0a (pattern: PRBS13Q) tests, see:

- [“Signaling Rate”](#) on page 48
- [“JRMS”](#) on page 49
- [“J4u”](#) on page 50
- [“J3u”](#) on page 51
- [“Even-Odd Jitter”](#) on page 52

### Signaling Rate

- Test Overview** The purpose of this test is to verify that the signaling rate meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS13Q must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum and maximum data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with the specified standards. Report the resulting value.



## JRMS

<b>Test Overview</b>	The purpose of this test is to verify that differential signal's JRMS meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
<b>Pass Conditions</b>	Refer to the section <a href="#">C2C transmitter characteristics</a> for the pass limits pertaining to each standard option.
<b>Measurement Algorithm</b>	1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the JRMS value to the specified standards.

J4u

**Test Overview** The purpose of this test is to verify that differential signal's J4u meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.

**Pass Conditions** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm** 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the J4u value meets the specified standards.

J3u

<b>Test Overview</b>	The purpose of this test is to verify that differential signal's J3u meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
<b>Pass Conditions</b>	Refer to the section <a href="#">C2C transmitter characteristics</a> for the pass limits pertaining to each standard option.
<b>Measurement Algorithm</b>	1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the J3u value meets the specified standards.

## Even-Odd Jitter

- Test Overview** The purpose of this test is to verify that differential signal's Even-Odd Jitter meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
- Pass Conditions** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.  
Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
- 3 On the Oscilloscope,
  - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
  - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 4 Compare and report the Even-Odd Jitter value to the specified standards.

## Output Voltage Measurements EYE TP0a

The Output Voltage Measurement EYE procedures for a signal with PRBS13Q pattern that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

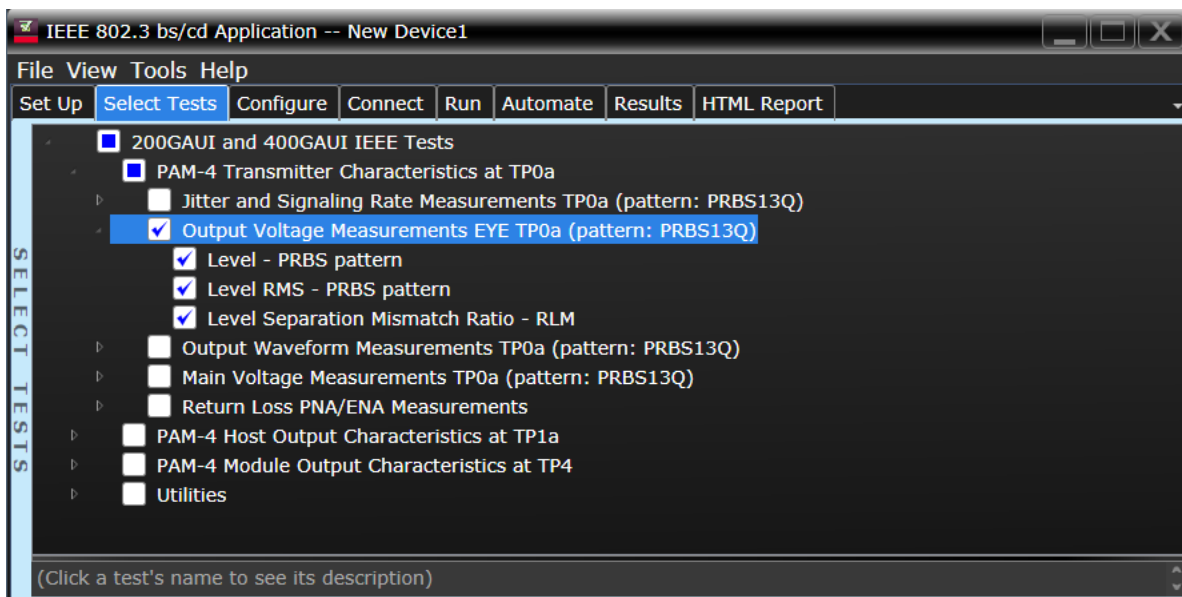


Figure 11 Selecting Output Voltage Measurements EYE Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Output Voltage Measurements EYE TP0a (pattern: PRBS13Q) tests, see:

- “[Level - PRBS Pattern](#)” on page 54
- “[Level RMS - PRBS Pattern](#)” on page 55
- “[Level Separation Mismatch Ratio - RLM](#)” on page 56

### NOTE

The tests [Level - PRBS pattern](#) and [Level RMS - PRBS pattern](#) are considered as “Information-Only” tests and cannot be used for compliance validation.

## Level - PRBS Pattern

- Test Overview** The purpose of this test is to obtain the mean voltage of each level of the signal with PRBS13Q pattern.
- Pass Condition** Not applicable as the test result is considered as “Information Only”.
- Measurement Algorithm**
- 1 Check that signal is connected and proper data pattern exists (PRBS13Q pattern must be used for this test).
  - 2  $V_0$ ,  $V_1$ ,  $V_2$  and  $V_3$  are the mean signal levels of the symbols corresponding to the PAM4 symbol levels 0, 1, 2 and 3 respectively, as defined in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2. The calculation of mean signal levels is also defined in section 120D.3.1.2.1.
  - 3 Average the pattern - 16 averages at 32 points per UI. For each pattern level create a histogram of the middle points of each UI. Calculate the mean of each histogram.
  - 4 Report these values for information-only purpose.

## Level RMS - PRBS Pattern

- Test Overview** The purpose of this test is to obtain the of the RMS level of the signal with PRBS13Q pattern.
- Pass Condition** Not applicable as the test result is considered as “Information Only”.
- Measurement Algorithm**
- 1 Run the Level - PRBS Pattern test as a prerequisite to this test.
  - 2 The minimum signal level RMS is calculated, as defined in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2. The RMS deviation is measured from the mean voltage at a point in long runs of each level.
  - 3 Report this value for information-only purpose.

## Level Separation Mismatch Ratio - RLM

- Test Overview** The purpose of this test is to obtain the of the Separation Mismatch Ratio level (RLM) of the signal with PRBS13Q pattern.
- Pass Condition** Refer to the section **C2C transmitter characteristics** for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Run the Level - PRBS Pattern as a prerequisite to this test to calculate the mid-range level.
  - 2 The mean signal levels are normalized so that  $V_0$  corresponds to -1,  $V_1$  to -ES1,  $V_2$  to ES2 and  $V_3$  to 1.
  - 3 The mean level  $V_{mid}$  is defined by equation (120D-3):
 
$$V_{mid} = (V_0 + V_3) / 2$$
  - 4 ES1 and ES2 are calculated using equations (120D-4) and (120D-5), respectively of the IEEE P802.3bs<sup>TM</sup>/D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2.
 
$$ES1 = (V_1 - V_{mid}) / (V_0 - V_{mid})$$

$$ES2 = (V_2 - V_{mid}) / (V_3 - V_{mid})$$
  - 5 The level separation mismatch ratio  $R_{LM}$  is defined by equation (120D-5).
 
$$R_{LM} = \min [(3 \times ES1), (3 \times ES2), (2 - 3 \times ES1), (2 - 3 \times ES2)]$$
  - 6 Report this value. It should be  $\geq 0.95$ .



## Output Waveform Measurements TP0a

The Output Waveform Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

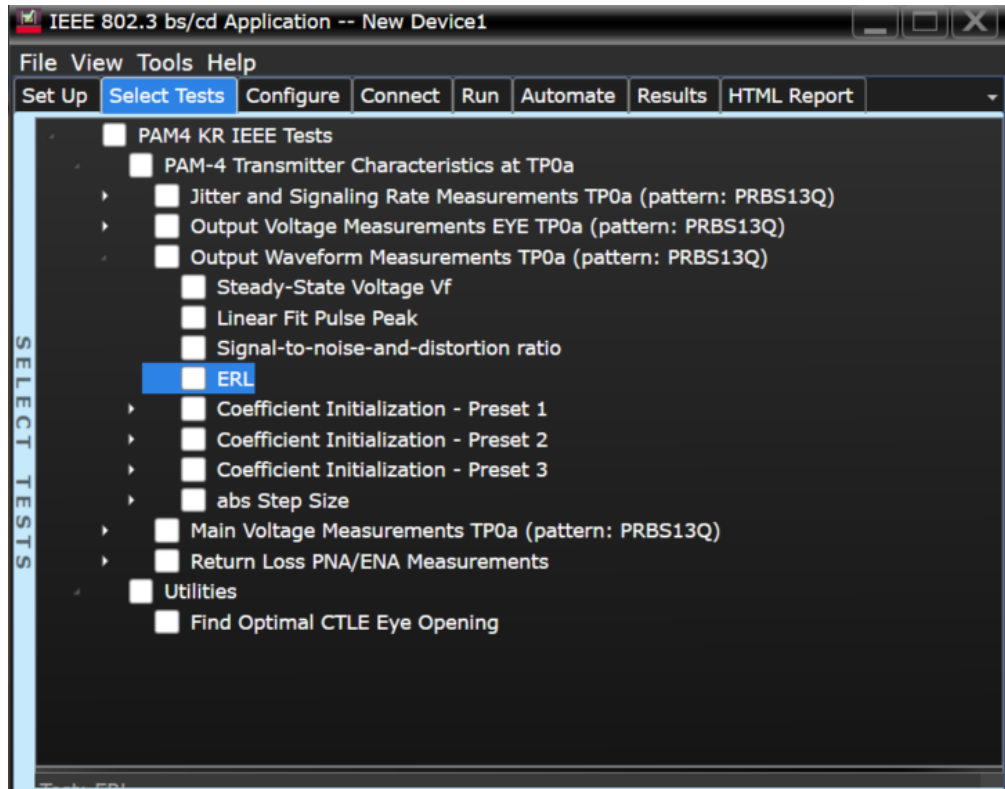


Figure 12 Selecting Transmitter Output Waveform Measurement Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Output Waveform Measurements TP0a (pattern: PRBS13Q) tests, see:

- [“Steady State Voltage Vf”](#) on page 58
- [“Linear Fit Pulse Peak”](#) on page 59
- [“Signal-to-noise-and-distortion ratio”](#) on page 60
- [“SNR\\_ISI Tests”](#) on page 61
- [“Pre and Post Equalization Tests”](#) on page 62
- [“ERL Test”](#) on page 73
- [“Coefficient Initialization - Preset n”](#) on page 74
- [“abs Step Size Test”](#) on page 76

Steady State Voltage  $V_f$

- Test Overview** The purpose of this test is to verify that the Steady State Voltage is between 0.4V and 0.6V.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Check that signal is connected and proper data pattern exists (PRBS13Q must be used for this test).
  - 2 Set memory depth and sample rate to capture the 8191 bits of the PRBS13Q pattern.
  - 3 Calculate  $V_f$  using the equations in section 85.8.3.3.5. The resulting value is the sum of columns of  $p(k)/M$ .  $N_p = 200$ ,  $D_p = 2$ .
  - 4 Compare and report the resulting value in the range between 0.4V and 0.6V.

## Linear Fit Pulse Peak

**Test Overview** The purpose of this test is to verify that the Linear Fit Pulse meets the specified standards.

**NOTE**

Run the Steady-State Voltage Vf test as a prerequisite to running the Linear Fit Pulse Peak test.

---

**Pass Conditions** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Check that signal is connected and proper data pattern exists (PRBS13Q must be used for this test).
- 2 Set memory depth and sample rate to capture the 8191 bits of the PRBS13Q pattern.
- 3 Calculate Linear Fit Pulse using the equations in section 85.8.3.3.5. The resulting value is the peak value of  $p(k)$ .  $N_p = 200$ ,  $D_p = 2$ .
- 4 Compare the specified standards to the resulting value.

Signal-to-noise-and-distortion ratio

- Test Overview** The purpose of this test is to verify that the Signal-to-noise-and-distortion ratio (SNDR) meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Calculate SNDR using measurements from Level RMS - PRBS pattern test and error from Linear Fit Pulse Peak test.
  - 2 Compare the resulting value of SNDR to the specified standards.

## SNR\_ISI Tests

**Test Overview** The purpose of this test is to verify that the Transmitter Output residual ratio (SNR\_ISI) for each value of Output Gain (in decibels) meets the specified standards.

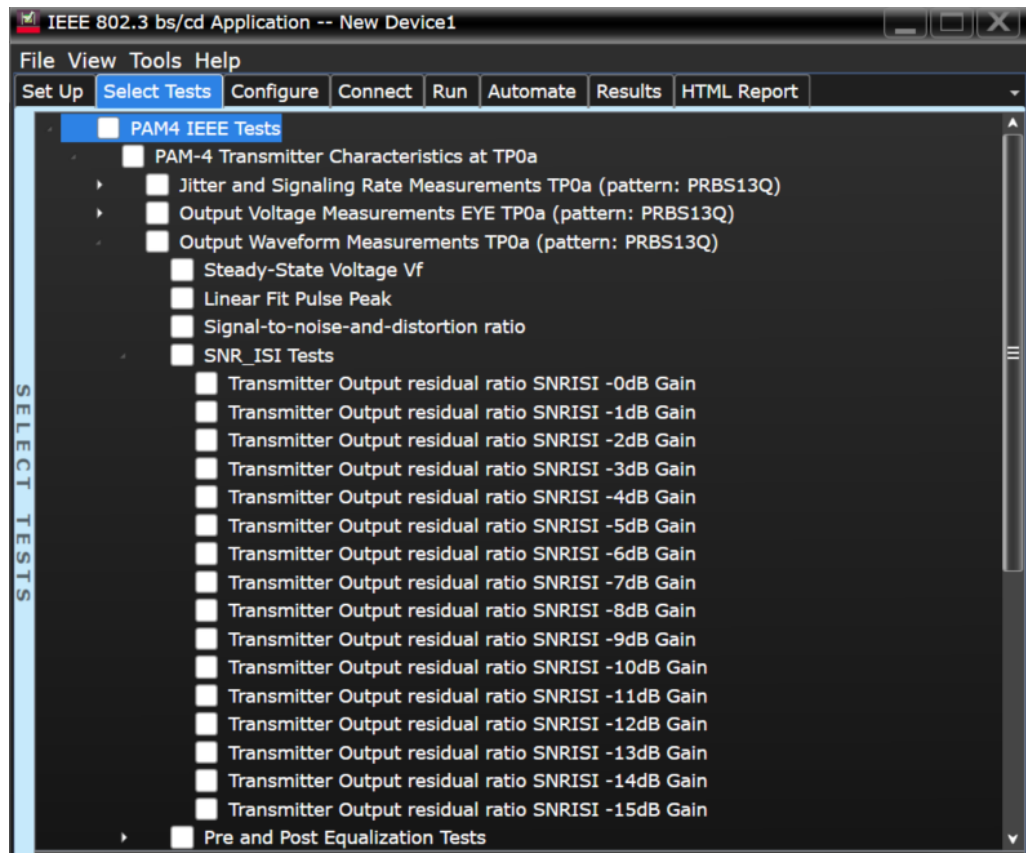


Figure 13 Selecting SNR\_ISI Tests

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

- Measurement Algorithm**
- 1 Select one or more tests that pertain to a specific Output Gain value.
  - 2 Calculate SNRISI for each selected test using measurements from Level RMS - PRBS pattern test and error from Linear Fit Pulse Peak test.
  - 3 Compare the resulting value to the specified standards.

## Pre and Post Equalization Tests

**Test Overview** The purpose of this test is to verify the Pre-cursor and Post-cursor equalization ratios.

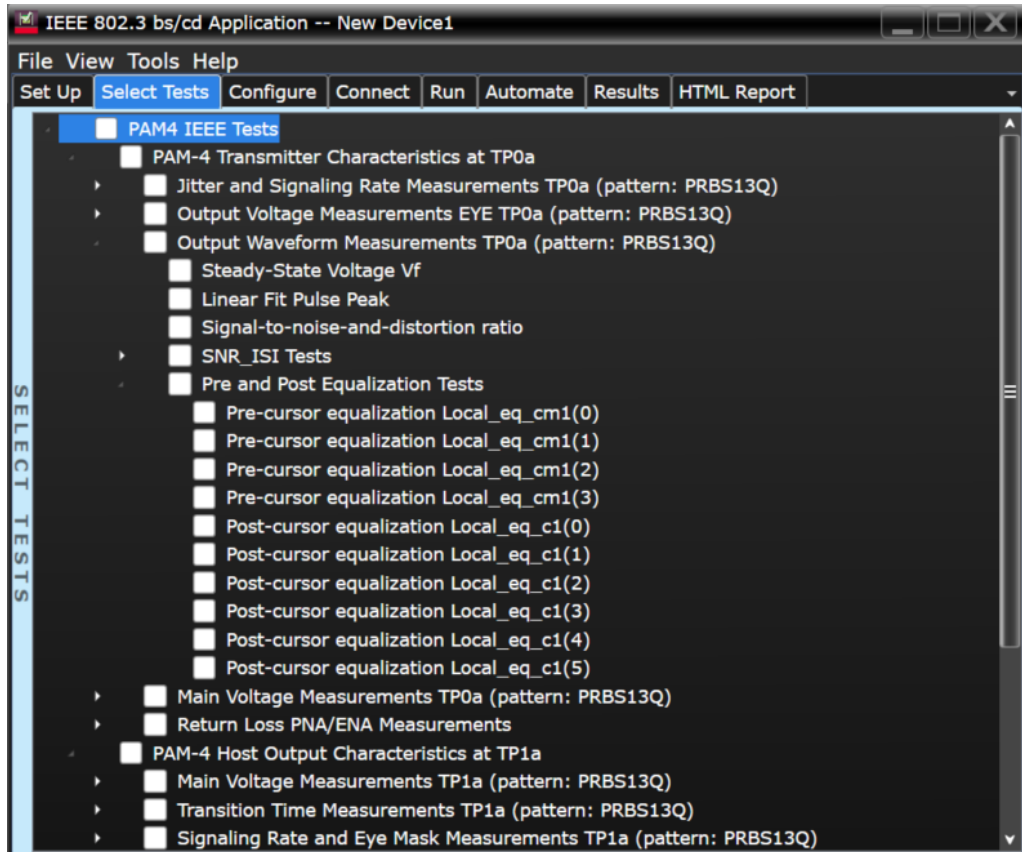


Figure 14 Selecting Pre and Post Equalization Tests

To know about the measurement algorithm for each Pre and Post Equalization Tests, see:

"Pre-cursor equalization Local\_eq\_cm1(0)" on page 63.

"Pre-cursor equalization Local\_eq\_cm1(1)" on page 64

"Pre-cursor equalization Local\_eq\_cm1(2)" on page 65

"Pre-cursor equalization Local\_eq\_cm1(3)" on page 66

"Pre-cursor equalization Local\_eq\_c1(0)" on page 67

"Pre-cursor equalization Local\_eq\_c1(1)" on page 68

"Pre-cursor equalization Local\_eq\_c1(2)" on page 69

"Pre-cursor equalization Local\_eq\_c1(3)" on page 70

"Pre-cursor equalization Local\_eq\_c1(4)" on page 71

"Pre-cursor equalization Local\_eq\_c1(5)" on page 72

### Pre-cursor equalization Local\_eq\_cm1(0)

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $0 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 0, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $0 \pm 0.04$ .
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS13Q pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix  $R_m$  using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 0.
  - 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $0 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_cm1(1)

**Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.05 \pm 0.04$ .

**Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 1, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.05 \pm 0.04$ .

**Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.

- 1 Request Transmitter to be set to "PRESET" condition.
- 2 Set memory depth to capture one full PRBS13Q pattern and scale.
- 3 Calculate linear fit pulse response at "PRESET" condition.
- 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
- 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 1.
- 6 Calculate linear fit pulse response 85.8.3.3.5 with Np = 200, Dp = 2. The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
- 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
- 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
- 9 Compare and report the value of pre-cursor ratio with  $-0.05 \pm 0.04$ .



### Pre-cursor equalization Local\_eq\_cm1(2)

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.1 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 2, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.1 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS13Q pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 2.
  - 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $-0.1 \pm 0.04$ .

**Pre-cursor equalization Local\_eq\_cm1(3)**

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.15 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 3, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.15 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS13Q pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 3.
  - 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $-0.15 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(0)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $0 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 0, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $0 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS13Q pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 0.
  - 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $0 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(1)

**Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.05 \pm 0.04$ .

**Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 1, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.05 \pm 0.04$ .

**Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.

- 1 Request Transmitter to be set to "PRESET" condition.
- 2 Set memory depth to capture one full PRBS13Q pattern and scale.
- 3 Calculate linear fit pulse response at "PRESET" condition.
- 4 Define matrix  $R_m$  using equation (92-4) from IEEE 802.3.
- 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 1.
- 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
- 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
- 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
- 9 Compare and report the value of post-cursor ratio with  $-0.05 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(2)

**Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.1 \pm 0.04$ .

**Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 2, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.1 \pm 0.04$ .

**Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.

- 1 Request Transmitter to be set to "PRESET" condition.
- 2 Set memory depth to capture one full PRBS13Q pattern and scale.
- 3 Calculate linear fit pulse response at "PRESET" condition.
- 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
- 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 2.
- 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
- 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
- 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
- 9 Compare and report the value of post-cursor ratio with  $-0.1 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(3)

**Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.15 \pm 0.04$ .

**Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 3, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.15 \pm 0.04$ .

**Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.

- 1 Request Transmitter to be set to "PRESET" condition.
- 2 Set memory depth to capture one full PRBS13Q pattern and scale.
- 3 Calculate linear fit pulse response at "PRESET" condition.
- 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
- 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 3.
- 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
- 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
- 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
- 9 Compare and report the value of post-cursor ratio with  $-0.15 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(4)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.2 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 4, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.2 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS13Q pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 4.
  - 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.2 \pm 0.04$ .

### Pre-cursor equalization Local\_eq\_c1(5)

**Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.25 \pm 0.04$ .

**Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 5, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.25 \pm 0.04$ .

**Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.

- 1 Request Transmitter to be set to "PRESET" condition.
- 2 Set memory depth to capture one full PRBS13Q pattern and scale.
- 3 Calculate linear fit pulse response at "PRESET" condition.
- 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
- 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 5.
- 6 Calculate linear fit pulse response 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ . The value for ES is defined to be  $(|ES1| + |ES2|)/2$  where ES1 and ES2 are defined in section 120D.3.1.2 of the IEEE P802.3bsTM /D3.5 document.
- 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
- 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
- 9 Compare and report the value of post-cursor ratio with  $-0.25 \pm 0.04$ .



## ERL Test

- Test Overview** The purpose of this test is to verify that the Effective Return Loss (ERL) at TP0a is greater than or equal to 15dB.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 In the **Set Up** tab of the Compliance Test Application, click **ERL File Setup** button to set up the s-parameter file (refer to Annex 93A.5.1 of the IEEE P802.3cd™ specification for more information about the standards defined to create the s-parameters).
  - 2 Click the **Select Tests** tab and check the ERL test to measure the effective return loss.
  - 3 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the effective return loss.
  - 4 Compare the resulting ERL value with the 15 dB.

## Coefficient Initialization - Preset n

**Test Overview** The purpose of this test is to verify that the Coefficients meets the specified standards. These test groups consist of the following tests:

- Coefficient Initialization - Preset 1
  - Coefficient Initialization - Preset 1 for c(-1)
  - Coefficient Initialization - Preset 1 for c(0)
  - Coefficient Initialization - Preset 1 for c(1)
  - Coefficient Initialization - Preset 1 for c(-2)
- Coefficient Initialization - Preset 2
  - Coefficient Initialization - Preset 2 for c(-1)
  - Coefficient Initialization - Preset 2 for c(0)
  - Coefficient Initialization - Preset 2 for c(1)
  - Coefficient Initialization - Preset 2 for c(-2)
- Coefficient Initialization - Preset 3
  - Coefficient Initialization - Preset 3 for c(-1)
  - Coefficient Initialization - Preset 3 for c(0)
  - Coefficient Initialization - Preset 3 for c(1)
  - Coefficient Initialization - Preset 3 for c(-2)

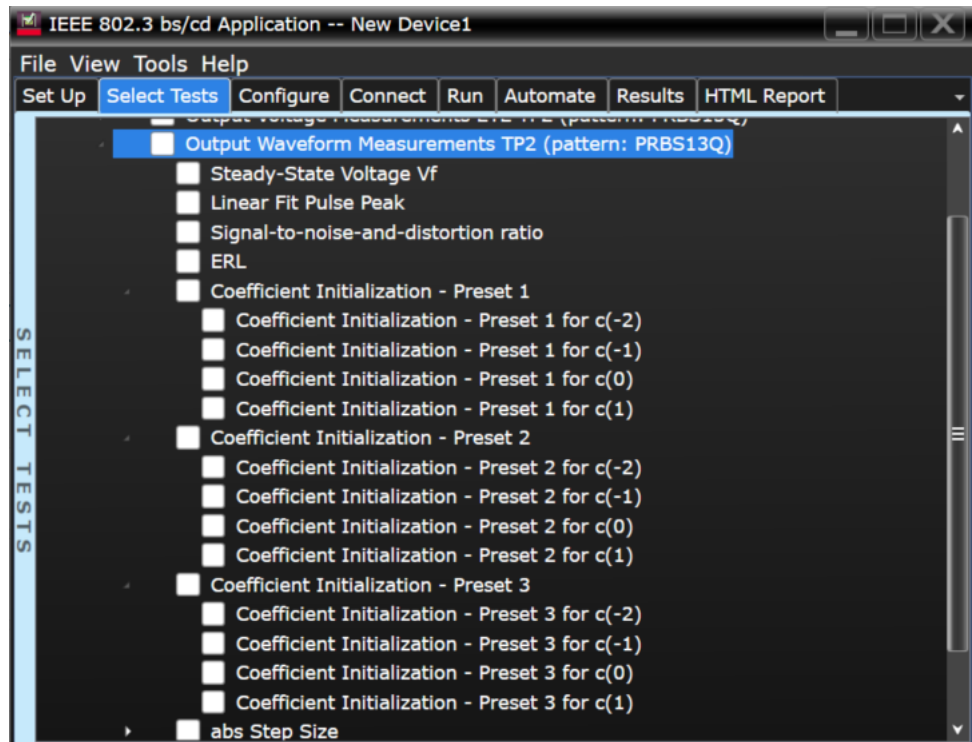


Figure 15 Selecting Coefficient Initialization - Preset n Tests

**Pass Condition**

Preset/Coefficient	c(-1)	c(0)	c(1)	c(-2)
Preset 1	[-0.05, 0.05]	[0.95, 1.050]	[-0.05, 0.05]	[-0.025, 0.025]
Preset 2	[-0.2, -0.1]	[0.7, 0.8]	[-0.15, -0.05]	[-0.025, 0.025]
Preset 3	[-0.3, -0.2]	[0.7, 0.8]	[-0.05, 0.05]	[-0.025, 0.025]

**Measurement Algorithm**

- 1 Request Transmitter to be set to "PRESET n" condition.
- 2 Capture full pattern of PRBS13Q at 32 points per UI.
- 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
- 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
- 5 Request preset # (for each test).
- 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
- 7 Calculate coefficients  $c(i)$  using equation 136-2
- 8 Report  $c(\#)$  value from step 7.

abs Step Size Test

**Test Overview** The purpose of this test is to verify the abs Step Size.

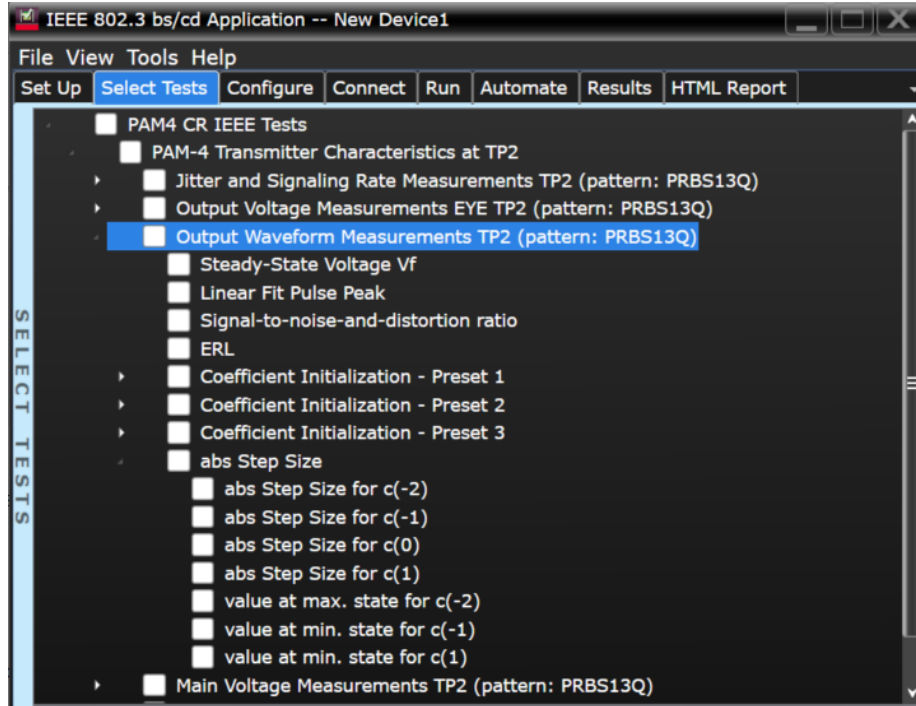


Figure 16 Selecting abs Step Size Tests

To know about the measurement algorithm for each abs Step Size test, see:

“abs Step Size for c(-1)” on page 77

“abs Step Size for c(0)” on page 78

“abs Step Size for c(1)” on page 79

“abs Step Size for c(-2)” on page 80

“value at min. state for c(-1)” on page 81

“value at min. state for c(1)” on page 82

“abs Step Size for c(-2)” on page 83

**abs Step Size for  $c(-1)$** 

- Test Overview** The purpose of this test is to verify that the abs Step Size for  $c(-1)$  is within limits.
- Pass Condition** When abs Coefficient Step Size -  $c(-1)$  is greater than or equal to 5mV and less than or equal to 50 mV.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request to change  $c(-1)$  to the first step.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Save coefficient  $c(-1)$  as base step value.
  - 9 Request next  $c(-1)$  step.
  - 10 Calculate linear fit pulse response as per section 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 11 Calculate coefficients  $c(i)$  using equation 136-2.
  - 12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.
  - 13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.

**abs Step Size for  $c(0)$** 

<b>Test Overview</b>	The purpose of this test is to verify that the abs Step Size for $c(0)$ is within limits.
<b>Pass Condition</b>	When abs Coefficient Step Size - $c(0)$ is greater than or equal to 5 mV and less than or equal to 50 mV.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"> <li>1 Request Transmitter to be set to "PRESET" condition.</li> <li>2 Capture full pattern of PRBS13Q at 32 points per UI.</li> <li>3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.</li> <li>4 Define <math>r(m)</math> from "PRESET" as per equation 136-1.</li> <li>5 Request to change <math>c(0)</math> to the first step.</li> <li>6 Calculate linear fit pulse response as per 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>7 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>8 Save coefficient <math>c(0)</math> as base step value.</li> <li>9 Request next <math>c(0)</math> step.</li> <li>10 Calculate linear fit pulse response as per section 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>11 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.</li> <li>13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.</li> </ol>

**abs Step Size for c(1)**

<b>Test Overview</b>	The purpose of this test is to verify that the abs Step Size for c(1) is within limits.
<b>Pass Condition</b>	When abs Coefficient Step Size - c(1) is greater than or equal to 5mV and less than or equal to 50 mV.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"> <li>1 Request Transmitter to be set to "PRESET" condition.</li> <li>2 Capture full pattern of PRBS13Q at 32 points per UI.</li> <li>3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.</li> <li>4 Define <math>r(m)</math> from "PRESET" as per equation 136-1.</li> <li>5 Request to change c(1) to the first step.</li> <li>6 Calculate linear fit pulse response as per 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>7 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>8 Save coefficient c(1) as base step value.</li> <li>9 Request next c(1) step.</li> <li>10 Calculate linear fit pulse response as per section 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>11 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.</li> <li>13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.</li> </ol>

**abs Step Size for  $c(-2)$** 

- Test Overview** The purpose of this test is to verify that the abs Step Size for  $c(-2)$  is within limits.
- Pass Condition** When abs Coefficient Step Size -  $c(-2)$  is greater than or equal to 5 mV and less than or equal to 50 mV.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request to change  $c(-2)$  to the first step.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Save coefficient  $c(-2)$  as base step value.
  - 9 Request next  $c(-2)$  step.
  - 10 Calculate linear fit pulse response as per section 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 11 Calculate coefficients  $c(i)$  using equation 136-2.
  - 12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.
  - 13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.



value at min. state for  $c(-1)$ 

- Test Overview** The purpose of this test is to verify that the value at min. state for  $c(-1)$  is within limits.
- Pass Condition** When value at min. state for  $c(-1)$  is less than or equal to  $-250$  m.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request user to set  $c(-3)$ ,  $c(-2)$ , and  $c(1)$  to zero. Decrement both  $c(0)$  and  $c(-1)$  to their minimum value.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Report  $c(-1)$  value from step 7.

value at min. state for  $c(1)$ 

<b>Test Overview</b>	The purpose of this test is to verify that the value at min. state for $c(1)$ is within limits.
<b>Pass Condition</b>	When value at min. state for $c(1)$ is less than or equal to $-250$ m.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"> <li>1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.</li> <li>2 Capture full pattern of PRBS13Q at 32 points per UI.</li> <li>3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.</li> <li>4 Define <math>r(m)</math> from "PRESET" as per equation 136-1.</li> <li>5 Request user to set <math>c(-2)</math>, <math>c(-1)</math>, and <math>c(1)</math> to zero. Decrement both <math>c(0)</math> and <math>c(1)</math> to their minimum value.</li> <li>6 Calculate linear fit pulse response as per 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 2</math>.</li> <li>7 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>8 Report <math>c(-3)</math> value from step 7.</li> </ol>

**abs Step Size for c(-2)**

- Test Overview** The purpose of this test is to verify that the value at max. state for c(-2) is within limits.
- Pass Condition** When value at max. state for c(-2) is greater than or equal to 100 m.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request user to set c(-3), c(-1), and c(1) to zero. Increment both c(0) and c(-2) to their maximum value.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Report c(-2) value from step 7.

## Main Voltage Measurements TP0a

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

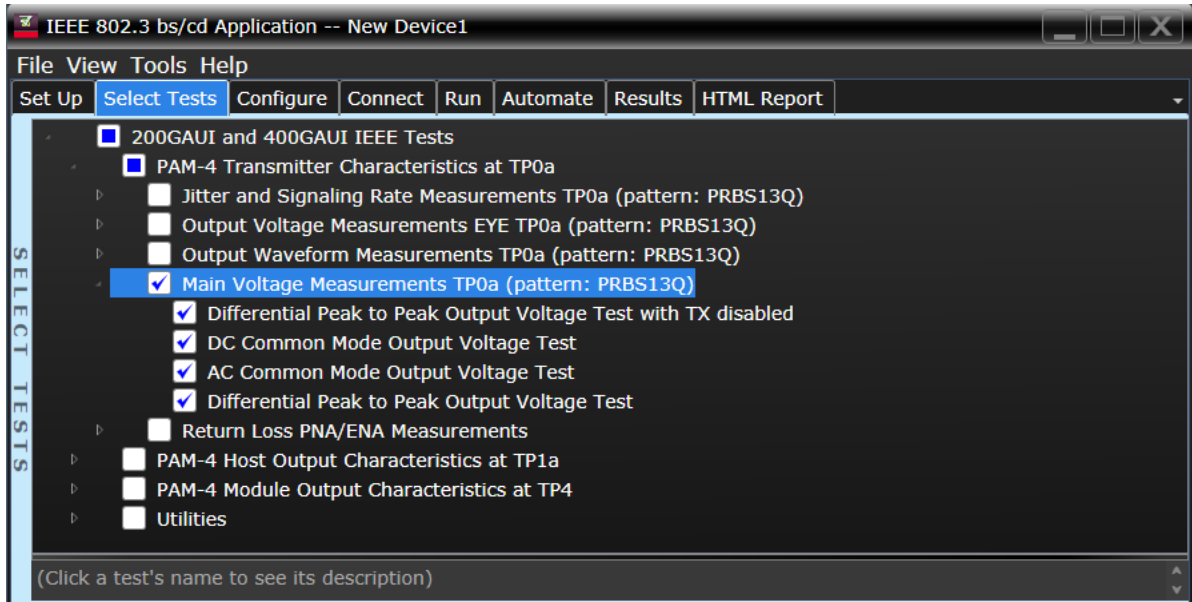


Figure 17 Selecting Main Voltage Measurement Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Main Voltage Measurements TP0a (pattern: PRBS13Q) tests, see:

- [“Differential Peak-to-Peak Output Voltage Test with TX Disabled”](#) on page 85
- [“DC Common Mode Output Voltage Test”](#) on page 86
- [“AC Common Mode Output Voltage Test”](#) on page 87
- [“Differential Peak-to-Peak Output Voltage Test”](#) on page 88

## Differential Peak-to-Peak Output Voltage Test with TX Disabled

- Test Overview** The purpose of this test is to verify that when TX is disabled, the peak-to-peak voltage meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain a sample or acquire the signal data.
  - 2 Ensure that TX is disabled on the acquired signal (no valid data transitions).
  - 3 Measure peak-to-peak voltage of the signal.
  - 4 Compare the maximum peak-to-peak voltage to the specified standards.

### DC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal meets the specified standards.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the DC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the specified standards.

## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal meets the specified standards.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the AC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the specified standards.

#### Differential Peak-to-Peak Output Voltage Test

- Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS13Q pattern meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS13Q pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal on DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage to the specified standards.



## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

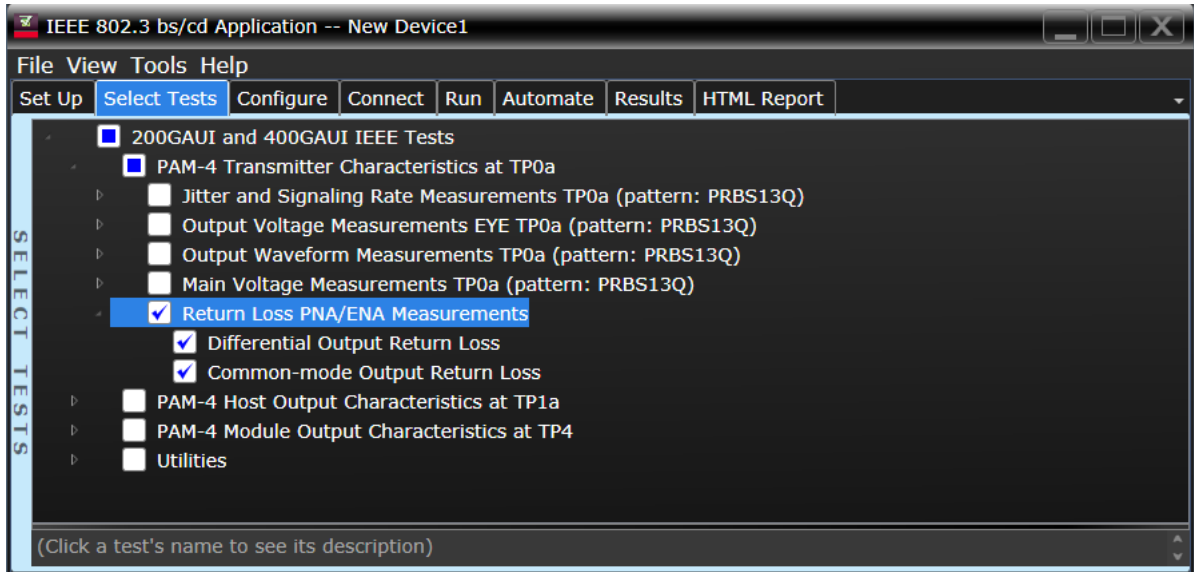


Figure 18 Selecting Return Loss PNA/ENA Measurements Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- [“Differential Output Return Loss”](#) on page 90
- [“Common-mode Output Return Loss”](#) on page 91

#### Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|

## Common-mode Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.



# 5 PAM4 Host Output Characteristics at TP1a

Main Voltage Measurements TP1a	95
Transition Time Measurements TP1a	101
Signaling Rate and Eye Mask Measurements TP1a	104
Return Loss ENA/PNA Measurements	109

This section provides the Methods of Implementation (MOIs) for the PAM4 200GAUI and 400GAUI IEEE PAM4 Host Output Characteristics at TP1a as specified in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120E.3.1, Table 120E-1. Measurements are made at TP1a.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## 200GAUI-4 and 400GAUI-8 C2M host output electrical characteristics

**Table 6** 200GAUI-4 and 400GAUI-8 C2M host output characteristics at TP1a

Parameter	Reference	Value	Units
Signaling rate per lane (range)	See Sec. 120E.3.1.1 of the IEEE specification	26.5625 ± 100 ppm	GBd
DC common-mode output voltage (max)	See Sec. 120E.3.1.2 of the IEEE specification	2.8	V
DC common-mode output voltage (min)	See Sec. 120E.3.1.2 of the IEEE specification	-0.3	V
Single-ended output voltage (max)	See Sec. 120E.3.1.2 of the IEEE specification	3.3	V
Single-ended output voltage (min)	See Sec. 120E.3.1.2 of the IEEE specification	-0.4	V
AC common-mode output voltage (max, RMS)	See Sec. 120E.3.1.2 of the IEEE specification	17.5	mV
Differential peak-to-peak output voltage (max) Transmitter disabled Transmitter enabled	See Sec. 120E.3.1.2 of the IEEE specification	35 880	mV
ESMW (Eye symmetry mask width)	See Sec. 120E.4.2 of the IEEE specification	0.22	UI
Eye height, differential (min)	See Sec. 120E.4.2 of the IEEE specification	32	mV
Differential output return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-2) of the IEEE specification	dB
Common to differential mode conversion return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-3) of the IEEE specification	dB
Transition time (min, 20% to 80%)	See Sec. 120E.3.1.5 of the IEEE specification	10	ps

## Main Voltage Measurements TP1a

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

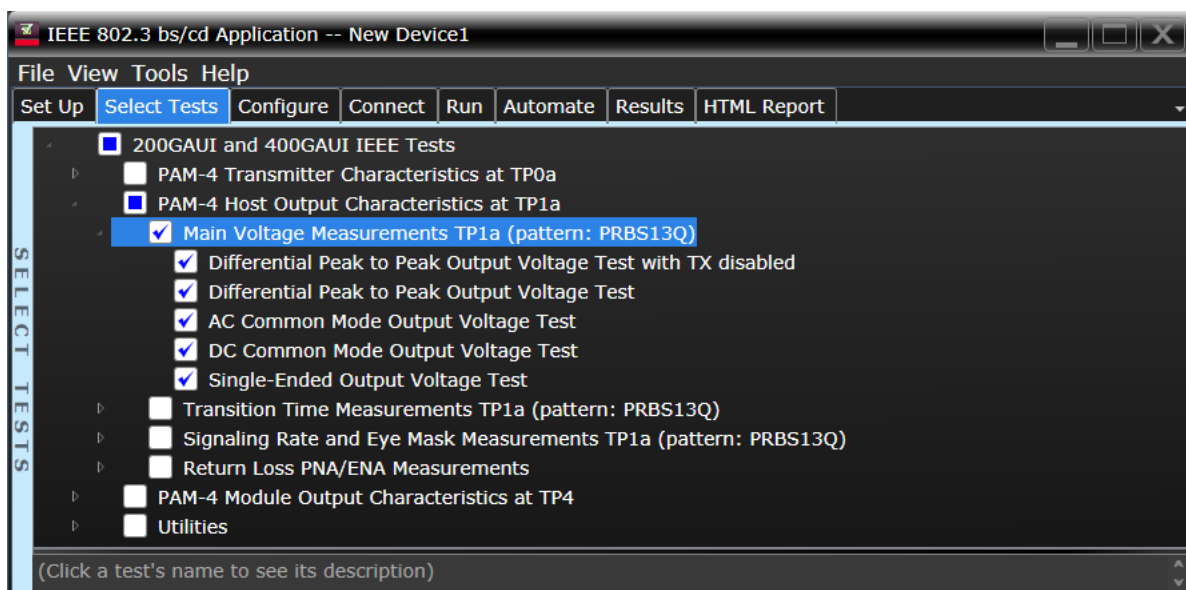


Figure 15 Selecting Main Voltage Measurement Tests

Refer to [Table 6](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Main Voltage Measurements TP1a (pattern: PRBS13Q) tests, see:

- “Differential Peak-to-Peak Output Voltage Test with TX Disabled” on page 96
- “Differential Peak-to-Peak Output Voltage Test” on page 97
- “AC Common Mode Output Voltage Test” on page 98
- “DC Common Mode Output Voltage Test” on page 99

#### Differential Peak-to-Peak Output Voltage Test with TX Disabled

**Test Overview** The purpose of this test is to verify that when TX is disabled, the peak-to-peak voltage must be less than 35mV.

**Pass Condition** Refer to [Table 6](#).

- Measurement Algorithm**
- 1 Obtain a sample or acquire the signal data.
  - 2 Ensure that TX is disabled on the acquired signal (no valid data transitions).
  - 3 Measure peak-to-peak voltage of the signal.
  - 4 Compare the maximum peak-to-peak voltage to 35mV.



## Differential Peak-to-Peak Output Voltage Test

- Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS13Q pattern is less than 880mV.
- Pass Condition** Refer to [Table 6](#).
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS13Q pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal on DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage with 880mV.

### AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal does not exceed 17.5mV.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 6](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the AC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement with 17.5mV.

## DC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal is between -300mV and 2.8V.

**NOTE**

This measurement can be done only with dual-single ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 6](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Measure the DC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 3 Compare the voltage measurement to the range between -300mV and 2.8V.

### Single-Ended Output Voltage Test

**Test Overview** The purpose of this test is to verify that the minimum voltage on a single-ended signal is greater than -400mV and that the maximum voltage is less than 3.3V.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 6](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the minimum and maximum voltage on each single-ended signal.
- 4 Compare the voltage measurements with the range between -400mV and 3.3V.

## Transition Time Measurements TP1a

The Transition Time Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

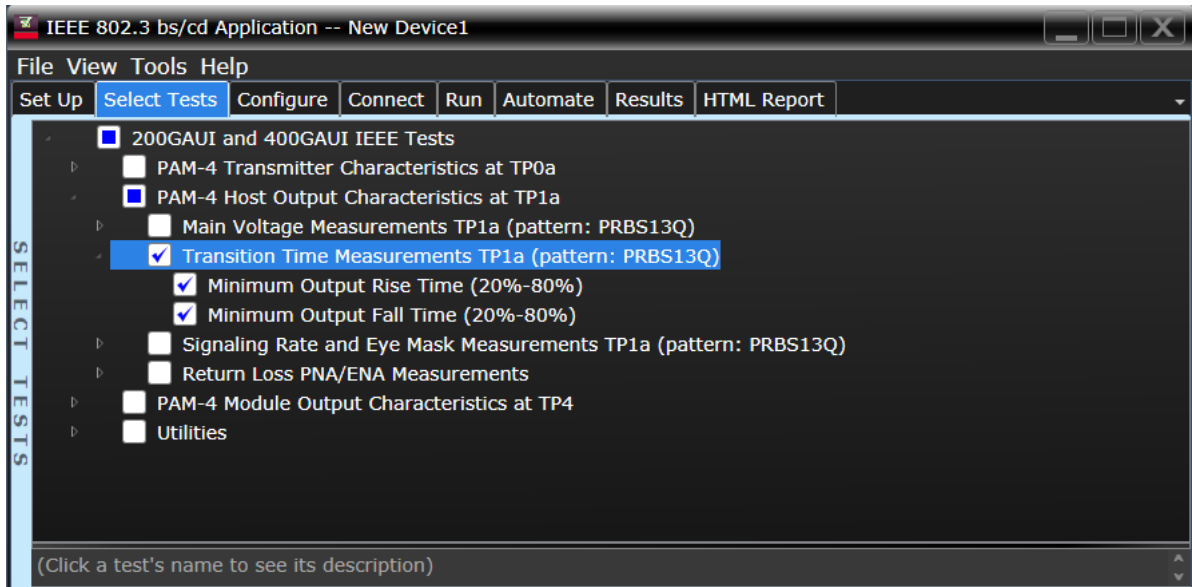


Figure 16 Selecting Transition Time Measurement Tests

Refer to [Table 6](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Transition Time Measurements TP1a (pattern: PRBS13Q) tests, see:

- “Minimum Output Rise Time (20%-80%)” on page 102
- “Minimum Output Fall Time (20%-80%)” on page 103

Minimum Output Rise Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise fall time is 10ps.

**Pass Condition** Refer to [Table 6](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS13Q.
  - 3 Find pattern 000333 for the rising edge.
  - 4 Measure rise time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 10ps.

## Minimum Output Fall Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise and fall times are 10ps.

**Pass Condition** Refer to [Table 6](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS13Q.
  - 3 Find pattern 333000 for the falling edge.
  - 4 Measure fall time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 10ps.

## Signaling Rate and Eye Mask Measurements TP1a

The Signaling Rate and Eye Mask Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

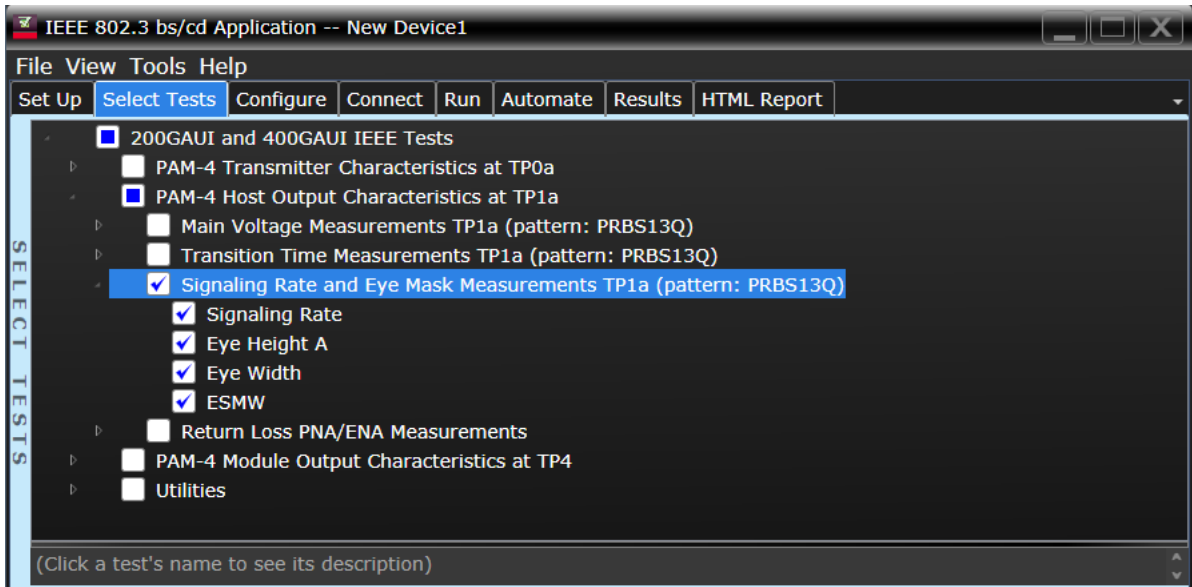


Figure 17 Selecting Signaling Rate and Eye Mask Measurement Tests

Refer to [Table 6](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Signaling Rate and Eye Mask Measurements TP1a (pattern: PRBS13Q) tests, see:

- “[Signaling Rate](#)” on page 105
- “[Eye Height](#)” on page 106
- “[Eye Width](#)” on page 107
- “[ESMW](#)” on page 108



## Signaling Rate

- Test Overview** The purpose of this test is to verify that the signaling rate mean is between  $26.5625 \pm 100\text{ppm}$  GBd.
- Pass Condition** Refer to [Table 6](#).
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS13Q must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum, maximum and mean data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with  $26.5625 \pm 100\text{ppm}$  GBd.
  - 7 Report the resulting value.

## Eye Height

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Eye Height A is greater than 32mV. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 6](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'. See IEEE 802.3bs D3.0, Section 120E, Table 120E-2 (Reference CTLE Coefficients).
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Eye Height A at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Eye Height A with 32mV. Report the resulting value.

## Eye Width

**Test Overview** The purpose of this test is to measure the Eye Width for a defined range of CTLE settings. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Not applicable as the test result is considered as “Information Only”.

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as ‘User-defined optimal CTLE’. See IEEE 802.3bs D3.0, Section 120E, Table 120E-2 (Reference CTLE Coefficients).
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Eye Width at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Report the resulting value of Eye Width.

**NOTE**

The Eye Width measurement is considered as an “Information-Only” test and cannot be used for compliance validation.

---

## ESMW

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the ESMW is greater than 220mUI (that is, 110mUI each for the left and right eye). The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 6](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'. See IEEE 802.3bs D3.0, Section 120E, Table 120E-2 (Reference CTLE Coefficients).
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the ESMW at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Calculate ESMW for each given eye (left and right) using the equations:
 
$$\text{Left} = (\text{Eye Width} / 2) - \text{Eye Skew}$$

$$\text{Right} = (\text{Eye Width} / 2) + \text{Eye Skew}$$
  - 6 Compare the ESMW with 220mUI (that is, 110mUI each for the left and right eye). Report the resulting value.

## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

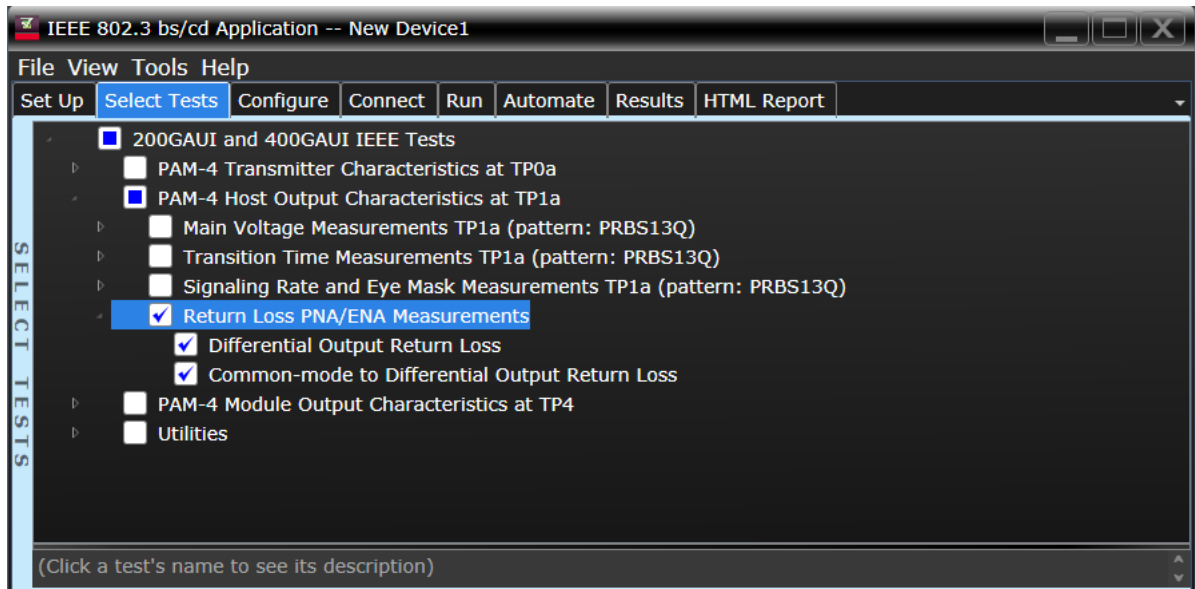


Figure 18 Selecting Return Loss Measurement Tests

Refer to [Table 6](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- [“Differential Output Return Loss”](#) on page 110
- [“Common-mode to Differential Output Return Loss”](#) on page 111

#### Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|

## Common-mode to Differential Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.





# 6 PAM4 Transmitter Characteristics at TP2

Jitter and Signaling Rate Measurements TP2 116

Output Voltage Measurements EYE TP2 121

Output Waveform Measurements TP2 125

Main Voltage Measurements TP2 140

Return Loss ENA/PNA Measurements 145

This section provides the Methods of Implementation (MOIs) for the IEEE PAM4 Transmitter Characteristics at TP2. Measurements are made at test point TP2.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## C2C transmitter characteristics

For CR tests

See [Table 7](#) for pass limits pertaining to 50GBASE-CR, 100GBASE-CR2, and 200GBASE-CR PAM4 tests, which are specified in IEEE P802.3cd™ /D3.0 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 50Gb/s, 100Gb/s, and 200Gb/s Operation) section 136.9.3, Table 136-11.

**Table 7 50GBASE-CR, 100GBASE-CR2, and 200GBASE-CR C2C transmitter characteristics at TP2**

Parameter	Reference	Value	Units
Differential pk-to-pk output voltage (max) with TX disabled <sup>a</sup>	See Sec. 93.8.1.3 of the IEEE specification	30	mV
DC common-mode voltage (max) <sup>a</sup>	See Sec. 93.8.1.3 of the IEEE specification	1.9	V
AC common-mode RMS output voltage, $v_{cmi}$ (max) <sup>a</sup>	See Sec. 93.8.1.3 of the IEEE specification	30	mV
Differential pk-to-pk, $v_{di}$ (max) <sup>a</sup>	See Sec. 93.8.1.3 of the IEEE specification	1200	mV
Effective return loss (ERL) (min.)	See Sec. 136.9.3.4 of the IEEE specification	See Equation (136-6) of the IEEE specification	dB
Common-mode to differential mode output return loss (min)	See Sec. 92.8.3.3 of the IEEE specification	See Equation (92-2) of the IEEE specification	dB
Common-mode to common-mode output return loss (min)	See Sec. 92.8.3.4 of the IEEE specification	See Equation (92-3) of the IEEE specification	dB
Transmitter steady-state voltage, $v_f$ (min)	See Sec. 136.9.3.1.2 of the IEEE specification	0.354	V
Transmitter steady-state voltage, $v_f$ (max)	See Sec. 136.9.3.1.2 of the IEEE specification	0.6	V
Linear fit pulse peak (min)	See Sec. 136.9.3.1.2 of the IEEE specification	$0.49 \times v_f$	V
Level separation mismatch ratio $R_{LM}$ (min)	See Sec.120D.3.1.2 of the IEEE specification	0.95	-
Transmitter output waveform	See Sections		
abs step size for c(-1), c(0), and c(1) (min.)	136.9.3.1.4	0.005	-
abs step size for c(-1), c(0), and c(1) (max.)	136.9.3.1.4	0.05	-
abs step size for c(-2) (min.)	136.9.3.1.4	0.005	-
abs step size for c(-2) (max.)	136.9.3.1.4	0.025	-
value at maximum state for c(-1) and c(1) (max.)	136.9.3.1.5	-0.25	-
value at maximum state for c(-2) (min.)	136.9.3.1.5	0.1	-
Signal-to-noise-and-distortion ratio SNDR (min)	See Sec.120D.3.1.6 of the IEEE specification	32.2	dB
$SNR_{ISI}$ (min) <sup>b</sup>	See Sec. 120D.3.1.7 of the IEEE specification	36.8	dB
Output jitter (max.)	See Sections		
JRMS	120D.3.1.8	0.023	UI
J3u	136.9.3.3	0.115	UI
Even-odd jitter, pk-pk	120D.3.1.8	0.019	UI
Signaling rate per lane (range)		$26.5625 \pm 100$ ppm	GBd

- a. Measurement uses the method described in section 93.8.1.3 of IEEE specification with the exception that the PRBS13Q test pattern is used.
- b. Measured only in unequalized setting.

## Jitter and Signaling Rate Measurements TP2

The Jitter and Signaling Rate Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

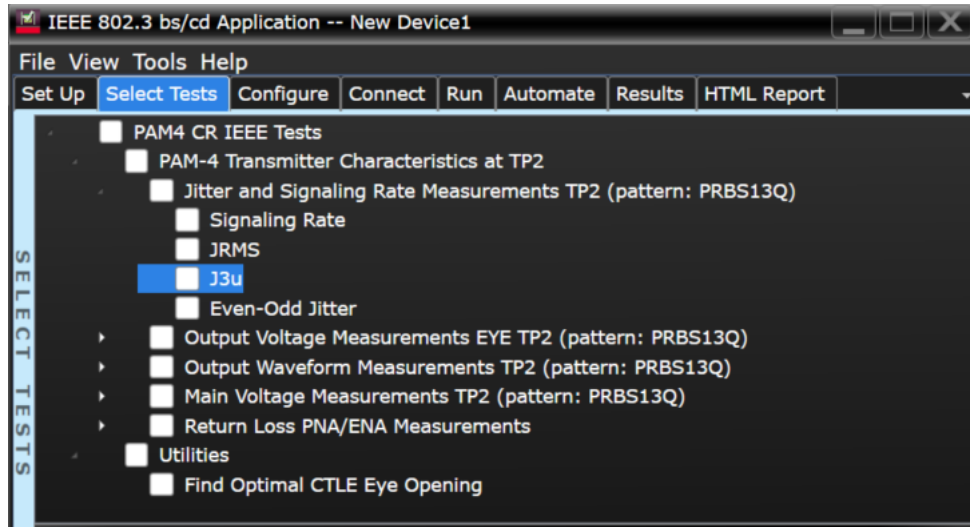


Figure 19 Selecting Jitter and Signaling Rate Measurement Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Jitter and Signaling Rate Measurements TP2 (pattern: PRBS13Q) tests, see:

- [“Signaling Rate”](#) on page 117
- [“JRMS”](#) on page 118
- [“J3u”](#) on page 119
- [“Even-Odd Jitter”](#) on page 120

## Signaling Rate

- Test Overview** The purpose of this test is to verify that the signaling rate meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS13Q must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum and maximum data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with the specified standards. Report the resulting value.

## JRMS

<b>Test Overview</b>	The purpose of this test is to verify that differential signal's JRMS meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
<b>Pass Conditions</b>	Refer to the section <a href="#">C2C transmitter characteristics</a> for the pass limits pertaining to each standard option.
<b>Measurement Algorithm</b>	1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the JRMS value to the specified standards.

J3u

<b>Test Overview</b>	The purpose of this test is to verify that differential signal's J3u meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
<b>Pass Conditions</b>	Refer to the section <a href="#">C2C transmitter characteristics</a> for the pass limits pertaining to each standard option.
<b>Measurement Algorithm</b>	1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the J3u value meets the specified standards.

## Even-Odd Jitter

- Test Overview** The purpose of this test is to verify that differential signal's Even-Odd Jitter meets the specified standards. All jitter tests are run in a single measurement. However, each test can be run individually.
- Pass Conditions** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS13Q pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.  
Irrespective of the Oscilloscope used, the signal must be of PRBS13Q pattern.

- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
- 3 On the Oscilloscope,
  - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Using PAM4 jitter measurements, at least 10,000 PRBS13Q patterns are captured to collect the measurement data of 12 edges.
  - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 4 Compare and report the Even-Odd Jitter value to the specified standards.



## Output Voltage Measurements EYE TP2

The Output Voltage Measurement EYE procedures for a signal with PRBS13Q pattern that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

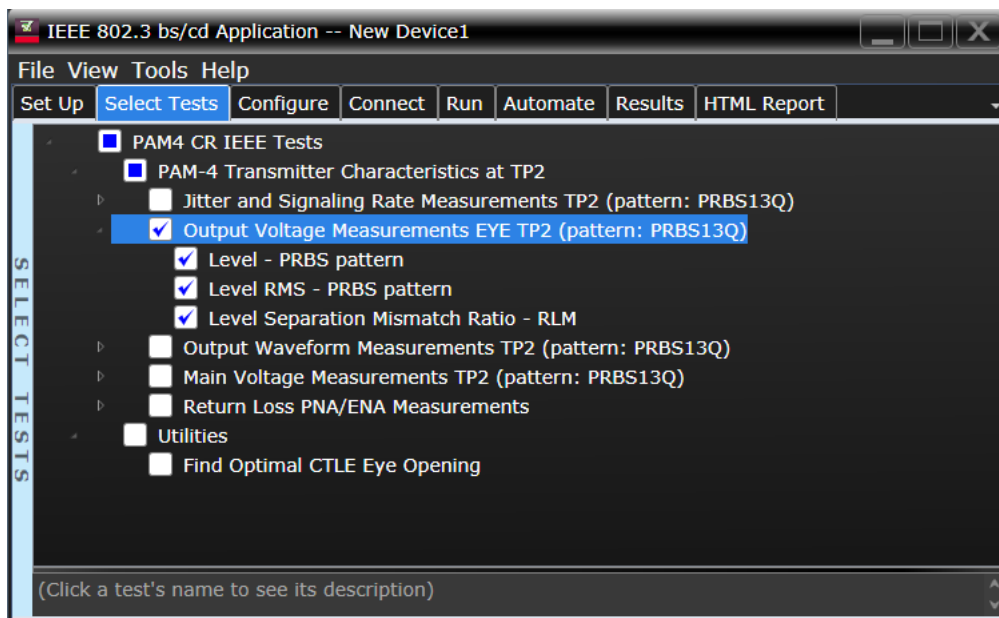


Figure 20 Selecting Output Voltage Measurements EYE Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Output Voltage Measurements EYE TP2 (pattern: PRBS13Q) tests, see:

- [“Level - PRBS Pattern”](#) on page 122
- [“Level RMS - PRBS Pattern”](#) on page 123
- [“Level Separation Mismatch Ratio - RLM”](#) on page 124

### NOTE

The tests Level - PRBS pattern and Level RMS - PRBS pattern are considered as “Information-Only” tests and cannot be used for compliance validation.

## Level - PRBS Pattern

- Test Overview** The purpose of this test is to obtain the mean voltage of each level of the signal with PRBS13Q pattern.
- Pass Condition** Not applicable as the test result is considered as “Information Only”.
- Measurement Algorithm**
- 1 Check that signal is connected and proper data pattern exists (PRBS13Q pattern must be used for this test).
  - 2  $V_0$ ,  $V_1$ ,  $V_2$  and  $V_3$  are the mean signal levels of the symbols corresponding to the PAM4 symbol levels 0, 1, 2 and 3 respectively, as defined in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2. The calculation of mean signal levels is also defined in section 120D.3.1.2.1.
  - 3 The mean level  $V_{mid}$  is defined by equation (120D-3), which is,
 
$$V_{mid} = (V_0 + V_3) / 2$$
  - 4 Report this value for information-only purpose.

## Level RMS - PRBS Pattern

- Test Overview** The purpose of this test is to obtain the of the RMS level of the signal with PRBS13Q pattern.
- Pass Condition** Not applicable as the test result is considered as “Information Only”.
- Measurement Algorithm**
- 1 Run the Level - PRBS Pattern test as a prerequisite to this test.
  - 2 The minimum signal level RMS is calculated, as defined in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2.
  - 3 Report this value for information-only purpose.

## Level Separation Mismatch Ratio - RLM

**Test Overview** The purpose of this test is to obtain the of the Separation Mismatch Ratio level (RLM) of the signal with PRBS13Q pattern.

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Run the Level - PRBS Pattern as a prerequisite to this test to calculate the mid-range level.
- 2 The mean signal levels are normalized so that  $V_0$  corresponds to -1,  $V_1$  to -ES1,  $V_2$  to ES2 and  $V_3$  to 1.
- 3 ES1 and ES2 are calculated using equations (120D-4) and (120D-5), respectively of the IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120D.3.1.2.

$$ES1 = (V_1 - V_{mid}) / (V_0 - V_{mid})$$

$$ES2 = (V_2 - V_{mid}) / (V_3 - V_{mid})$$

4 The level separation mismatch ratio  $R_{LM}$  is defined by equation (120D-5).

$$R_{LM} = \min [(3 \times ES1), (3 \times ES2), (2 - 3 \times ES1), (2 - 3 \times ES2)]$$

5 Report this value for information-only purpose.

## Output Waveform Measurements TP2

The Output Waveform Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

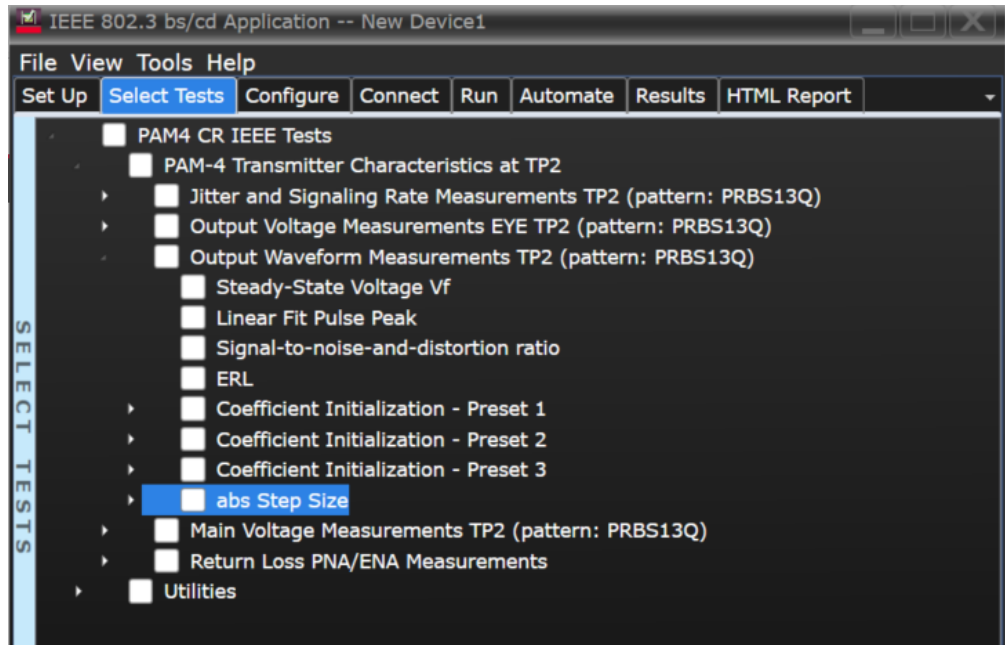


Figure 21 Selecting Transmitter Output Waveform Measurement Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Output Waveform Measurements TP2 (pattern: PRBS13Q) tests, see:

- [“Steady State Voltage Vf”](#) on page 126
- [“Linear Fit Pulse Peak”](#) on page 127
- [“Signal-to-noise-and-distortion ratio”](#) on page 128
- [“ERL Test”](#) on page 129
- [“Coefficient Initialization - Preset n”](#) on page 130
- [“abs Step Size Test”](#) on page 132

Steady State Voltage  $V_f$ 

- Test Overview** The purpose of this test is to verify that the Steady State Voltage is between 0.4V and 0.6V.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Check that signal is connected and proper data pattern exists (PRBS13Q must be used for this test).
  - 2 Set memory depth and sample rate to capture the 8191 bits of the PRBS13Q pattern.
  - 3 Calculate  $V_f$  using the equations in section 85.8.3.3.5. The resulting value is the sum of columns of  $p(k)/M$ .  $N_p = 200$ ,  $D_p = 2$ .
  - 4 Compare and report the resulting value in the range between 0.4V and 0.6V.

## Linear Fit Pulse Peak

**Test Overview** The purpose of this test is to verify that the Linear Fit Pulse meets the specified standards.

**NOTE**

Run the Steady-State Voltage Vf test as a prerequisite to running the Linear Fit Pulse Peak test.

---

**Pass Conditions** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Check that signal is connected and proper data pattern exists (PRBS13Q must be used for this test).
- 2 Set memory depth and sample rate to capture the 8191 bits of the PRBS13Q pattern.
- 3 Calculate Linear Fit Pulse using the equations in section 85.8.3.3.5. The resulting value is the peak value of  $p(k)$ .  $N_p = 200$ ,  $D_p = 2$ .
- 4 Compare the specified standards to the resulting value.

Signal-to-noise-and-distortion ratio

- Test Overview** The purpose of this test is to verify that the Signal-to-noise-and-distortion ratio (SNDR) meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Calculate SNDR using measurements from Level RMS - PRBS pattern test and error from Linear Fit Pulse Peak test.
  - 2 Compare the resulting value of SNDR to the specified standards.



## ERL Test

- Test Overview** The purpose of this test is to verify that the Effective Return Loss (ERL) meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- 1 In the **Set Up** tab of the Compliance Test Application, click **ERL File Setup** button to set up the s-parameter file (refer to Annex 93A.5.1 of the IEEE P802.3cd™ specification for more information about the standards defined to create the s-parameters).
  - 2 Click the **Select Tests** tab and check the ERL test to measure the effective return loss.
  - 3 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the effective return loss.
  - 4 Calculate ERL using equation (136-6).

## Coefficient Initialization - Preset n

**Test Overview** The purpose of this test is to verify that the Coefficients meets the specified standards. These test groups consist of the following tests:

- Coefficient Initialization - Preset 1
  - Coefficient Initialization - Preset 1 for c(-1)
  - Coefficient Initialization - Preset 1 for c(0)
  - Coefficient Initialization - Preset 1 for c(1)
  - Coefficient Initialization - Preset 1 for c(-2)
- Coefficient Initialization - Preset 2
  - Coefficient Initialization - Preset 2 for c(-1)
  - Coefficient Initialization - Preset 2 for c(0)
  - Coefficient Initialization - Preset 2 for c(1)
  - Coefficient Initialization - Preset 2 for c(-2)
- Coefficient Initialization - Preset 3
  - Coefficient Initialization - Preset 3 for c(-1)
  - Coefficient Initialization - Preset 3 for c(0)
  - Coefficient Initialization - Preset 3 for c(1)
  - Coefficient Initialization - Preset 3 for c(-2)

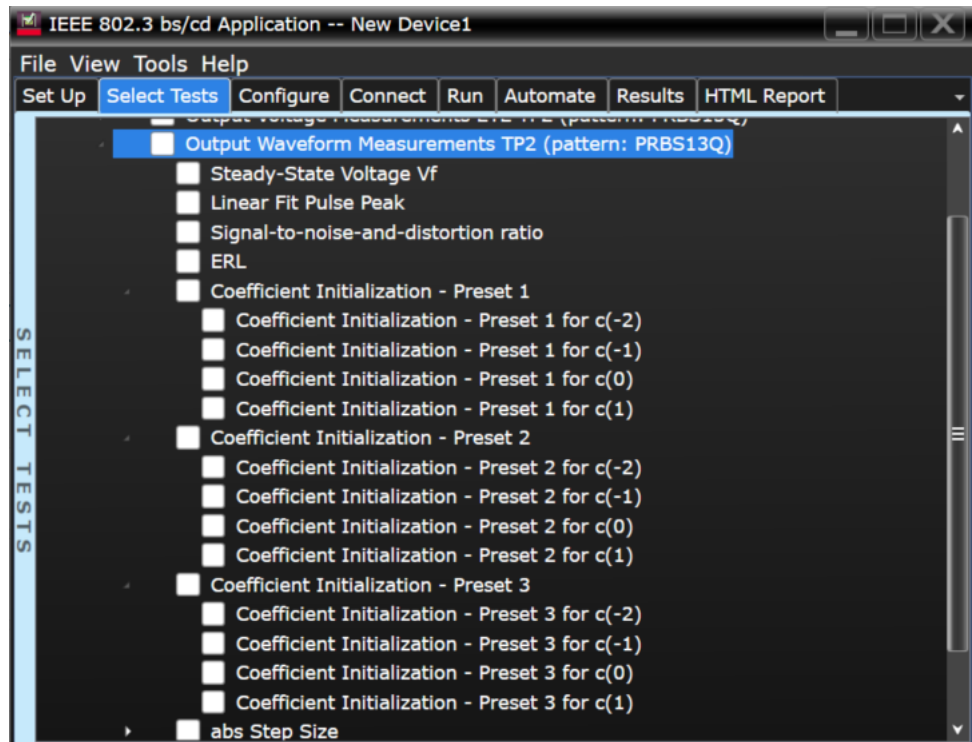


Figure 22 Selecting Coefficient Initialization - Preset n Tests

**Pass Condition**

Preset/Coefficient	c(-1)	c(0)	c(1)	c(-2)
Preset 1	[-0.05, 0.05]	[0.95, 1.050]	[-0.05, 0.05]	[-0.025, 0.025]
Preset 2	[-0.2, -0.1]	[0.7, 0.8]	[-0.15, -0.05]	[-0.025, 0.025]
Preset 3	[-0.3, -0.2]	[0.7, 0.8]	[-0.05, 0.05]	[-0.025, 0.025]

**Measurement Algorithm**

- 1 Request Transmitter to be set to "PRESET n" condition.
- 2 Capture full pattern of PRBS13Q at 32 points per UI.
- 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
- 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
- 5 Request preset # (for each test).
- 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
- 7 Calculate coefficients  $c(i)$  using equation 136-2
- 8 Report  $c(\#)$  value from step 7.

abs Step Size Test

**Test Overview** The purpose of this test is to verify the abs Step Size.

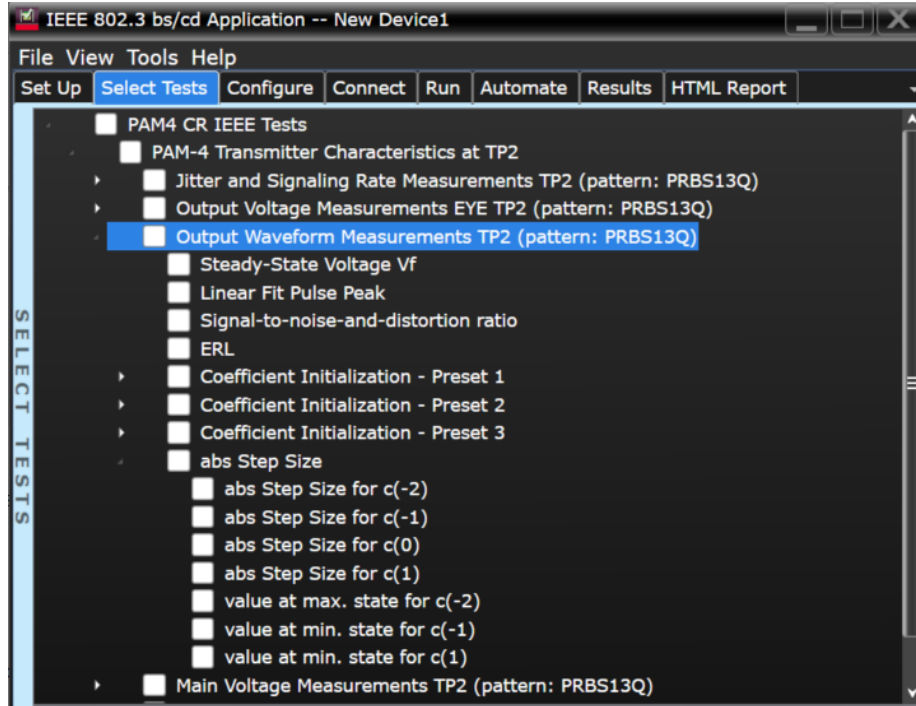


Figure 23 Selecting abs Step Size Tests

To know about the measurement algorithm for each abs Step Size test, see:

“abs Step Size for c(-1)” on page 133

“abs Step Size for c(0)” on page 134

“abs Step Size for c(1)” on page 135

“abs Step Size for c(-2)” on page 136

“value at min. state for c(-1)” on page 137

“value at min. state for c(1)” on page 138

“value at min. state for c(-2)” on page 139

**abs Step Size for  $c(-1)$** 

- Test Overview** The purpose of this test is to verify that the abs Step Size for  $c(-1)$  is within limits.
- Pass Condition** When abs Coefficient Step Size -  $c(-1)$  is greater than or equal to 5mV and less than or equal to 50 mV.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request to change  $c(-1)$  to the first step.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Save coefficient  $c(-1)$  as base step value.
  - 9 Request next  $c(-1)$  step.
  - 10 Calculate linear fit pulse response as per section 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 11 Calculate coefficients  $c(i)$  using equation 136-2.
  - 12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.
  - 13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.

**abs Step Size for  $c(0)$** 

<b>Test Overview</b>	The purpose of this test is to verify that the abs Step Size for $c(0)$ is within limits.
<b>Pass Condition</b>	When abs Coefficient Step Size - $c(0)$ is greater than or equal to 5 mV and less than or equal to 50 mV.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"> <li>1 Request Transmitter to be set to "PRESET" condition.</li> <li>2 Capture full pattern of PRBS13Q at 32 points per UI.</li> <li>3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.</li> <li>4 Define <math>r(m)</math> from "PRESET" as per equation 136-1.</li> <li>5 Request to change <math>c(0)</math> to the first step.</li> <li>6 Calculate linear fit pulse response as per 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>7 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>8 Save coefficient <math>c(0)</math> as base step value.</li> <li>9 Request next <math>c(0)</math> step.</li> <li>10 Calculate linear fit pulse response as per section 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>11 Calculate coefficients <math>c(i)</math> using equation 136-2.</li> <li>12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.</li> <li>13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.</li> </ol>

**abs Step Size for c(1)**

<b>Test Overview</b>	The purpose of this test is to verify that the abs Step Size for c(1) is within limits.
<b>Pass Condition</b>	When abs Coefficient Step Size - c(1) is greater than or equal to 5mV and less than or equal to 50 mV.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"> <li>1 Request Transmitter to be set to "PRESET" condition.</li> <li>2 Capture full pattern of PRBS13Q at 32 points per UI.</li> <li>3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.</li> <li>4 Define <math>r(m)</math> from "PRESET" as per equation 136-1.</li> <li>5 Request to change c(1) to the first step.</li> <li>6 Calculate linear fit pulse response as per 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>7 Calculate coefficients c(i) using equation 136-2.</li> <li>8 Save coefficient c(1) as base step value.</li> <li>9 Request next c(1) step.</li> <li>10 Calculate linear fit pulse response as per section 85.8.3.3.5 with <math>N_p = 200</math>, <math>D_p = 3</math>.</li> <li>11 Calculate coefficients c(i) using equation 136-2.</li> <li>12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.</li> <li>13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.</li> </ol>

**abs Step Size for c(-2)**

- Test Overview** The purpose of this test is to verify that the abs Step Size for c(-2) is within limits.
- Pass Condition** When abs Coefficient Step Size - c(-2) is greater than or equal to 5 mV and less than or equal to 50 mV.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request to change c(-2) to the first step.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Save coefficient c(-2) as base step value.
  - 9 Request next c(-2) step.
  - 10 Calculate linear fit pulse response as per section 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 3$ .
  - 11 Calculate coefficients  $c(i)$  using equation 136-2.
  - 12 Calculate the step size as coefficient value from step 11 – coefficient value from step 7.
  - 13 Repeat steps 9-12 for as many steps as user requests. Each of these step sizes is calculated as coefficient value from step 11 – previous coefficient value from step 11.



value at min. state for  $c(-1)$ 

- Test Overview** The purpose of this test is to verify that the value at min. state for  $c(-1)$  is within limits.
- Pass Condition** When value at min. state for  $c(-1)$  is less than or equal to  $-250$  m.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request user to set  $c(-3)$ ,  $c(-2)$ , and  $c(1)$  to zero. Decrement both  $c(0)$  and  $c(-1)$  to their minimum value.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Report  $c(-1)$  value from step 7.

**value at min. state for  $c(1)$** 

- Test Overview** The purpose of this test is to verify that the value at min. state for  $c(1)$  is within limits.
- Pass Condition** When value at min. state for  $c(1)$  is less than or equal to  $-250$  m.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request user to set  $c(-2)$ ,  $c(-1)$ , and  $c(1)$  to zero. Decrement both  $c(0)$  and  $c(1)$  to their minimum value.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Report  $c(-3)$  value from step 7.

value at min. state for  $c(-2)$ 

- Test Overview** The purpose of this test is to verify that the value at max. state for  $c(-2)$  is within limits.
- Pass Condition** When value at max. state for  $c(-2)$  is greater than or equal to 100 m.
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition. If preset has already been calculated during trial, steps 1-4 are skipped.
  - 2 Capture full pattern of PRBS13Q at 32 points per UI.
  - 3 Calculate linear fit pulse response at "PRESET" condition as per section 85.8.3.3.5.
  - 4 Define  $r(m)$  from "PRESET" as per equation 136-1.
  - 5 Request user to set  $c(-3)$ ,  $c(-1)$ , and  $c(1)$  to zero. Increment both  $c(0)$  and  $c(-2)$  to their maximum value.
  - 6 Calculate linear fit pulse response as per 85.8.3.3.5 with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients  $c(i)$  using equation 136-2.
  - 8 Report  $c(-2)$  value from step 7.

## Main Voltage Measurements TP2

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

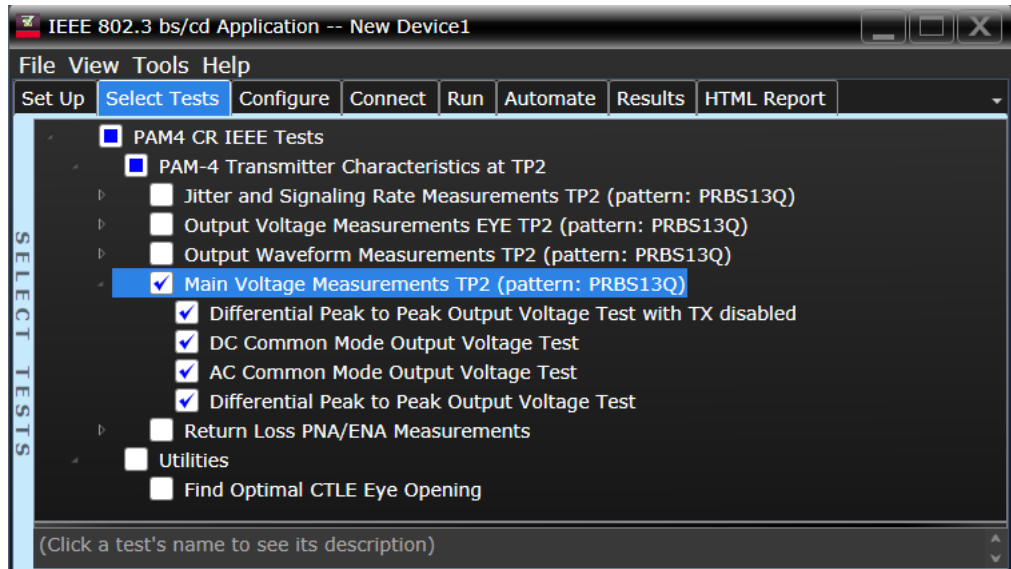


Figure 24 Selecting Main Voltage Measurement Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Main Voltage Measurements TP2 (pattern: PRBS13Q) tests, see:

- “Differential Peak-to-Peak Output Voltage Test with TX Disabled” on page 141
- “DC Common Mode Output Voltage Test” on page 142
- “AC Common Mode Output Voltage Test” on page 143
- “Differential Peak-to-Peak Output Voltage Test” on page 144

## Differential Peak-to-Peak Output Voltage Test with TX Disabled

- Test Overview** The purpose of this test is to verify that when TX is disabled, the peak-to-peak voltage meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain a sample or acquire the signal data.
  - 2 Ensure that TX is disabled on the acquired signal (no valid data transitions).
  - 3 Measure peak-to-peak voltage of the signal.
  - 4 Compare the maximum peak-to-peak voltage to the specified standards.

## DC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal meets the specified standards.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the DC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the specified standards.

## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal meets the specified standards.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the AC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the specified standards.

### Differential Peak-to-Peak Output Voltage Test

- Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS13Q pattern meets the specified standards.
- Pass Condition** Refer to the section [C2C transmitter characteristics](#) for the pass limits pertaining to each standard option.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS13Q pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal on DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage to the specified standards.



## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

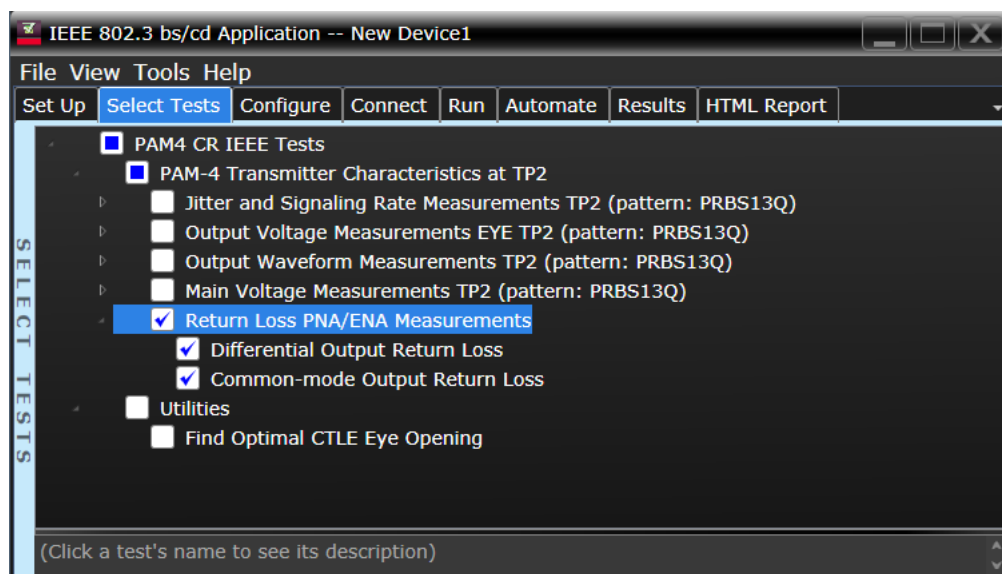


Figure 25 Selecting Return Loss PNA/ENA Measurements Tests

Refer to the section [C2C transmitter characteristics](#) for information on the pass limits for each test that is displayed for the selected standard option.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- [“Differential Output Return Loss”](#) on page 146
- [“Common-mode Output Return Loss”](#) on page 147

#### Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|

## Common-mode Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.



# 7 PAM4 Module Output Characteristics at TP4

Main Voltage Measurements TP4	151
Transition Time Measurements TP4	155
Signaling Rate and Eye Mask Measurements TP4	158
Return Loss ENA/PNA Measurements	168

This section provides the Methods of Implementation (MOIs) for the PAM4 200GAUI and 400GAUI IEEE PAM4 Module Output Characteristics at TP4 as specified in IEEE P802.3bs™ /D3.5 (Draft Standard for Ethernet Amendment 10: Media Access Control Parameters, Physical Layers and Management Parameters for 200Gb/s and 400Gb/s Operation), Annex 120E.3.2, Table 120E-3. Measurements are made at TP4.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## 200GAUI-4 and 400GAUI-8 C2M module output electrical characteristics

**Table 8** 200GAUI-4 and 400GAUI-8 C2M module output characteristics at TP4

Parameter	Reference	Value	Units
Signaling rate per lane (range)	See Sec. 120E.3.1.1 of the IEEE specification	26.5625 ± 100 ppm	GBd
AC common-mode output voltage (max, RMS)	See Sec. 120E.3.1.2 of the IEEE specification	17.5	mV
Differential peak-to-peak output voltage (max)	See Sec. 120E.3.1.2 of the IEEE specification	900	mV
Near-end ESMW (Eye symmetry mask width)	See Sec. 120E.4.2 of the IEEE specification	0.265	UI
Near-end Eye height, differential (min)	See Sec. 120E.4.2 of the IEEE specification	70	mV
Far-end ESMW (Eye symmetry mask width)	See Sec. 120E.4.2 of the IEEE specification	0.2	UI
Far-end Eye height, differential (min)	See Sec. 120E.4.2 of the IEEE specification	30	mV
Differential output return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-2) of the IEEE specification	dB
Common to differential mode conversion return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-3) of the IEEE specification	dB
Transition time (min, 20% to 80%)	See Sec. 120E.3.1.5 of the IEEE specification	9.5	ps
DC common mode voltage (min) <sup>a</sup>	See Sec. 120E.3.1.2 of the IEEE specification	-350	mV
DC common mode voltage (max) <sup>a</sup>	See Sec. 120E.3.1.2 of the IEEE specification	2850	mV

a. DC common mode voltage is generated by the host. Specification includes effects of ground offset voltage.

## Main Voltage Measurements TP4

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

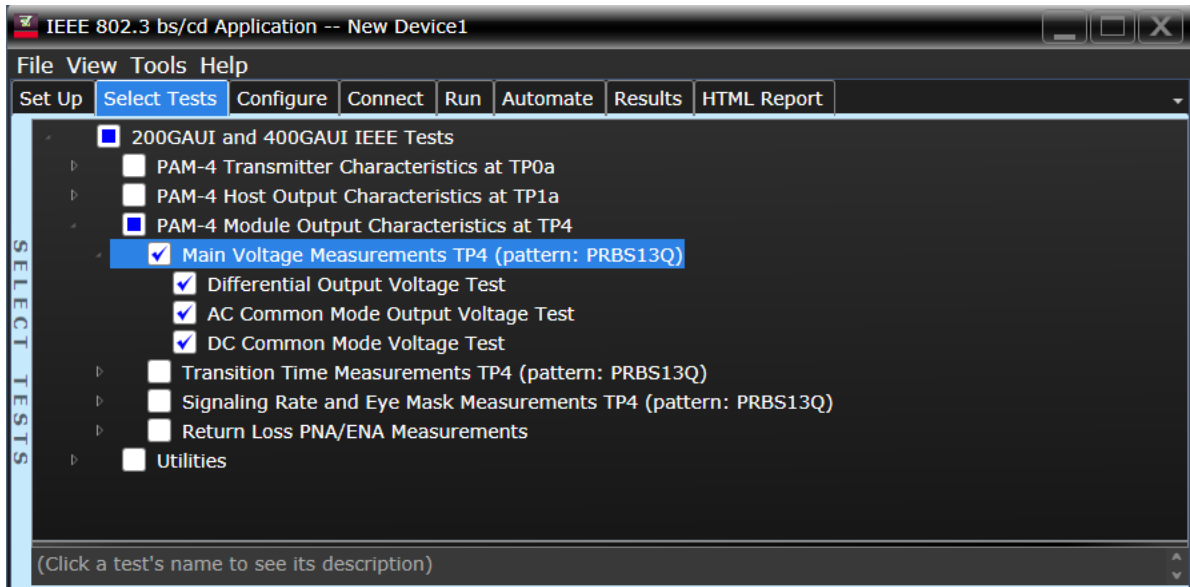


Figure 26 Selecting Main Voltage Measurement Tests

Refer to [Table 8](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Main Voltage Measurements TP4 (pattern: PRBS13Q) tests, see:

- “[Differential Output Voltage Test](#)” on page 152
- “[AC Common Mode Output Voltage Test](#)” on page 153
- “[DC Common Mode Voltage Test](#)” on page 154

### Differential Output Voltage Test

**Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS13Q pattern is less than 900mV.

**Pass Condition** Refer to [Table 8](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS13Q pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal of DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage to 900mV.



## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common-mode voltage of the signal does not exceed 17.5mV.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 8](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the peak-to-peak voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement with 17.5mV.

## DC Common Mode Voltage Test

**Test Overview** The purpose of this test is to verify that the common-mode voltage of the signal is between -350mV and 2.85V.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 8](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the peak-to-peak voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the range between -350mV and 2.85V.

## Transition Time Measurements TP4

The Transition Time Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

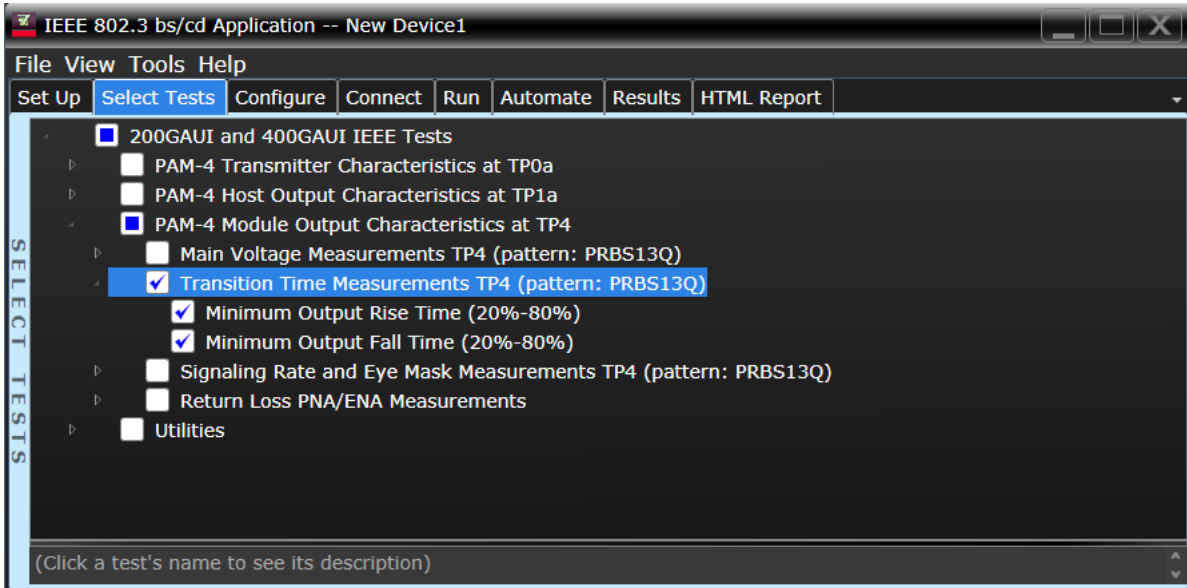


Figure 27 Selecting Transition Time Measurement Tests

Refer to [Table 8](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Transition Time Measurements TP4 (pattern: PRBS13Q) tests, see:

- “Minimum Output Rise Time (20%-80%)” on page 156
- “Minimum Output Fall Time (20%-80%)” on page 157

Minimum Output Rise Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise time is 9.5ps.

**Pass Condition** Refer to [Table 8](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS13Q.
  - 3 Find pattern 000333 for rising edge.
  - 4 Measure rise time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 9.5ps.

## Minimum Output Fall Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum fall time is 9.5ps.

**Pass Condition** Refer to [Table 8](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS13Q.
  - 3 Find pattern 333000 for the falling edge.
  - 4 Measure fall time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum fall time with 9.5ps.

## Signaling Rate and Eye Mask Measurements TP4

The Signaling Rate and Eye Mask Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

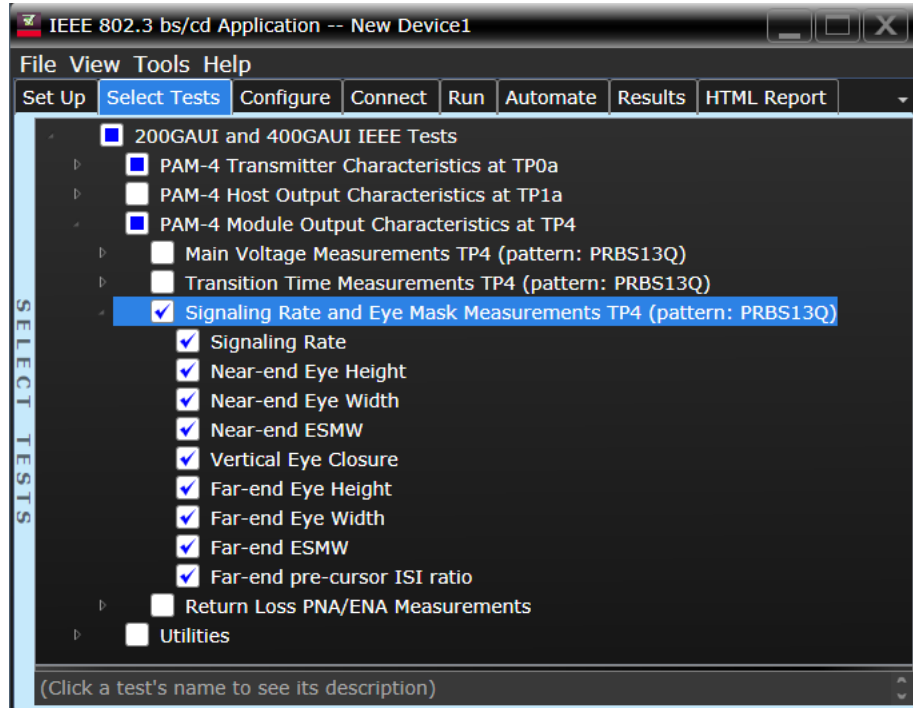


Figure 28 Selecting Signaling Rate and Eye Mask Measurement Tests

Refer to [Table 8](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Signaling Rate and Eye Mask Measurements TP4 (pattern: PRBS13Q) tests, see:

- “[Signaling Rate](#)” on page 159
- “[Near-end Eye Height](#)” on page 160
- “[Near-end Eye Width](#)” on page 161
- “[Near-end ESMW](#)” on page 162
- “[Vertical Eye Closure](#)” on page 163
- “[Far-end Eye Height](#)” on page 164
- “[Far-end Eye Width](#)” on page 165
- “[Far-end ESMW](#)” on page 166
- “[Far-end pre-cursor ISI ratio](#)” on page 167

## Signaling Rate

- Test Overview** The purpose of this test is to verify that the signaling rate mean is between  $26.5625 \pm 100\text{ppm}$  GBd.
- Pass Condition** Refer to [Table 8](#).
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS13Q must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum, maximum and mean data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with  $26.5625 \pm 100\text{ppm}$  GBd.
  - 7 Report the resulting value.

## Near-end Eye Height

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Near-end Eye Height is greater than 70mV. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 8](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Near-end Eye Height at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Near-end Eye Height with 70mV. Report the resulting value.



## Near-end Eye Width

**Test Overview** The purpose of this test is to measure the Near-end Eye Width for a defined range of CTLE settings. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Not applicable as the test result is considered as “Information Only”.

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as ‘User-defined optimal CTLE’.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Near-end Eye Width at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Report the resulting value of Near-end Eye Width.

**NOTE**

The Near-end Eye Width measurement is considered as an “Information-Only” test and cannot be used for compliance validation.

---

## Near-end ESMW

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Near-end ESMW is greater than 265mUI (that is, 132.5mUI each for the left and right eye). The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 8](#).

**NOTE**

The Near-end ESMW test checks for margins to the left and right of  $TC_{min}$ . Therefore, the limit used for measurements in this test is 0.1325UI.

**Measurement Algorithm**

- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
- 2 Obtain sample or acquire signal data.
- 3 Measure the Near-end ESMW ESMW at an **Eye Height/Width Probability** setting of 1E-5.
- 4 On the Oscilloscope,
  - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
- 5 Calculate Near-end ESMW for each given eye (left and right) using the equations:
 
$$\text{Left} = (\text{Eye Width} / 2) - \text{Eye Skew}$$

$$\text{Right} = (\text{Eye Width} / 2) + \text{Eye Skew}$$
- 6 Compare the Near-end ESMW with 265mUI (that is, 132.5mUI each for the left and right eye). Report the resulting value.

## Vertical Eye Closure

- Test Overview** The purpose of this test is to measure the Vertical Eye Closure at EH15 (1E-15).
- Pass Conditions** Not applicable as the test result is considered as “Information Only”.
- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as ‘User-defined optimal CTLE’.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Vertical Eye Closure at an **Eye Height/Width Probability** setting of 1E-15 (EH15).
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Measure and calculate AV as the mean value of logic 1 minus the mean value of logic 0 at the central 5% of the eye.
  - 6 Calculate Vertical Eye Closure (VEC) using the equation:
 
$$VEC = 20\log(AV/EH15)$$
  - 7 Report the resulting value of Vertical Eye Closure.

**NOTE**

The Vertical Eye Closure measurement is considered as an “Information-Only” test and cannot be used for compliance validation.

## Far-end Eye Height

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Far-end Eye Height is greater than 30mV. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 8](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Far-end Eye Height at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Far-end Eye Height with 30mV. Report the resulting value.

## Far-end Eye Width

**Test Overview** The purpose of this test is to measure the Far-end Eye Width for a defined range of CTLE settings. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Not applicable as the test result is considered as “Information Only”.

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as ‘User-defined optimal CTLE’.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Far-end Eye Width at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Report the resulting value of Far-end Eye Width.

**NOTE**

The Far-end Eye Width measurement is considered as an “Information-Only” test and cannot be used for compliance validation.

---

## Far-end ESMW

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Far-end ESMW is greater than 200mUI (that is, 100mUI each for the left and right eye). The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 8](#).

**NOTE**

The Far-end ESMW test checks for margins to the left and right of  $TC_{min}$ . Therefore, the limit used for measurements in this test is 0.1UI.

**Measurement Algorithm**

- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
- 2 Obtain sample or acquire signal data.
- 3 Measure the Far-end ESMW ESMW at an **Eye Height/Width Probability** setting of 1E-5.
- 4 On the Oscilloscope,
  - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
- 5 Calculate Far-end ESMW for each given eye (left and right) using the equations:

$$\text{Left} = (\text{Eye Width} / 2) - \text{Eye Skew}$$

$$\text{Right} = (\text{Eye Width} / 2) + \text{Eye Skew}$$

- 6 Compare the Far-end ESMW with 200mUI (that is, 100mUI each for the left and right eye). Report the resulting value.

Far-end pre-cursor ISI ratio

**Test Overview** The purpose of this test is to verify that for a selected CTLE settings, the Far-end ESMW is greater than 200mUI (that is, 100mUI each for the left and right eye). The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 8](#).

**NOTE**

The Far-end ESMW test checks for margins to the left and right of  $TC_{min}$ . Therefore, the limit used for measurements in this test is 0.1UI.

**Measurement Algorithm**

- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
- 2 Obtain sample or acquire signal data.
- 3 Measure the Far-end ESMW ESMW at an **Eye Height/Width Probability** setting of 1E-5.
- 4 On the Oscilloscope,
  - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
- 5 Calculate Far-end ESMW for each given eye (left and right) using the equations:
 
$$\text{Left} = (\text{Eye Width} / 2) - \text{Eye Skew}$$

$$\text{Right} = (\text{Eye Width} / 2) + \text{Eye Skew}$$
- 6 Compare the Far-end ESMW with 200mUI (that is, 100mUI each for the left and right eye). Report the resulting value.

## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

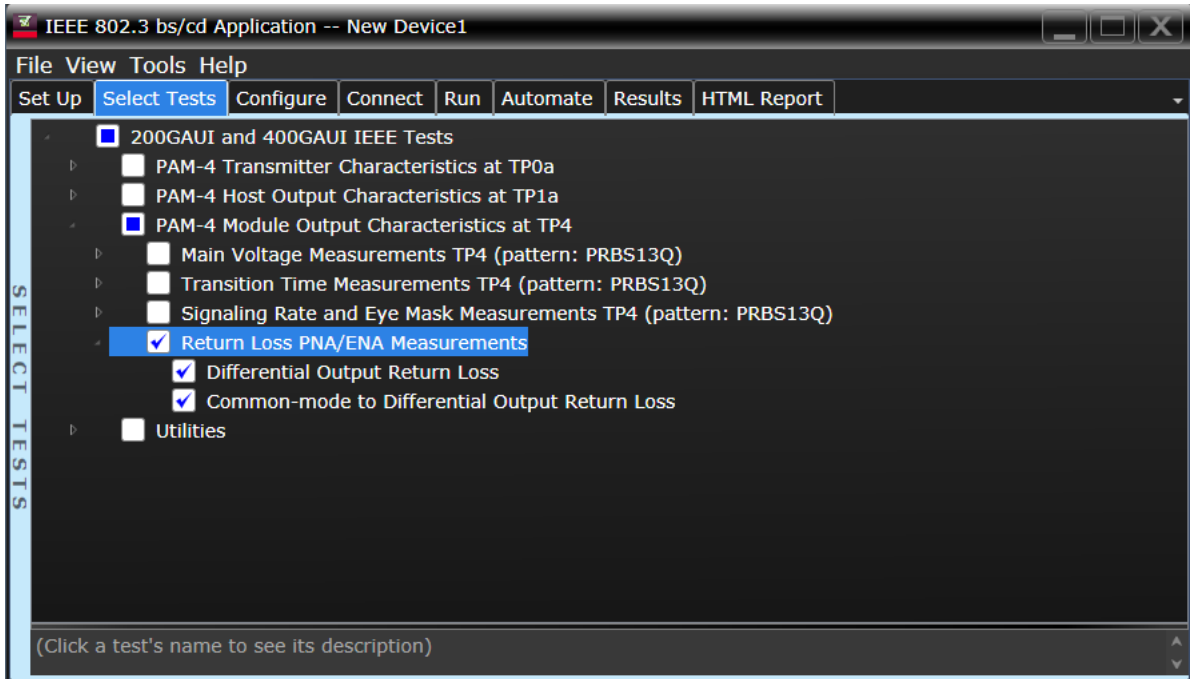


Figure 29 Selecting Return Loss Measurement Tests

Refer to [Table 8](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- [“Differential Output Return Loss”](#) on page 169
- [“Common-mode to Differential Output Return Loss”](#) on page 170



## Differential Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.

#### Common-mode to Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|

# 8 NRZ Transmitter Characteristics at TP0a

Jitter and Signaling Rate Measurements TP0a 174

Output Waveform Measurements TP0a 179

Main Voltage Measurements TP0a 194

Return Loss ENA/PNA Measurements 199

This section provides the Methods of Implementation (MOIs) for the 200GAUI and 400GAUI IEEE NRZ Transmitter Characteristics at TP0a as specified in IEEE Std. 802.3-2015 (IEEE standard for Ethernet), Annex 83D.3.1, Table 83D-1 with 120B.3.1. Measurements are made at TP0a.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## CAUI-4 C2C transmitter electrical characteristics

**Table 9 CAUI-4 C2C transmitter characteristics at TP0a**

Parameter	Reference	Value	Units
Signaling rate per lane (range)	See Sec. 93.8.1.2 of the IEEE specification	25.78125 ± 100 ppm	GBd
Differential peak-to-peak output voltage (max)	See Sec. 93.8.1.3 of the IEEE specification	30	mV
Transmitter disabled		1200	mV
Transmitter enabled			
Common-mode voltage (max)	See Sec. 93.8.1.3 of the IEEE specification	1.9	V
Common-mode voltage (min)	See Sec. 93.8.1.3 of the IEEE specification	0	V
AC common-mode output voltage (max, RMS)	See Sec. 93.8.1.3 of the IEEE specification	12	mV
Differential output return loss (min)	See Sec. 93.8.1.4 of the IEEE specification	See Equation (93-3) of the IEEE specification	dB
Common-mode output return loss (min)	See Sec. 93.8.1.4 of the IEEE specification	See Equation (93-4) of the IEEE specification	dB
Output waveform <sup>a</sup>	See Sections		
Steady state voltage $v_f$ (max)	93.8.1.5.2 <sup>b</sup>	0.6	V
Steady state voltage $v_f$ (min)	93.8.1.5.2 <sup>b</sup>	0.4	V
Linear fit pulse peak (min)	93.8.1.5.2 <sup>b</sup>	$0.71 \times v_f$	V
Pre-cursor equalization	83D.3.1.1	Table 83D-2	-
Post-cursor equalization	83D.3.1.1	Table 83D-3	-
Signal-to-noise-and-distortion ratio (min)	See Sec. 93.8.1.6 <sup>b</sup> of the IEEE specification	27	dB
Output jitter (max)	See Sec. 92.8.3.8 of the IEEE specification		
Even-odd jitter		0.035	UI
Effective bounded uncorrelated jitter, peak-to-peak <sup>c</sup>		0.1	UI
Effective total uncorrelated jitter, peak-to-peak <sup>c,d</sup>		0.26	UI

a. The state of the transmit equalizer is controlled by management interface.

b. The values of the parameters are measured as defined in the referenced sub-clause except that the values of  $N_p$  and  $N_w$  are 5.

c. Effective bounded uncorrelated jitter and effective total uncorrelated jitter are measured as defined in section 92.8.3.8.2 of the IEEE specification except that the range for fitting CDF<sub>Li</sub> and CDF<sub>Ri</sub>, (as defined in section 92.8.3.8.2 c), shall be from  $10^{-6}$  to  $10^{-4}$ .

d. Effective total uncorrelated jitter, peak-to-peak is specified to a probability of  $10^{-15}$ .

## 200GAUI-8 and 400GAUI-16 C2C transmitter characteristics

A 200GAUI-8 or a 400GAUI-16 chip-to-chip transmitter shall meet all specifications in section 83D.3.1 of the IEEE specification (refer to [Table 9](#) for limits corresponding to Table 83D-1) with the following exceptions:

- The signaling rate per lane is  $26.5625 \text{ Gbd} \pm 100 \text{ ppm}$ .
- The value for the “Linear fit pulse peak (min)” in Table 83D-1 is  $0.75 \times \text{vf}$ .
- The value for the “Effective total uncorrelated jitter, peak-to-peak” in [Table 9](#) is 0.19 UI.
- The value of the probability in footnote ‘d’ of [Table 9](#) is  $10^{-6}$ .
- The high-pass filter used for the jitter measurements in section 92.8.3.8 of the IEEE specification has a 3 dB frequency of 4 MHz.

If a Clause 45 MDIO is implemented, *Local\_eq\_cm1* and *Local\_eq\_c1* for each lane (0 through 7 for 200GAUI-8 and 0 through 15 for 400GAUI-16) and direction (transmit and receive) are accessible through registers 1.500 through 1.531 (see sections 45.2.1.116d through 45.2.1.116g of the IEEE specification).

## Jitter and Signaling Rate Measurements TP0a

The Jitter and Signaling Rate Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

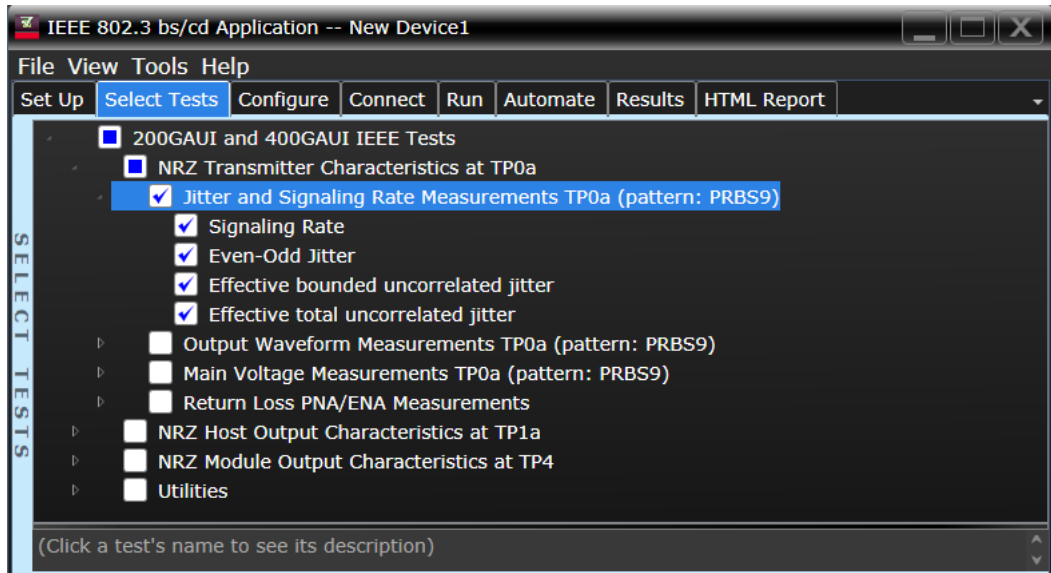


Figure 30 Selecting Main Voltage Measurement Tests

Refer to [Table 9](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Jitter and Signaling Rate Measurements TP0a (pattern: PRBS9) tests, see:

- “[Signaling Rate](#)” on page 175
- “[Even-Odd Jitter](#)” on page 176
- “[Effective bounded uncorrelated jitter](#)” on page 177
- “[Effective total uncorrelated jitter](#)” on page 178

## Signaling Rate

- Test Overview** The purpose of this test is to verify that the signaling rate is between  $26.5625 \pm 100\text{ppm}$  GBd.
- Pass Condition** Refer to the exceptions described in “200GAUI-8 and 400GAUI-16 C2C transmitter characteristics” on page 173.
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS9 must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum and maximum data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with  $26.5625 \pm 100\text{ppm}$  GBd. Report the resulting value.

## Even-Odd Jitter

**Test Overview** The purpose of this test is to verify that differential signal's Even-Odd Jitter is less than 0.035 UI. All jitter tests are run in a single measurement. However, each test can be run individually.

**Pass Conditions** Refer to [Table 9](#).

**Measurement Algorithm** 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS9 pattern.

**NOTE**

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS9 pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS9 patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

**NOTE**

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the Even-Odd Jitter value to the respective maximum specification.



Effective bounded uncorrelated jitter

**Test Overview** The purpose of this test is to verify that differential signal's peak-to-peak effective bounded uncorrelated jitter is less than 0.1 UI. All jitter tests are run in a single measurement. However, each test can be run individually.

**Pass Conditions** Refer to [Table 9](#).

**Measurement Algorithm** 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS9 pattern.

#### NOTE

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS9 pattern.

- 
- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
  - 3 On the Oscilloscope,
    - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Using PAM4 jitter measurements, at least 10,000 PRBS9 patterns are captured to collect the measurement data of 12 edges.
    - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

#### NOTE

This measurement can run for a duration of 8-10 minutes.

- 
- 4 Compare and report the effective bounded uncorrelated jitter value to the respective maximum specification.

Effective total uncorrelated jitter

**Test Overview** The purpose of this test is to verify that differential signal's peak-to-peak effective total uncorrelated jitter is less than 0.19 UI. All jitter tests are run in a single measurement. However, each test can be run individually.

**Pass Conditions** Refer to [Table 9](#) and the exceptions described in “200GAUI-8 and 400GAUI-16 C2C transmitter characteristics” on page 173.

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data. Set acquisition depth to five times the length of the PRBS9 pattern.

#### NOTE

For UXR Series Oscilloscopes, connections must be established between Data+ to Channel 1 and Data- to Channel 2 to measure the defined 12 edges.

Irrespective of the Oscilloscope used, the signal must be of PRBS9 pattern.

- 2 In the **Configure** tab, set the value for the Signaling Rate as that of the Symbol Rate of the acquired signal.
- 3 On the Oscilloscope,
  - a Set Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
  - b Using PAM4 jitter measurements, at least 10,000 PRBS9 patterns are captured to collect the measurement data of 12 edges.
  - c Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.

#### NOTE

This measurement can run for a duration of 8-10 minutes.

- 4 Compare and report the effective total uncorrelated jitter value to the respective maximum specification.

## Output Waveform Measurements TP0a

The Output Waveform Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

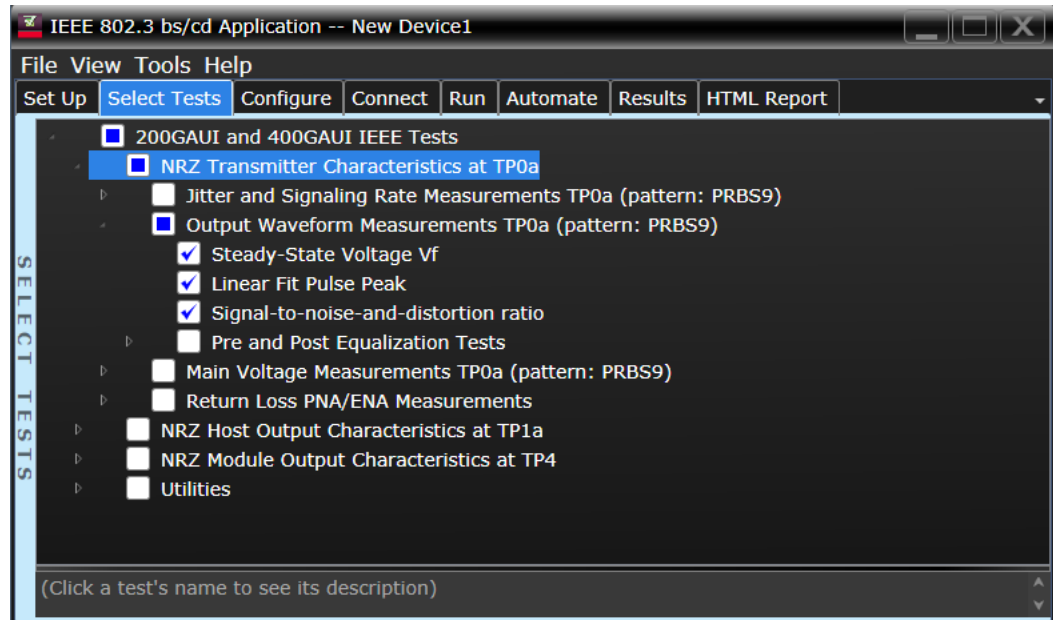


Figure 31 Selecting Jitter and Signaling Rate Measurement Tests

Refer to [Table 9](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Output Waveform Measurements TP0a (pattern: PRBS9) tests, see:

- “Steady State Voltage Vf” on page 180
- “Linear Fit Pulse Peak” on page 181
- “Signal-to-noise-and-distortion ratio” on page 182
- “Pre and Post Equalization Tests” on page 183

Steady State Voltage  $V_f$

**Test Overview** The purpose of this test is to verify that the Steady State Voltage is between 0.4V and 0.6V.

**Pass Condition** Refer to [Table 9](#).

- Measurement Algorithm**
- 1 Check that signal is connected and proper data pattern exists (PRBS9 must be used for this test).
  - 2 Set memory depth and sample rate to capture the 511 bits of the PRBS9 pattern.
  - 3 Calculate  $V_f$  using the equations in section 85.8.3.3.5. The resulting value is the sum of columns of  $p(k)/M$ .  $N_p = 200$ ,  $D_p = 2$ .
  - 4 Compare and report the resulting value in the range between 0.4V and 0.6V.

## Linear Fit Pulse Peak

**Test Overview** The purpose of this test is to verify that the Linear Fit Pulse is greater than ( $V_f \times 0.75$ ).

**NOTE**

Run the Steady-State Voltage  $V_f$  test as a prerequisite to running the Linear Fit Pulse Peak test.

---

**Pass Conditions** Refer to [Table 9](#) and the exceptions described in “[200GAUI-8 and 400GAUI-16 C2C transmitter characteristics](#)” on page 173.

**Measurement Algorithm**

- 1 Check that signal is connected and proper data pattern exists (PRBS9 must be used for this test).
- 2 Set memory depth and sample rate to capture the 511 bits of the PRBS9 pattern.
- 3 Calculate Linear Fit Pulse using the equations in section 85.8.3.3.5. The resulting value is the peak value of  $p(k)$ .  $N_p = 200$ ,  $D_p = 2$ .
- 4 Compare and report the resulting value with ( $V_f \times 0.75$ ).

Signal-to-noise-and-distortion ratio

- Test Overview** The purpose of this test is to verify that the Signal-to-noise-and-distortion ratio (SNDR) is greater than 27 dB.
- Pass Condition** Refer to [Table 9](#).
- Measurement Algorithm**
- 1 Calculate SNDR using measurements from Level RMS - PRBS pattern test and error from Linear Fit Pulse Peak test.
  - 2 Compare and report the value of SNDR with 27 dB.

## Pre and Post Equalization Tests

**Test Overview** The purpose of this test is to verify the Pre-cursor and Post-cursor equalization ratios.

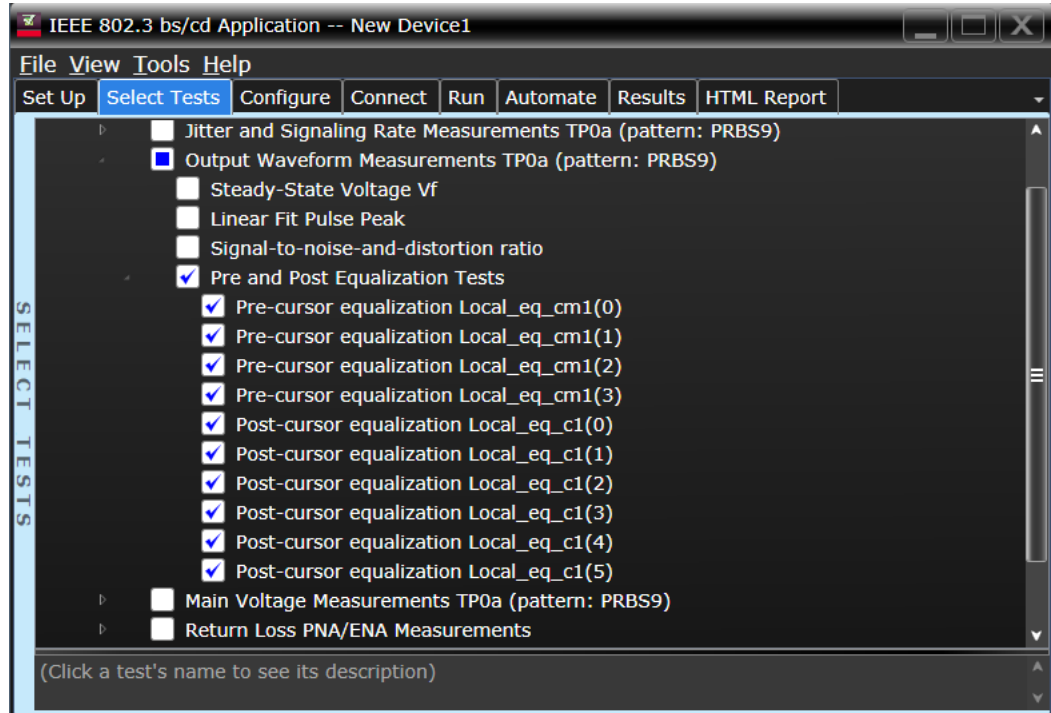


Figure 32 Selecting Transmitter Output Waveform Tests

To know about the measurement algorithm for each Pre and Post Equalization Tests, see:

- “Pre-cursor equalization Local\_eq\_cm1(0)” on page 184
- “Pre-cursor equalization Local\_eq\_cm1(1)” on page 185
- “Pre-cursor equalization Local\_eq\_cm1(2)” on page 186
- “Pre-cursor equalization Local\_eq\_cm1(3)” on page 187
- “Pre-cursor equalization Local\_eq\_c1(0)” on page 188
- “Post-cursor equalization Local\_eq\_c1(1)” on page 189
- “Post-cursor equalization Local\_eq\_c1(2)” on page 190
- “Post-cursor equalization Local\_eq\_c1(3)” on page 191
- “Post-cursor equalization Local\_eq\_c1(4)” on page 192
- “Post-cursor equalization Local\_eq\_c1(5)” on page 193

**Pre-cursor equalization Local\_eq\_cm1(0)**

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $0 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 0, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $0 \pm 0.04$ .
- Measurement Algorithm**
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 0.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $0 \pm 0.04$ .



**Pre-cursor equalization Local\_eq\_cm1(1)**

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.05 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 1, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.05 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 1.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $-0.05 \pm 0.04$ .

**Pre-cursor equalization Local\_eq\_cm1(2)**

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.1 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 2, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.1 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 2.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $-0.1 \pm 0.04$ .

**Pre-cursor equalization Local\_eq\_cm1(3)**

- Test Overview** The purpose of this test is to verify that the Pre-cursor equalization ratio is  $-0.15 \pm 0.04$ .
- Pass Condition** When the Pre-cursor equalization with weight Local\_eq\_cm1 = 3, the ratio defined by  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.15 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Pre-cursor equalization with weight local\_eq\_cm1 = 3.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate pre-cursor ratio using the equation  $C(-1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of pre-cursor ratio with  $-0.15 \pm 0.04$ .

**Pre-cursor equalization Local\_eq\_c1(0)**

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $0 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 0, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $0 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 0.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $0 \pm 0.04$ .

### Post-cursor equalization Local\_eq\_c1(1)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.05 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 1, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.05 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 1.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.05 \pm 0.04$ .

### Post-cursor equalization Local\_eq\_c1(2)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.1 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 2, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.1 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 2.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.1 \pm 0.04$ .

### Post-cursor equalization Local\_eq\_c1(3)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.15 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 3, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.15 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 3.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.15 \pm 0.04$ .

#### Post-cursor equalization Local\_eq\_c1(4)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.2 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 4, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.2 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 4.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.2 \pm 0.04$ .



### Post-cursor equalization Local\_eq\_c1(5)

- Test Overview** The purpose of this test is to verify that the Post-cursor equalization ratio is  $-0.25 \pm 0.04$ .
- Pass Condition** When the Post-cursor equalization with weight Local\_eq\_c1 = 5, the ratio defined by  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$  must be within  $-0.25 \pm 0.04$ .
- Measurement Algorithm** Skip to step 5 if the first four steps have already been measured/calculated in a previous equalization test of the same trial.
- 1 Request Transmitter to be set to "PRESET" condition.
  - 2 Set memory depth to capture one full PRBS9 pattern and scale.
  - 3 Calculate linear fit pulse response at "PRESET" condition.
  - 4 Define matrix Rm using equation (92-4) from IEEE 802.3.
  - 5 Request to change the eq setting to Post-cursor equalization with weight local\_eq\_c1 = 5.
  - 6 Calculate linear fit pulse response as per section 93.8.1.5.2 of the IEEE Std. 802.3-2015 specification document, with  $N_p = 200$ ,  $D_p = 2$ .
  - 7 Calculate coefficients using equation (92-5) from IEEE 802.3.
  - 8 Calculate post-cursor ratio using the equation  $C(1) / [|C(-1)| + |C(0)| + |C(1)|]$ .
  - 9 Compare and report the value of post-cursor ratio with  $-0.25 \pm 0.04$ .

## Main Voltage Measurements TP0a

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

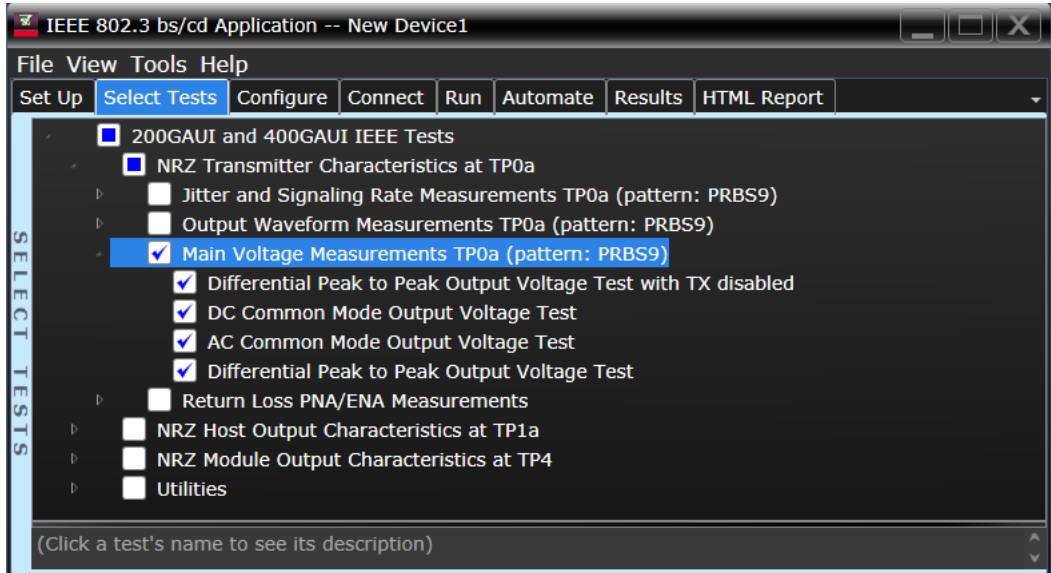


Figure 33 Selecting Transmitter Output Voltage Measurement EYE Tests

Refer to [Table 9](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Main Voltage Measurements TP0a (pattern: PRBS9) tests, see:

- “[Differential Peak-to-Peak Output Voltage Test with TX Disabled](#)” on page 195
- “[DC Common Mode Output Voltage Test](#)” on page 196
- “[AC Common Mode Output Voltage Test](#)” on page 197
- “[Differential Peak-to-Peak Output Voltage Test](#)” on page 198

## Differential Peak-to-Peak Output Voltage Test with TX Disabled

- Test Overview** The purpose of this test is to verify that when TX is disabled, the peak-to-peak voltage must be less than 30mV.
- Pass Condition** Refer to [Table 9](#).
- Measurement Algorithm**
- 1 Obtain a sample or acquire the signal data.
  - 2 Ensure that TX is disabled on the acquired signal (no valid data transitions).
  - 3 Measure peak-to-peak voltage of the signal.
  - 4 Compare the maximum peak-to-peak voltage with 30mV.

### DC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal is between 0V to 1.9V.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 9](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the DC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the range from 0V to 1.9 V.

## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal does not exceed 12mV.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 9](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the AC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement with 12mV.

#### Differential Peak-to-Peak Output Voltage Test

**Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS9 pattern is less than 1200mV.

**Pass Condition** Refer to [Table 9](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS9 pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal on DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage with 1200mV.

## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

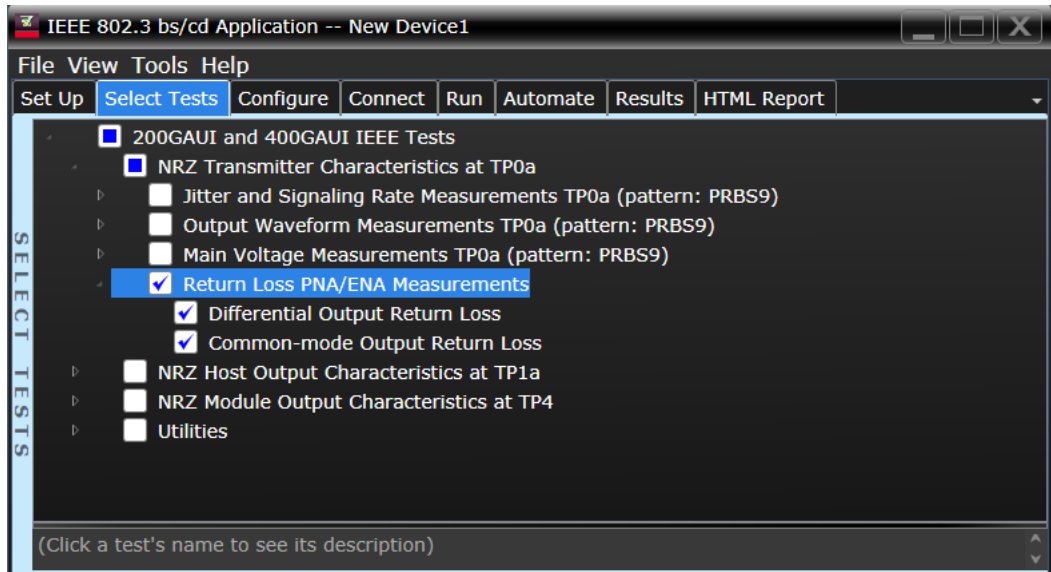


Figure 34 Selecting Return Loss Measurement Tests

Refer to [Table 9](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- “[Differential Output Return Loss](#)” on page 200
- “[Common-mode Output Return Loss](#)” on page 201

#### Differential Output Return Loss

- |                              |   |
|------------------------------|---|
| <b>Measurement Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|------------------------------|---|



## Common-mode Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.



# 9 NRZ Host Output Characteristics at TP1a

Main Voltage Measurements TP1a 206  
Transition Time Measurements TP1a 212  
Signaling Rate and Eye Mask Measurements TP1a 215  
Return Loss ENA/PNA Measurements 219

This section provides the Methods of Implementation (MOIs) for the 200GAUI and 400GAUI IEEE NRZ Host Output Characteristics at TP1a as specified in IEEE Std. 802.3-2015 (IEEE standard for Ethernet), Annex 83E.3.1, Table 83E-1 with 120C.3.1. Measurements are made at TP1a.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the **Compliance Test Application** must match the frequency of the acquired input signal.

---

## CAUI-4 C2M host output electrical characteristics

**Table 10 CAUI-4 C2C host output characteristics at TP1a**

Parameter	Reference	Value	Units
Signaling rate per lane (range)	See Sec. 83E.3.1.1 of the IEEE specification	25.78125 ± 100 ppm	GBd
DC Common-mode voltage (max)	See Sec. 83E.3.1.2 of the IEEE specification	2.8	V
DC Common-mode voltage (min)	See Sec. 83E.3.1.2 of the IEEE specification	-0.3	V
Single-ended output voltage (max)	See Sec. 83E.3.1.2 of the IEEE specification	3.3	V
Single-ended output voltage (min)	See Sec. 83E.3.1.2 of the IEEE specification	-0.4	V
AC common-mode output voltage (max, RMS)	See Sec. 83E.3.1.2 of the IEEE specification	17.5	mV
Differential peak-to-peak output voltage (max) Transmitter disabled Transmitter enabled	See Sec. 83E.3.1.2 of the IEEE specification	35 900	mV mV
Eye width (min)	See Sec. 83E.3.1.6 of the IEEE specification	0.46	UI
Eye height A, differential (min)	See Sec. 83E.3.1.6 of the IEEE specification	95	mV
Differential output return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-2) of the IEEE specification	dB
Common to differential mode conversion return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-3) of the IEEE specification	dB
Transition time (min, 20% to 80%)	See Sec. 83E.3.1.5 of the IEEE specification	10	dB

## 200GAUI-8 and 400GAUI-16 C2M host output characteristics

A 200GAUI-8 or a 400GAUI-16 chip-to-module host output shall meet all specifications in section 83E.3.1 of the IEEE specification (refer to [Table 10](#) for limits corresponding to Table 83E-1) with the following exceptions:

- The signaling rate per lane is  $26.5625 \text{ Gbd} \pm 100 \text{ ppm}$ .
- The clock recovery unit corner frequency is 4 MHz.

If a Clause 45 MDIO is implemented, the variable *Recommended\_CTLE\_value* is accessible in the module for lanes 0 through 7 for 200GAUI-8 and 0 through 15 for 400GAUI-16 through registers 1.400 to 1.415 (see sections 45.2.1.116a and 45.2.1.116b of the IEEE specification).

## Main Voltage Measurements TP1a

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

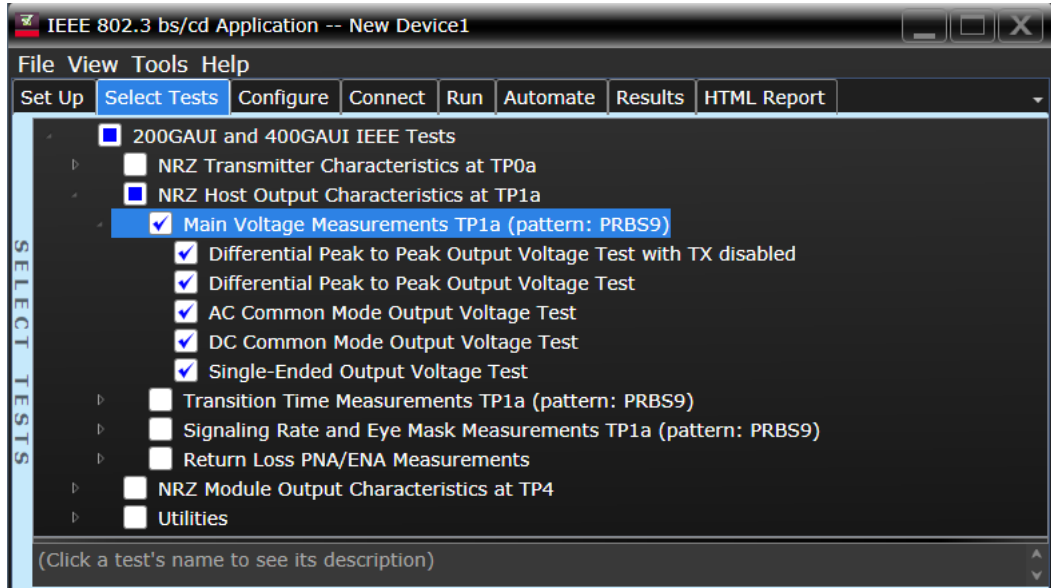


Figure 35 Selecting Main Voltage Measurement Tests

Refer to [Table 10](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Main Voltage Measurements TP1a (pattern: PRBS9) tests, see:

- “Differential Peak-to-Peak Output Voltage Test with TX Disabled” on page 207
- “Differential Peak-to-Peak Output Voltage Test” on page 208
- “AC Common Mode Output Voltage Test” on page 209
- “DC Common Mode Output Voltage Test” on page 210
- “Single-ended Output Voltage Test” on page 211

## Differential Peak-to-Peak Output Voltage Test with TX Disabled

- Test Overview** The purpose of this test is to verify that when TX is disabled, the peak-to-peak voltage must be less than 35mV.
- Pass Condition** Refer to [Table 10](#).
- Measurement Algorithm**
- 1 Obtain a sample or acquire the signal data.
  - 2 Ensure that TX is disabled on the acquired signal (no valid data transitions).
  - 3 Measure peak-to-peak voltage of the signal.
  - 4 Compare the maximum peak-to-peak voltage to 35mV.

### Differential Peak-to-Peak Output Voltage Test

**Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS9 pattern is less than 900mV.

**Pass Condition** Refer to [Table 10](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS9 pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal on DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage with 900mV.



## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal does not exceed 17.5mV.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 10](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the AC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement with 17.5mV.

### DC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common mode signal is between -300mV and 2.8V.

**NOTE**

This measurement can be done only with dual-single ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 10](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the DC common-mode voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the range between -300mV and 2.8V.

## Single-ended Output Voltage Test

**Test Overview** The purpose of this test is to verify that the minimum voltage on a single-ended signal is greater than -400mV and that the maximum voltage is less than 3.3V.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 10](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the minimum and maximum voltage on each single-ended signal.
- 4 Compare the voltage measurements with the range between -400mV and 3.3V.

## Transition Time Measurements TP1a

The Transition Time Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

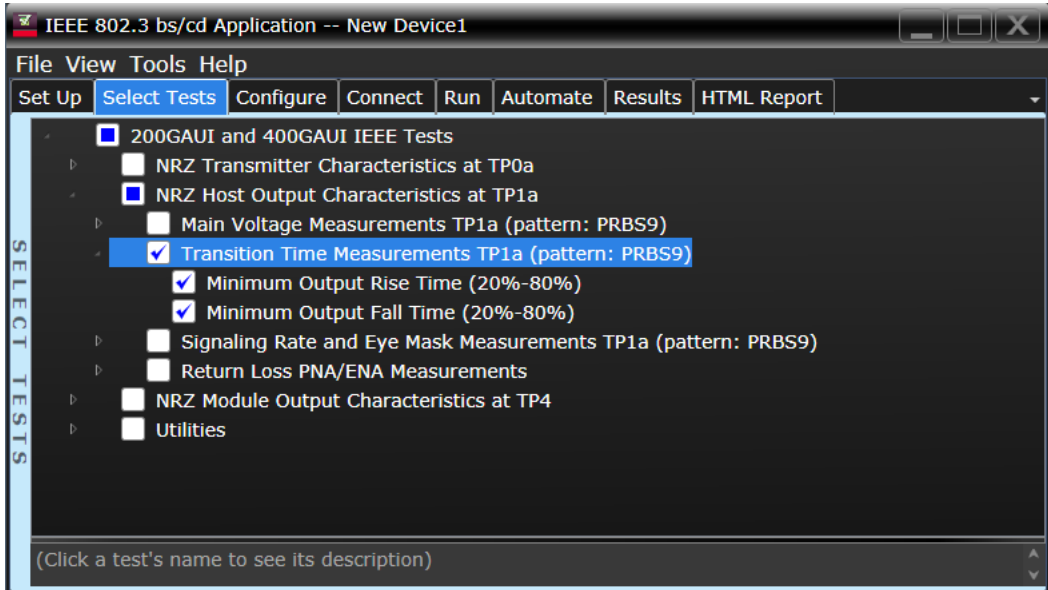


Figure 36 Selecting Transition Time Measurement Tests

Refer to [Table 10](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Transition Time Measurements TP1a (pattern: PRBS9) tests, see:

- “Minimum Output Rise Time (20%-80%)” on page 213
- “Minimum Output Fall Time (20%-80%)” on page 214

## Minimum Output Rise Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise fall time is 10ps.

**Pass Condition** Refer to [Table 10](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS9.
  - 3 Find pattern 000333 for the rising edge.
  - 4 Measure rise time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 10ps.

Minimum Output Fall Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise and fall times are 10ps.

**Pass Condition** Refer to [Table 10](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS9.
  - 3 Find pattern 333000 for the falling edge.
  - 4 Measure fall time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 10ps.

## Signaling Rate and Eye Mask Measurements TP1a

The Signaling Rate and Eye Mask Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

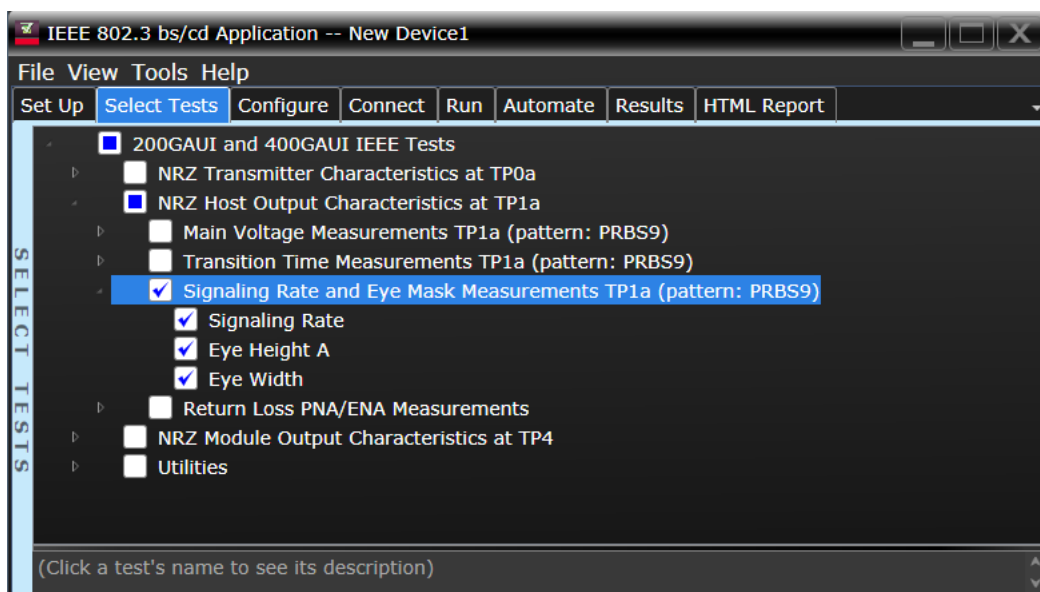


Figure 37 Selecting Eye Mask Measurement Tests

Refer to [Table 10](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Signaling Rate and Eye Mask Measurements TP1a (pattern: PRBS9) tests, see:

- “[Signaling Rate](#)” on page 216
- “[Eye Height](#)” on page 217
- “[Eye Width](#)” on page 218

### Signaling Rate

**Test Overview** The purpose of this test is to verify that the signaling rate mean is between  $26.5625 \pm 100\text{ppm}$  GBd.

**Pass Condition** Refer to the exceptions described in “200GAUI-8 and 400GAUI-16 C2M host output characteristics” on page 205.

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS9 must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum, maximum and mean data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with  $26.5625 \pm 100\text{ppm}$  GBd.
  - 7 Report the resulting value.



## Eye Height

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Eye Height is greater than 95mV. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 10](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Eye Height A at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Eye Height A with 95mV. Report the resulting value.

## Eye Width

<b>Test Overview</b>	The purpose of this test is to verify that for a defined range of CTLE settings, the Eye Width is greater than 460mUI. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.
<b>Pass Conditions</b>	Not applicable as the test result is considered as “Information Only”.
<b>Measurement Algorithm</b>	<ol style="list-style-type: none"><li>1 Manually select the optimal CTLE setting from the <b>Use Optimized CTLE for Eye Opening</b> drop-down options in the <b>Configure</b> tab. The selected CTLE setting is called as ‘User-defined optimal CTLE’.</li><li>2 Obtain sample or acquire signal data.</li><li>3 Measure the Eye Width at an <b>Eye Height/Width Probability</b> setting of 1E-5.</li><li>4 On the Oscilloscope,<ol style="list-style-type: none"><li>a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.</li><li>b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.</li></ol></li><li>5 Compare the Eye Width with 460mUI. Report the resulting value.</li></ol>

## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

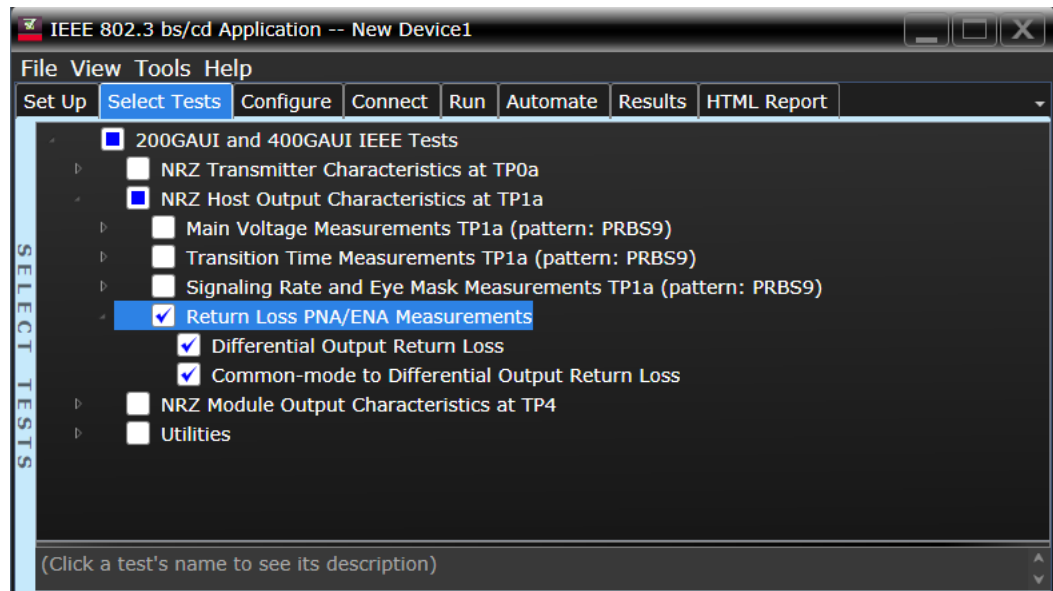


Figure 38 Selecting Return Loss Measurement Tests

Refer to [Table 10](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- “Differential Output Return Loss” on page 220
- “Common-mode to Differential Output Return Loss” on page 221

#### Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|

## Common-mode to Differential Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.



# 10 NRZ Module Output Characteristics at TP4

Main Voltage Measurements TP4 226  
Transition Time Measurements TP4 230  
Signaling Rate and Eye Mask Measurements TP4 233  
Return Loss ENA/PNA Measurements 238

This section provides the Methods of Implementation (MOIs) for the 200GAUI and 400GAUI IEEE NRZ Transmitter Characteristics at TP4 as specified in IEEE Std. 802.3-2015 (IEEE standard for Ethernet), Annex 83E.3.2, Table 83E-3 with 120C.3.2. Measurements are made at TP4.

## NOTE

Ensure that the **Signaling Rate** setting in the **Configure** tab of the **Compliance Test Application** must match the frequency of the acquired input signal.

---

## CAUI-4 module output characteristics

**Table 11 CAUI-4 module output characteristics at TP4**

Parameter	Reference	Value	Units
Signaling rate per lane (range)	See Sec. 83E.3.1.1 of the IEEE specification	25.78125 ± 100 ppm	GBd
AC common-mode output voltage (max, RMS)	See Sec. 83E.3.1.2 of the IEEE specification	17.5	mV
Differential output voltage (max)	See Sec. 83E.3.1.2 of the IEEE specification	900	mV
Eye-width (min)	See Sec. 83E.3.2.1 of the IEEE specification	0.57	UI
Eye height, differential (min)	See Sec. 83E.3.2.1 of the IEEE specification	228	mV
Vertical Eye Closure (max)	See Sec. 83E.4.2.1 of the IEEE specification	5.5	dB
Differential output return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-2) of the IEEE specification	dB
Common to differential mode conversion return loss (min)	See Sec. 83E.3.1.3 of the IEEE specification	See Equation (83E-3) of the IEEE specification	dB
Transition time (min, 20% to 80%)	See Sec. 83E.3.1.5 of the IEEE specification	12	ps
DC common mode voltage (min) <sup>a</sup>	See Sec. 83E.3.1.2 of the IEEE specification	-350	mV
DC common mode voltage (max) <sup>a</sup>	See Sec. 83E.3.1.2 of the IEEE specification	2850	mV

a. DC common mode voltage is generated by the host. Specification includes effects of ground offset voltage.



## 200GAUI-8 and 400GAUI-16 C2M module output characteristics

A module output of 200GAUI-8 or a 400GAUI-16 chip-to-module shall meet all specifications in section 83E.3.2 of the IEEE specification (refer to [Table 11](#) for limits corresponding to Table 83E-3) with the following exceptions:

- The signaling rate per lane is  $26.5625 \text{ Gbd} \pm 100 \text{ ppm}$ .
- The eye height, eye width, and vertical eye closure are as specified in section 109B.3.2.1 of the IEEE specification, for a PHY that includes an RS-FEC sublayer.
- The clock recovery unit corner frequency is 4 MHz.

## Main Voltage Measurements TP4

The Main Voltage measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

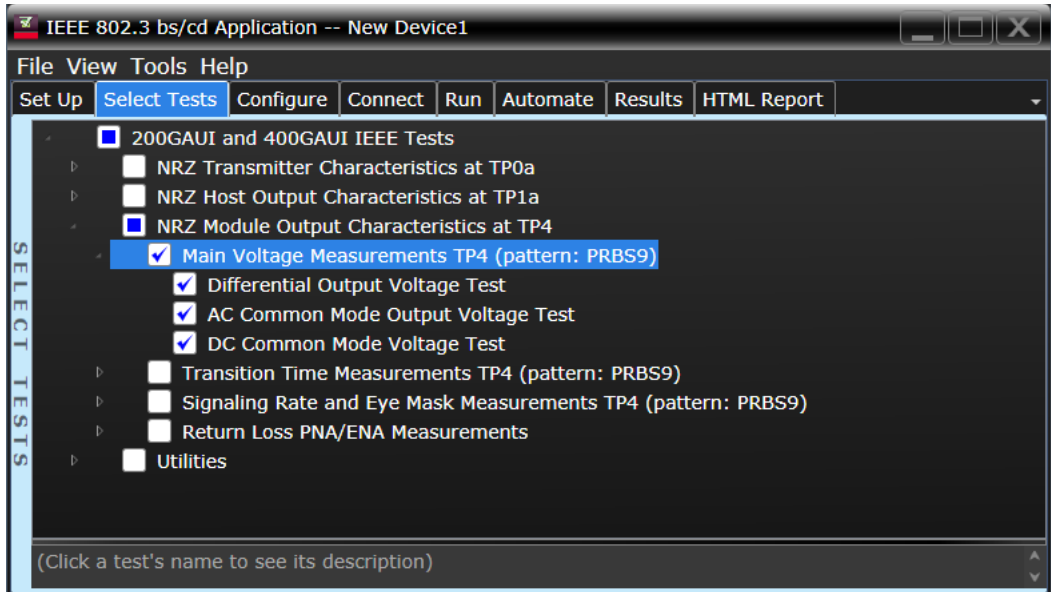


Figure 39 Selecting Main Voltage Measurement Tests

Refer to [Table 11](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Main Voltage Measurements TP4 (pattern: PRBS9) tests, see:

- “[Differential Output Voltage Test](#)” on page 227
- “[AC Common Mode Output Voltage Test](#)” on page 228
- “[DC Common Mode Voltage Test](#)” on page 229

## Differential Output Voltage Test

- Test Overview** The purpose of this test is to verify that the peak-to-peak voltage of the differential signal on a PRBS9 pattern is less than 900mV.
- Pass Condition** Refer to [Table 11](#).
- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is connected, has TX enabled and has a PRBS9 pattern.
  - 3 Measure the peak-to-peak voltage of the differential signal of DUT+ and DUT-.
  - 4 Compare the maximum peak-to-peak voltage to 900mV.

## AC Common Mode Output Voltage Test

**Test Overview** The purpose of this test is to verify that the common-mode voltage of the signal does not exceed 17.5mV.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 11](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the peak-to-peak voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement with 17.5mV.

## DC Common Mode Voltage Test

**Test Overview** The purpose of this test is to verify that the common-mode voltage of the signal is between -350mV and 2.85V.

**NOTE**

This measurement can be done only with dual single-ended connection but not with a differential probing connection.

---

**Pass Condition** Refer to [Table 11](#).

**Measurement Algorithm**

- 1 Obtain sample or acquire signal data.
- 2 Verify that there is a signal and that the connection is dual single-ended.
- 3 Measure the peak-to-peak voltage.
  - If the Test Application is running on the UXR Series Oscilloscope, perform the measurement with the **Instrument Setup** set to **Channels 1 and 2**. Repeat the measurement with the **Instrument Setup** set to **Channels 3 and 4**.
- 4 Compare the voltage measurement to the range between -350mV and 2.85V.

## Transition Time Measurements TP4

The Transition Time Measurement procedures described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

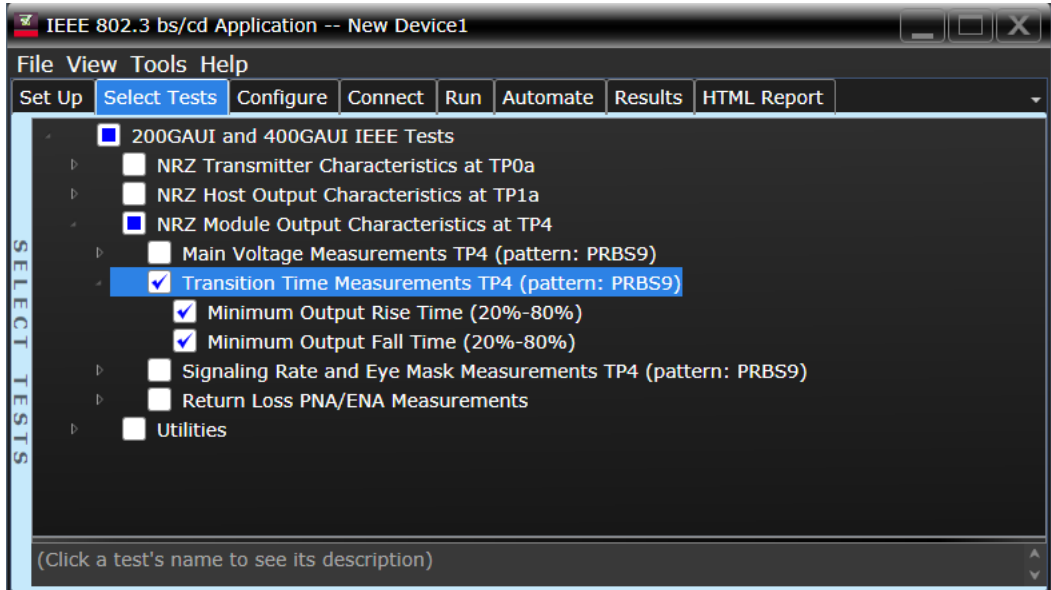


Figure 40 Selecting Transition Time Measurement Tests

Refer to [Table 11](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Transition Time Measurements TP4 (pattern: PRBS9) tests, see:

- “Minimum Output Rise Time (20%-80%)” on page 231
- “Minimum Output Fall Time (20%-80%)” on page 232

## Minimum Output Rise Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum rise time is 12ps.

**Pass Condition** Refer to [Table 11](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS9.
  - 3 Find pattern 000333 for rising edge.
  - 4 Measure rise time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum rise time with 12ps.

Minimum Output Fall Time (20%-80%)

**Test Overview** The purpose of this test is to verify that the minimum fall time is 12ps.

**Pass Condition** Refer to [Table 11](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Verify that the signal is PRBS9.
  - 3 Find pattern 333000 for the falling edge.
  - 4 Measure fall time from 20% to 80% of the signal amplitude.
  - 5 Compare the minimum fall time with 12ps.



## Signaling Rate and Eye Mask Measurements TP4

The Signaling Rate and Eye Mask Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope and the IEEE802.3 bs/cd Test Application.

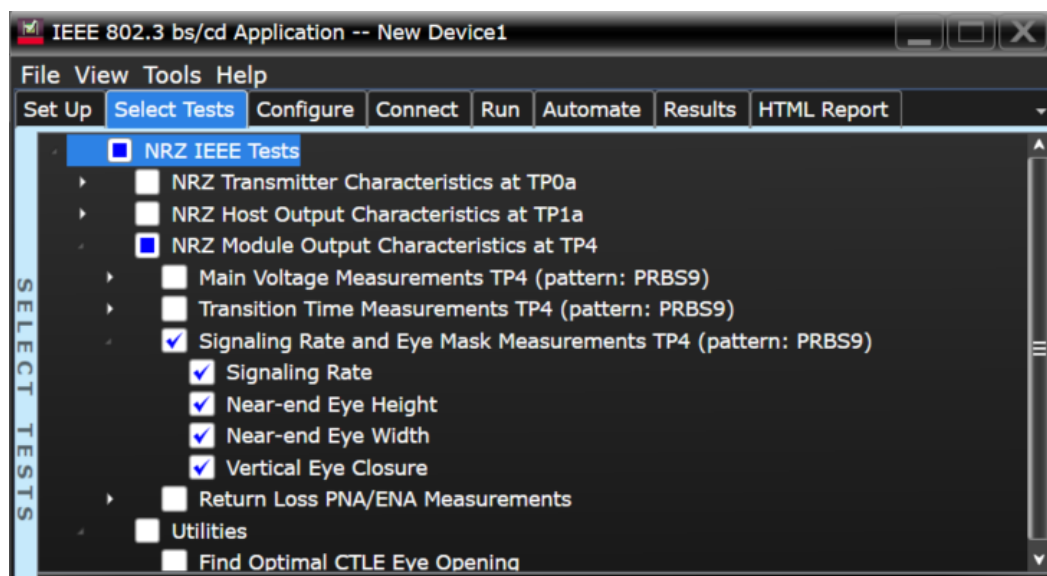


Figure 41 Selecting Eye Mask Measurement Tests

Refer to [Table 11](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Signaling Rate and Eye Mask Measurements TP4 (pattern: PRBS9) tests, see:

- “[Signaling Rate](#)” on page 234
- “[Near-end Eye Height](#)” on page 235
- “[Near-end Eye Width](#)” on page 236
- “[Vertical Eye Closure](#)” on page 237

### Signaling Rate

**Test Overview** The purpose of this test is to verify that the signaling rate mean is between  $26.5625 \pm 100\text{ppm}$  GBd.

**Pass Condition** Refer to [Table 11](#).

- Measurement Algorithm**
- 1 Obtain sample or acquire signal data.
  - 2 Check that the signal is connected, has a bit-rate of 53.125 GHz and that data pattern exists (PRBS9 must be used for this test).
  - 3 In the **Configure** tab, set **Signaling Rate** to 26.5625 Gb/s.
  - 4 Measure minimum, maximum and mean data rate.
  - 5 Report minimum and maximum values.
  - 6 Compare the mean data rate value with  $26.5625 \pm 100\text{ppm}$  GBd.
  - 7 Report the resulting value.

## Near-end Eye Height

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Near-end Eye Height is greater than 228mV. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 11](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Near-end Eye Height at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Near-end Eye Height with 228mV. Report the resulting value.

## Near-end Eye Width

**Test Overview** The purpose of this test is to verify that for a defined range of CTLE settings, the Near-end Eye Width is greater than 570mUI. The CTLE values range from 1dB lower than the user-defined optimal CTLE to 1dB higher than the user-defined optimal CTLE.

**Pass Conditions** Refer to [Table 11](#).

- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Near-end Eye Width at an **Eye Height/Width Probability** setting of 1E-5.
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Compare the Near-end Eye Width with 570mUI. Report the resulting value.

## Vertical Eye Closure

- Test Overview** The purpose of this test is to verify that the Vertical Eye Closure at EH15 (1E-15) is less than 5.5 dB.
- Pass Conditions** Refer to [Table 11](#).
- Measurement Algorithm**
- 1 Manually select the optimal CTLE setting from the **Use Optimized CTLE for Eye Opening** drop-down options in the **Configure** tab. The selected CTLE setting is called as 'User-defined optimal CTLE'.
  - 2 Obtain sample or acquire signal data.
  - 3 Measure the Vertical Eye Closure at an **Eye Height/Width Probability** setting of 1E-15 (EH15).
  - 4 On the Oscilloscope,
    - a set the Clock Recovery to OJTF First Order PLL with Nominal Data Rate (26.5625 Gbps) and Loop Bandwidth to 4 MHz.
    - b Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
  - 5 Measure and calculate AV as the mean value of logic 1 minus the mean value of logic 0 at the central 5% of the eye.
  - 6 Calculate Vertical Eye Closure (VEC) using the equation:
 
$$VEC = 20\log(AV/EH15)$$
  - 7 Compare the Vertical Eye Closure with 5.5 dB. Report the resulting value.

## Return Loss ENA/PNA Measurements

The Return Loss ENA/PNA Measurement procedures that are described in this section are performed using a Keysight Infiniium oscilloscope, PNA or ENA and the IEEE802.3 bs/cd Test Application. The Compliance Test Application controls the PNA/ENA to set the test limits and run the tests. You must ensure that the connected PNA/ENA is calibrated.

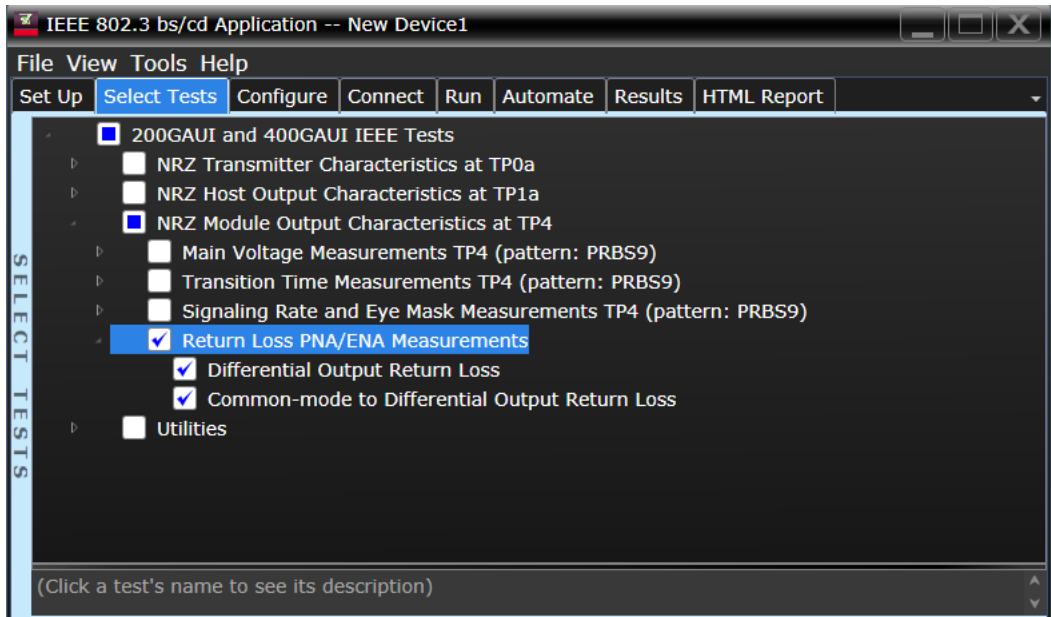


Figure 42 Selecting Return Loss Measurement Tests

Refer to [Table 11](#) for information on the pass limits for each test.

To know about the measurement algorithm for each Return Loss PNA/ENA Measurements tests, see:

- [“Differential Output Return Loss”](#) on page 239
- [“Common-mode to Differential Output Return Loss”](#) on page 240

## Differential Output Return Loss

- Measurement Algorithm**
- 1 Ensure that the PNA/ENA is physically connected and calibrated.
  - 2 In the **Set Up** tab of the Compliance Test Application, click **Connect PNA** or **Connect ENA** to establish connectivity to the connected equipment.
  - 3 Click the **Select Tests** tab and check the tests to measure the Return Loss Measurements.
  - 4 Click **Run** under the **Run** tab. The Compliance Test Application automatically calculates the return loss.
  - 5 Compare the reported values with the specification to check for compliance.

Common-mode to Differential Output Return Loss

- |                                  |   |
|----------------------------------|---|
| <b>Measurement<br/>Algorithm</b> | <ol style="list-style-type: none"><li>1 Ensure that the PNA/ENA is physically connected and calibrated.</li><li>2 In the <b>Set Up</b> tab of the Compliance Test Application, click <b>Connect PNA</b> or <b>Connect ENA</b> to establish connectivity to the connected equipment.</li><li>3 Click the <b>Select Tests</b> tab and check the tests to measure the Return Loss Measurements.</li><li>4 Click <b>Run</b> under the <b>Run</b> tab. The Compliance Test Application automatically calculates the return loss.</li><li>5 Compare the reported values with the specification to check for compliance.</li></ol> |
|----------------------------------|---|



# 11 Utilities

Utilities in IEEE Tests [242](#)

This section provides the Methods of Implementation (MOIs) for the Utilities available for each combination of Standard Option and Signal Type to find the optimal CTLE Eye Opening.

**NOTE**

Ensure that the **Signaling Rate** setting in the **Configure** tab of the Compliance Test Application must match the frequency of the acquired input signal.

---

## Utilities in IEEE Tests

The procedures described in this section to find Optimal CTLE Eye Opening and Far-end CTLE Eye Opening are performed using a Keysight Infiniium oscilloscope and the D9010EBSC IEEE802.3 bs/cd Test Application.

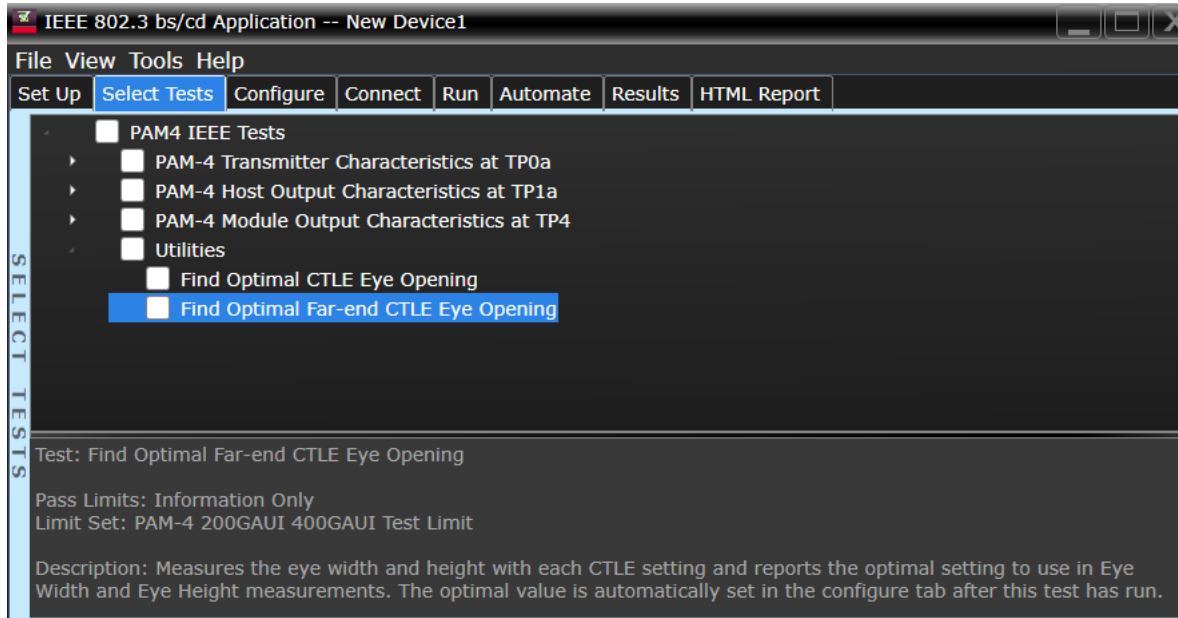


Figure 43 Selecting Utilities under the Select Tests tab

### NOTE

The test group **Utilities**, is available for each combination of **Standard Option** and **Signal Type** under the **Set Up** tab.

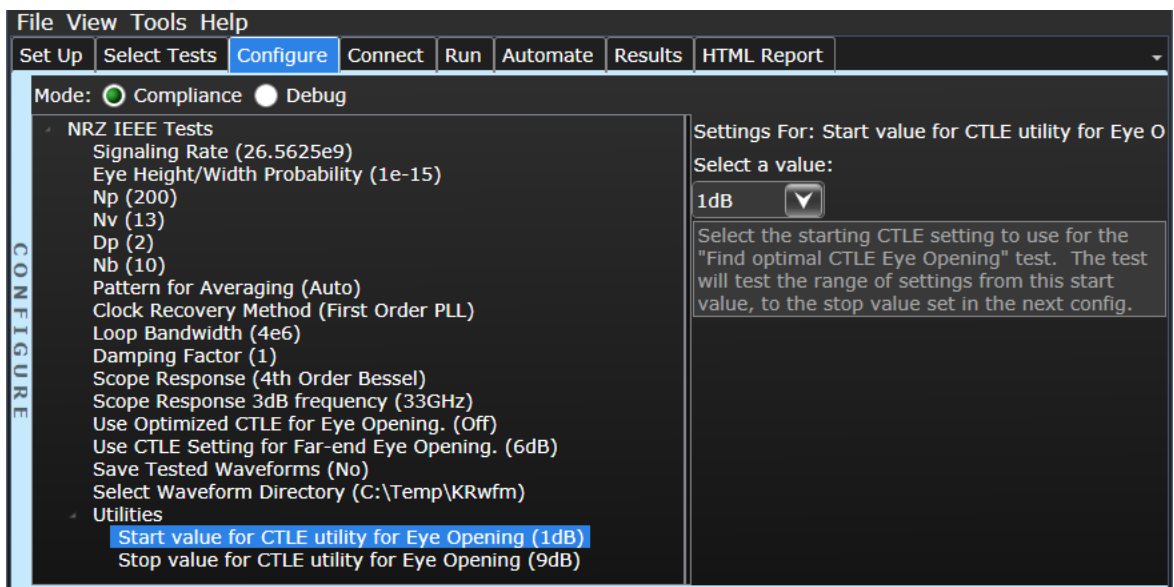
## Find Optimal CTLE Eye Opening

**Test Overview** The purpose of this test is to loop through CTLE settings to find the optimal CTLE setting for the largest area of the Eye.

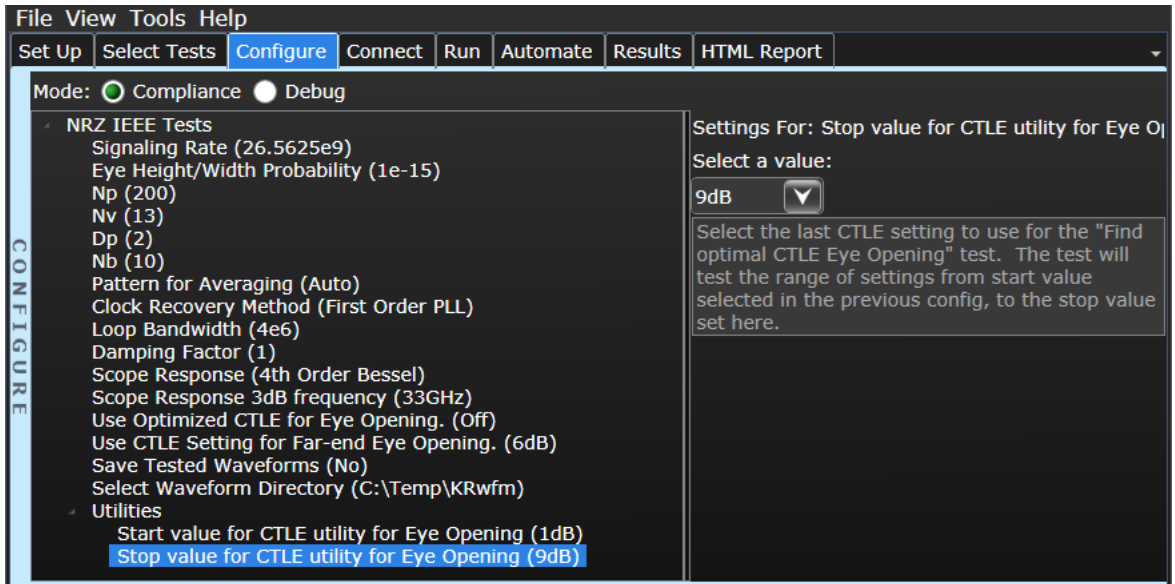
**NOTE**

This test describes the procedure for the option **200GAUI-x** and **400GAUI-x**, **NRZ** signals only. However, you can apply the same procedure for the rest of the combinations as well.

**Measurement Algorithm** 1 Set the CTLE value to match the value set for the option **Start value for CTLE utility for Eye Opening** in the **Configure** tab.



- 2 Obtain or acquire signal data.
- 3 Set memory depth to capture 1 million UI.
- 4 On the Oscilloscope, Clock Recovery is set to OJTF First Order PLL with Nominal Data Rate and Loop Bandwidth. Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
- 5 Measure Eye Height and Eye Width.
- 6 Calculate area of the center eye using the formula  $EH1 \cdot EW1$ .
- 7 Repeat the previous steps for each CTLE setting until the CTLE value attains the value set for the option **Stop value for CTLE utility for Eye Opening** in the **Configure** tab.



- 8 Report the CTLE setting with the largest eye area. The Application automatically changes the configured CTLE setting to the optimal value.

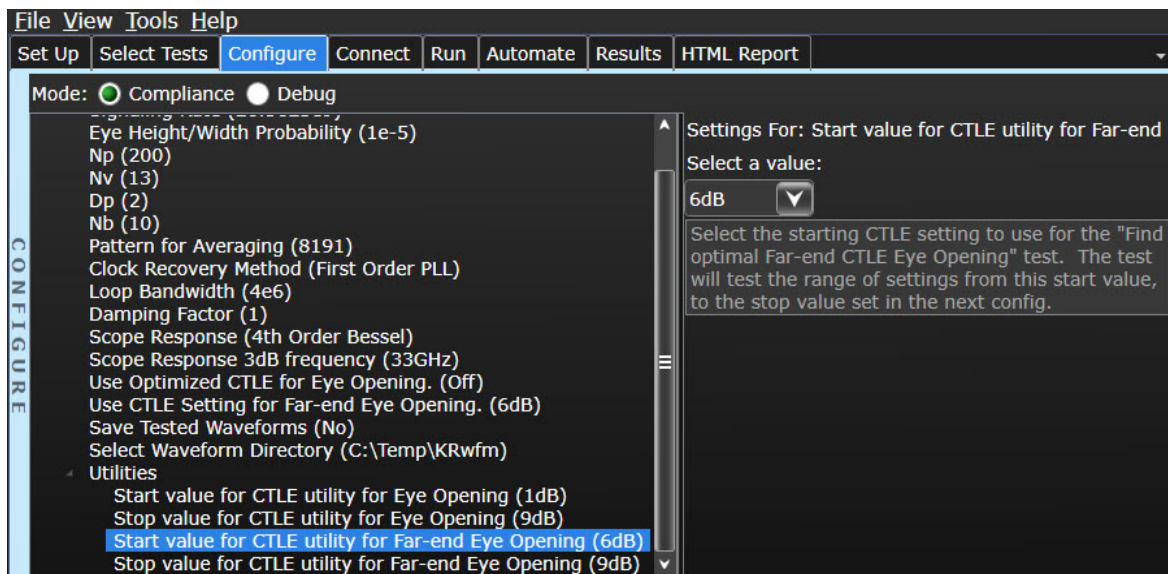
## Find Optimal Far-end CTLE Eye Opening

**Test Overview** The purpose of this test is to measure the eye width and height with each CTLE setting and report the optimal setting to use in Eye Width and Eye Height measurements. The optimal value is automatically set in the **Configure** tab after this test has run.

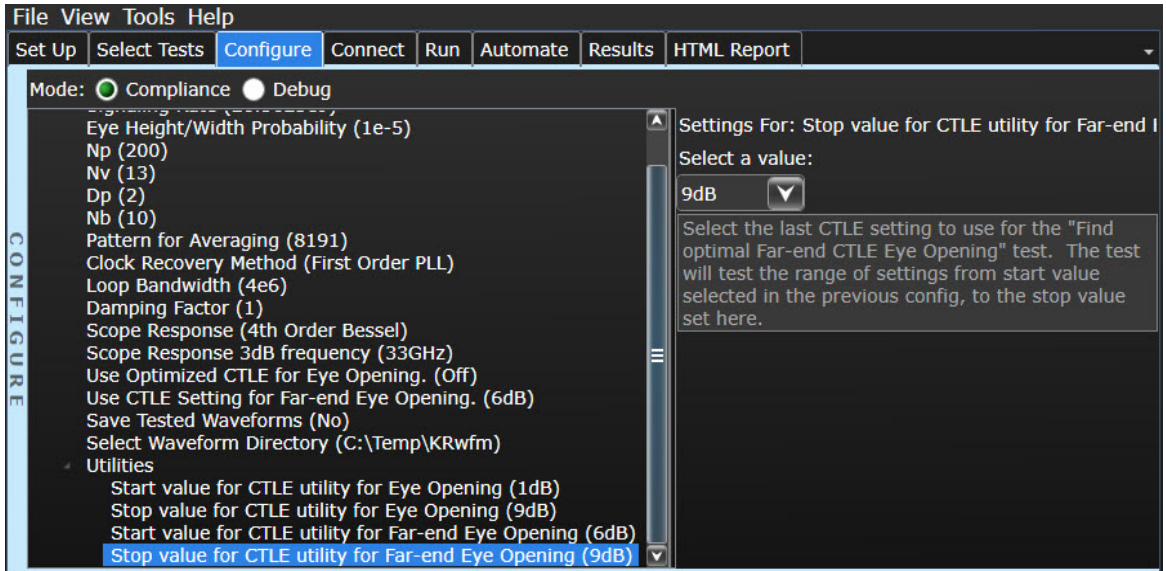
**NOTE**

The **Find Optimal Far-end CTLE Eye Opening** test, is available only for **200GAUI-x** and **400GAUI-x, PAM4** signals under the **Set Up** tab.

**Measurement Algorithm** 1 Set the CTLE value to match the value set for the option **Start value for CTLE utility for Far-end Eye Opening** in the **Configure** tab.



- 2 Add Far-end channel tf4.
- 3 Obtain or acquire signal data.
- 4 Set memory depth to capture 1 million UI.
- 5 On the Oscilloscope, Clock Recovery is set to OJTF First Order PLL with Nominal Data Rate and Loop Bandwidth. Set 4<sup>th</sup> Order Bessel Thompson filter to 33 GHz with 3 dB gain.
- 6 Measure Eye Height and Eye Width.
- 7 Calculate area of the center eye using the formula  $EH1 \cdot EW1$ .
- 8 Repeat the previous steps for each CTLE setting until the CTLE value attains the value set for the option **Stop value for CTLE utility for Far-end Eye Opening** in the **Configure** tab.



- 9 Report the CTLE setting with the largest eye area. The Application automatically changes the configured CTLE setting to the optimal value.

# 12 Debug Mode

Debug mode can be selected to make enable the ability to change jitter measurement options. In the **Configure** tab, select the **Debug** radio button. This will add the following options:

- **Rj Bandwidth** – Choose the Rj Filter. Options are Narrow (Pink) or Wide (White). This changes the amount of DC jitter in the Rj measurement.
- **Jitter Pattern Length** – Choose Periodic or Arbitrary. Periodic is used for data patterns that are periodic and repeat through the scope memory. Arbitrary is used for random data patterns or long data patterns (for example, PRBS31) that do not repeat through the scope memory. If Arbitrary is selected, set the ISI filters.
- **ISI Filter Lead** – When using Arbitrary mode for the Jitter Pattern Length, set the Leading ISI filter coefficient. To help select the correct ISI filter, see [Application Note 1574: Choosing the ISI Filter Size for EZJIT Plus Arbitrary Data Jitter Analysis](#) (at [www.keysight.com](http://www.keysight.com), literature part number 5989-4974EN).
- **ISI Filter Lag** – When using Arbitrary mode for the Jitter Pattern Length, set the Lagging ISI filter coefficient. Again, to help select the correct ISI filter, see [Application Note 1574: Choosing the ISI Filter Size for EZJIT Plus Arbitrary Data Jitter Analysis](#).





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